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# A Surface Science View onto Cuprous Oxide: Growth, Termination, Electronic Structure and Optical Response

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**Keywords:** copper oxide, cuprous oxide, surface, oxidation, termination, reconstruction, structure, atomistic models, adsorption, electronic properties, optical properties, doping, scanning tunneling microscopy, density functional theory

**Abstract:**

The oxides of copper have attracted the attention of scientists already for more than hundred years. This fascination is fueled by many outstanding properties of the material, for example, a semiconducting behavior that led to the first diode fabricated in electronics, a pronounced excitonic response that stimulated an intense search for Bose-Einstein condensation, and a pivotal role in unconventional superconductivity. Despite this central position in past and present research activities, many aspects of copper oxides are not sufficiently understood to date. This applies in particular to their surface characteristics, where even fundamental questions, such as the energetically favored termination of low-index  $\text{Cu}_2\text{O}$  and  $\text{CuO}$  planes, are still subject of debates. This review aims at addressing these deficiencies by compiling state-of-the-art knowledge of the surface science of copper oxides, and especially of cuprous oxide.

A first focus of the article lies in the oxidation characteristic of copper as a means to prepare well-defined oxide surfaces. It demonstrates that low-pressure oxidation only results in the formation of ultrathin precursor oxides, with properties deviating substantially from those of the bulk material. Consequently, reliable pathways to produce high-quality and bulk-compatible surfaces, either of  $\text{Cu}_2\text{O}$  thin films or bulk crystals, are presented. The following chapter provides a comprehensive introduction into the atomic structure of the most relevant  $\text{Cu}_2\text{O}$  surfaces, i.e., the (111), (100) and (110) planes. It gives an overview of important diffraction and microscopy experiments on the most accessible  $\text{Cu}_2\text{O}$  terminations, and complements this with state-of-the-art theoretical studies to develop corresponding atomistic models. The chapter closes by presenting the atomic configurations of the most relevant  $\text{Cu}_2\text{O}$  surfaces at given thermodynamic conditions.

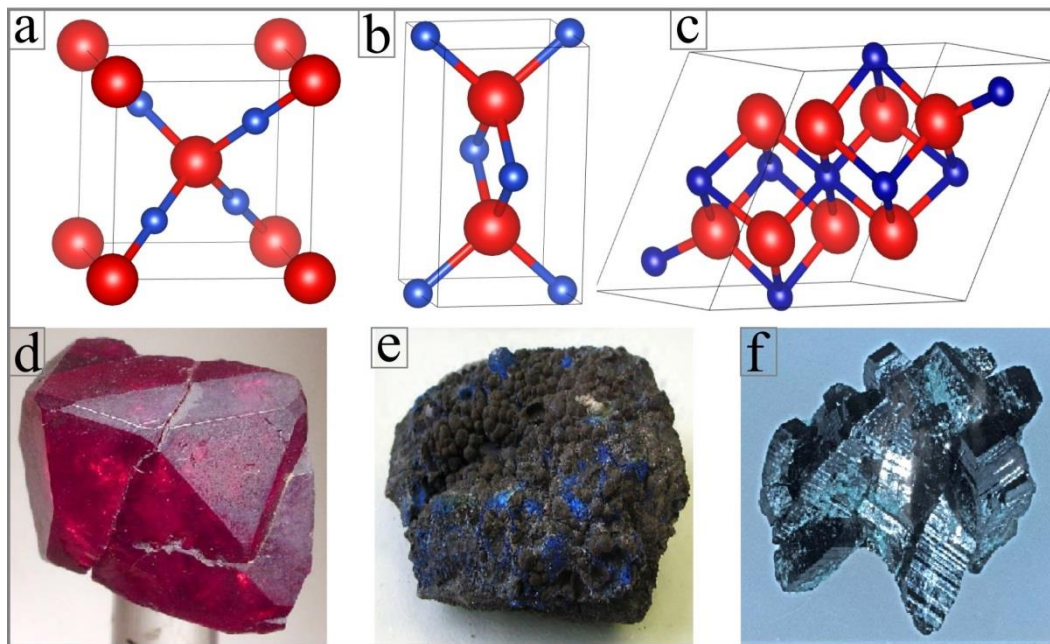
Chapter four develops a surface-science view onto the unique optical response of cuprous oxide. After introducing the well-known bulk behaviour, it highlights how optical properties can be probed on surfaces with high spectral and spatial resolution. The chapter discusses how optical near-field techniques are employed to analyze oxide excitons and their trapping at lattice defects in real-space experiments. The last chapter summarizes efforts to alter intrinsic  $\text{Cu}_2\text{O}$  properties, e.g., the p-type conductivity, the width of the band gap and the exciton trapping and recombination behavior, via doping. It illuminates this topic from an experimental and theoretical viewpoint and highlights several unsolved questions related to the topic.

Despite considerable efforts, this review can only present the current state of knowledge on  $\text{Cu}_2\text{O}$  surfaces, a subject that continuously advances due to new scientific findings and innovations. We nonetheless hope that it provides a comprehensive and topical overview of the unusual properties of this fascinating oxide system.

# 1. Introduction

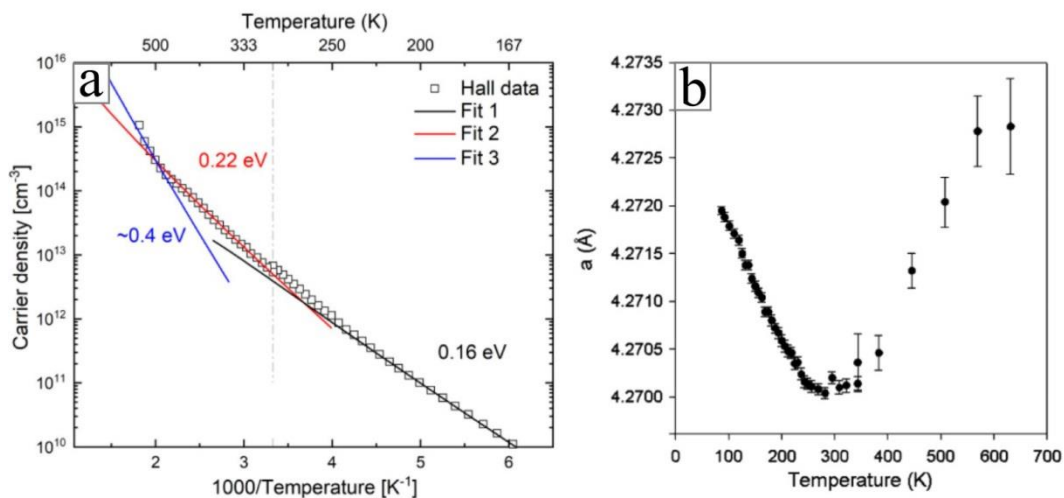
The oxides of copper belong to most fascinating and most intensively studied binary oxide materials in physics and chemistry. The reasons behind are their outstanding functionality, as far as the electronic, optical and chemical characteristics are concerned, and their broad availability with copper being the 28<sup>th</sup> most abundant element in the earth crust. This review article focusses on the surface properties of copper oxides, thus aims at complementing the many insightful articles on the bulk oxide material.<sup>1,2,3</sup>

Following the primary Cu oxidation states, +1 and +2, two main oxide phases can be distinguished that is cuprous oxide (Cu(I)-oxide, Cu<sub>2</sub>O) and cupric oxide (Cu(II)-oxide, CuO) (Fig. 1). Moreover, a mixed valence phase, Cu<sub>4</sub>O<sub>3</sub>, exists with 50% of the Cu ions in +1 and 50% in +2 oxidation state. Cuprous oxide, being in the center of this work, can be found as the natural mineral cuprite and is known for its beautiful and intense red color (Fig. 1a). The coloring gives a first hint on the band gap of the material that amounts to 2.15 eV and allows only red/orange light to be transmitted. Cuprous oxide crystallizes in a cubic lattice with *Pn3m* space group (4.27 Å lattice parameter), whereby the Cu and O ions occupy the fcc and bcc sites of the cube, respectively. Moreover, the structure comprises two Cu-O sub-lattices, being shifted against each other by ¼ of the cube diagonal. Cupric oxide, on the other hand, naturally occurs as tenorite, a black-colored mineral with a reduced band gap of 1.35 eV (Fig. 1b). The oxide crystallizes in a monoclinic lattice (space group *C2/c*) with angles  $\beta = 100^\circ$  and  $\alpha, \gamma = 90^\circ$ . Finally, Cu<sub>4</sub>O<sub>3</sub> or paramelaconite adopts a tetragonal lattice with *I41/amd* space group and has an indirect band gap of 1.34 eV (direct gap 2.47 eV, Fig. 1c).<sup>4,5</sup>



**Figure 1:** Crystal structures of (a) Cu<sub>2</sub>O, (b) CuO and (c) Cu<sub>4</sub>O<sub>3</sub> and photographs of the corresponding minerals. [Adapted from wikipedia]

Many unique properties render the copper oxides relevant for fundamental research and technical applications. In contrast to other binary oxides, they exhibit a pronounced p-type conductance behavior due to the low formation enthalpy of Cu vacancies ( $V_{\text{Cu}}$ ) in the lattice.<sup>6,7</sup> The associated holes float up in the band structure and occupy delocalized states at the valence band (VB) top, ensuring high hole mobility. In contrast, charge-compensating defects, such as O vacancies and interstitials, have high formation enthalpies and get inserted into the Cu-O lattice at much lower quantities than the  $V_{\text{Cu}}$  defects.<sup>7</sup> Note that most other binary oxides feature n-type conductance behavior, as the formation enthalpy of O vacancies is low and hole states produced by cationic defects tend to localize in the band gap.<sup>8</sup> A robust p-type conductance response is found for both,  $\text{Cu}_2\text{O}$  and  $\text{CuO}$ , with the former one having higher carrier densities.<sup>9</sup>

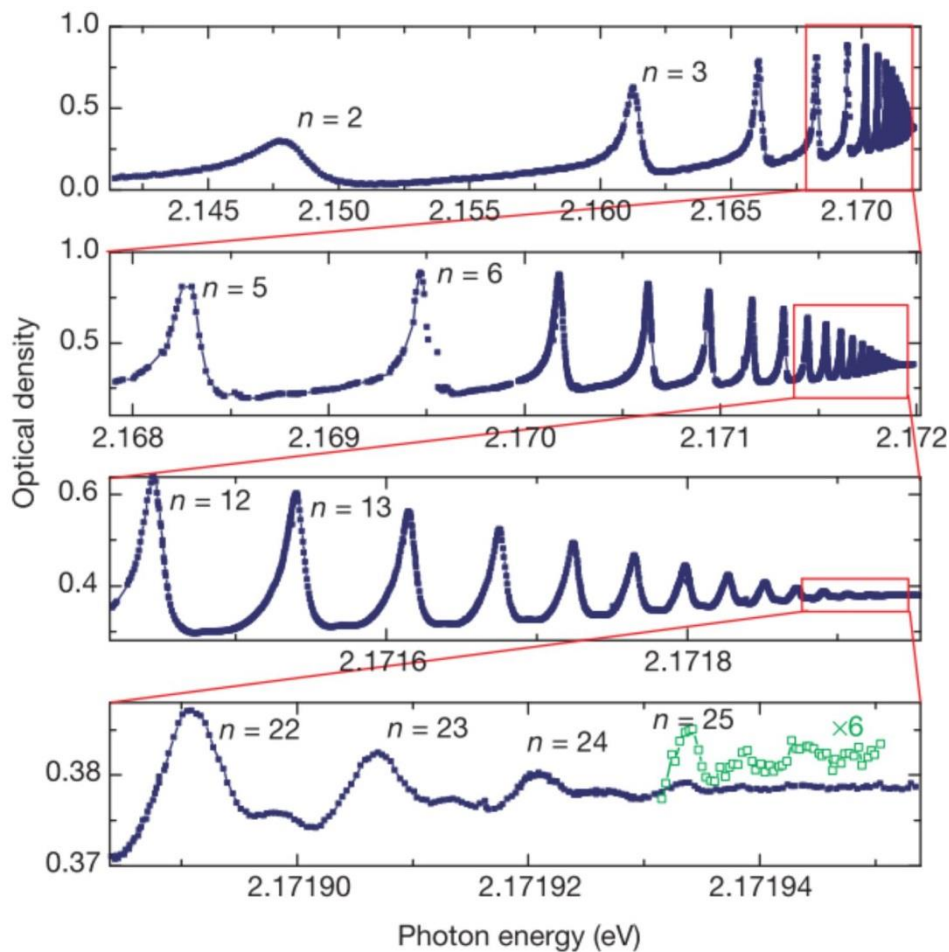


**Figure 2:** (a) Hole concentration versus inverse temperature as determined by Hall measurements for a  $\text{Cu}_2\text{O}$  single crystal. Arrhenius fits are indicated by solid lines, the corresponding activation energies are assigned to Cu vacancies (0.22 eV) and nitrogen acceptors (0.16 eV).<sup>10</sup> (b) Temperature-dependent lattice parameter of  $\text{Cu}_2\text{O}$  from X-ray diffraction measurements.<sup>16</sup>

Not all questions related to the p-type nature of copper oxides are comprehensively answered by now. Temperature-dependent conductivity measurements on  $\text{Cu}_2\text{O}$ , for example, appear to be incompatible with the  $V_{\text{Cu}}$  acceptor levels calculated by density functional theory (DFT).<sup>10</sup> Two types of  $V_{\text{Cu}}$  defects have been identified in the  $\text{Cu}_2\text{O}$  lattice, a simple vacancy produced by removing one Cu ion from the otherwise intact lattice, and a split vacancy, where an adjacent Cu ion relaxes towards the void to adopt a tetrahedral coordination with four O neighbors.<sup>7,11</sup> Depending on the computational approach, a variety of formation enthalpies have been calculated for the two vacancies, whereby the simple defect seems systematically preferred over the split one. Moreover, the (0/-) charging energy of simple  $V_{\text{Cu}}$  defects was found to vary between 0.23 eV<sup>12</sup> and 0.28 eV,<sup>7</sup> being in reasonable agreement with the results of deep-level transient spectroscopy.<sup>13</sup> Temperature-dependent conductance measurements, on the other hand, revealed a matching activation energy of 0.22 eV only in the temperature window from 200 to 500 K, while low-

temperature data indicated acceptor energies as small as 0.16 eV (Fig. 2a).<sup>10</sup> This finding suggests the presence of another low-lying acceptor state in natural Cu<sub>2</sub>O crystals, which was theoretically connected to substitutional N-atoms on O lattice sites<sup>14</sup> or N<sub>2</sub> molecules replacing a lattice Cu atom.<sup>15</sup> Up to this point, the impact of nitrogen doping on the Cu<sub>2</sub>O behavior could not be clarified, and the topic will thus be addressed later in the text.

Another peculiarity of cuprous oxide is its negative thermal expansion coefficient at temperatures between 100 and 300 K (Fig. 2b). It has been related to unidirectional phonon modes being excited perpendicular to the O-Cu-O bonds. As a result, the Cu<sub>4</sub>O tetrahedrons undergo a tilting in the lattice and reduce their mutual distance at increasing temperature.<sup>16</sup>



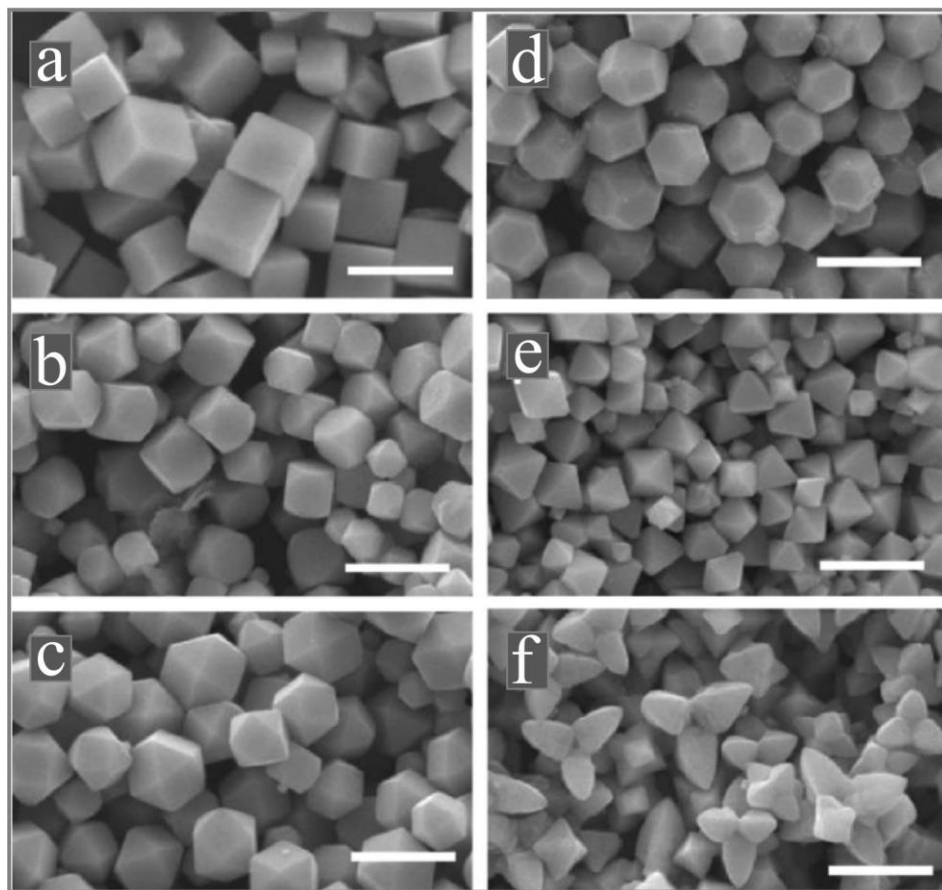
**Figure 3:** High-resolution absorption spectra of Cu<sub>2</sub>O excitons measured with a single-frequency laser on a natural oxide crystal at 1.2 K. Peaks correspond to exciton resonances with different principal quantum number.<sup>18</sup>

A major research spotlight of cuprous oxide focusses on its rich optical response, as governed by a set of para- and ortho-excitons and their trapping behavior at Cu and O defects in the lattice. The Cu<sub>2</sub>O excitons have exceptionally large ground-state binding energies of ~140 meV, with the para-excitons being 12 meV more stable due to spin-exchange interactions.<sup>17</sup> Correspondingly, numerous Rydberg excitons have

been detected in high quality  $\text{Cu}_2\text{O}$  crystals (Fig. 3). In fact,  $\text{Cu}_2\text{O}$  holds the world record of the highest observed Rydberg state ( $n=25$ ) among all excitonic systems.<sup>18</sup> Moreover, the high exciton binding energy renders  $\text{Cu}_2\text{O}$  an ideal material to explore bosonic condensation of electron-hole pairs.<sup>19,20</sup> However, unambiguous evidence for the formation of excitonic condensates could not be provided so far. The condensation seems hampered by two-body collision processes at high exciton density, whereby one exciton recombines while the other decays into two unbound carriers. This decay channel drastically reduces the exciton lifetime and prevents condensation.<sup>21</sup>

The  $\text{Cu}_2\text{O}$  excitons have a dipole forbidden nature, which is a direct consequence of the Mott-Hubbard character of the oxide band gap. The hot electrons hereby occupy Cu  $4s$  derived CB states, the corresponding holes localize in the Cu  $3d$  bands at the VB top. Exciton recombination thus requires a change in the orbital momentum quantum number of  $\Delta l = 2$ . While radiative decay of para-excitons is spin-forbidden in addition, making them optically dark, ortho-excitons can recombine via phonon involvement.<sup>22</sup> Not surprisingly, the dipole forbidden nature gives rise to long radiative lifetimes,<sup>23,24</sup> and extended diffusion lengths of  $\text{Cu}_2\text{O}$  excitons, reaching up to 100  $\mu\text{m}$  for para-excitons in ultraclean  $\text{Cu}_2\text{O}$  crystals.<sup>25</sup> Along their diffusion path, the excitons couple to defects and trapping at Cu and O vacancies gives rise to particularly strong luminescence peaks. The  $V_{\text{Cu}}$  mediated emission hereby locates at 940 nm, while peaks at 750 and 830 nm originate from radiative recombination via double and single-charged O vacancies in the  $\text{Cu}_2\text{O}$  lattice, respectively.<sup>26</sup>

The fascinating electronic and optical properties of copper oxides have initiated an intense search for technical applications. After discovery of the first diode behavior in a Cu/ $\text{Cu}_2\text{O}$  junction in 1933,<sup>27</sup> copper oxide was considered to be an auspicious material to fabricate semiconductor devices. However, the semiconductor revolution actually bypassed the Cu-O system due to difficulties to produce a clean and defect-free feedstock with controlled doping level. However, its p-type nature together with a direct-forbidden band gap in the visible spectral range renders  $\text{Cu}_2\text{O}$  interesting for solar-cell applications. The oxide matrix hereby simultaneously acts as absorber and hole conductor, whereas charge separation and electron collection takes place at the interface to an n-type material.<sup>28</sup> A prototypical all-oxide solar-cell design comprises  $\text{Cu}_2\text{O}/\text{ZnO}$  heterojunctions that have matching band alignments and good interfacial lattice registry at the same time.<sup>29,30</sup> Accessible light-to-current conversion rates remained low, however, with a maximum efficiency of about 2% reported in 2006.<sup>31,32</sup> The rather high defect concentration and the presence of parasitic recombination channels for hot carriers was found to be responsible for the low charge-separation efficiency, and still represents the main bottleneck for establishing a  $\text{Cu}_2\text{O}$  solar-cell technology.



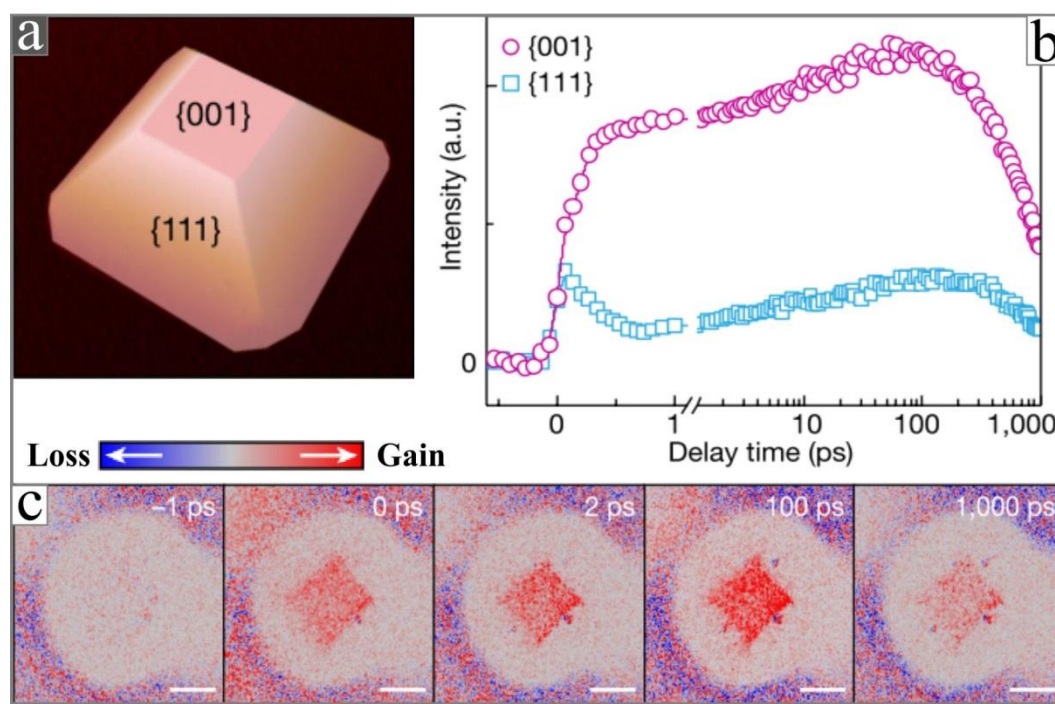
**Figure 4:** SEM images of shape-selected  $\text{Cu}_2\text{O}$  nanocrystals prepared with wet chemical, electrodeposition and solvothermal synthesis methods: (a) cubes, (b) truncated cubes, (c) cuboctahedrons, (d) truncated octahedrons, (e) octahedrons and (f) extended hexapods. All scale bars: 1  $\mu\text{m}$ . Adapted from [36].

All applications discussed so far rely on the specific bulk properties of copper oxides, for which a mechanistic level of understanding has been achieved in the past years.<sup>1</sup> The situation is less satisfying as far as the surface properties of  $\text{CuO}$  and  $\text{Cu}_2\text{O}$  are concerned, and hardly any surface-science studies have been reported for  $\text{Cu}_4\text{O}_3$ .<sup>33</sup> Designated surface experiments have mostly been carried out with oxide nanoparticles, for which several, easily accessible preparation schemes are available. Low-dimensional oxide structures have consequently become a research spotlight in the last decade.<sup>34,35,36</sup>  $\text{Cu-O}$  nanoparticles can be fabricated with well-defined shapes nowadays, opening a convenient pathway to address the unique performance of a given oxide termination (Fig. 4).<sup>37</sup> Common routes towards facet engineering rely on the use of distinct precursor solutions, reduction conditions or calcination temperatures that favor the development of a certain oxide facet.<sup>38</sup>

By employing highly homogenous particle ensembles, the catalytic impact of individual  $\text{Cu}_2\text{O}$  facets can be addressed explicitly. For example, hydrogen and CO reduction experiments were used to determine the reactivity of cubic versus octahedral  $\text{Cu}_2\text{O}$  nanoparticles, exposing mostly (100) and (111) crystal facets,



respectively.<sup>39</sup> Hereby, the onset temperature for oxide reduction was found to be  $\sim 100$  K lower for octahedral particles, suggesting a higher reactivity of the  $\text{Cu}_2\text{O}(111)$  surface. This finding is traditionally explained with the presence of low-coordinated  $\text{Cu}_{\text{cus}}$  ions in the bulk-cut (111) plane, although the availability of such sites in real surfaces was never proven and seems questionable in the light of studies presented in this article. The activity of (100) and (111) facets in light-driven hydrogen evolution reactions was probed by time-resolved photocurrent measurements performed with a transient photoelectron microscope (PEEM).<sup>40</sup> The experiments demonstrated ultrafast electron transfer from (111) to (100) facets to be a key component for the catalytic activity of the nanoparticles (Fig. 5). Even the charge flow between different facets of individual  $\text{Cu}_2\text{O}$  crystallites could directly be probed with a double-tip atomic force microscope (AFM).<sup>41</sup>  $\text{Cu}_2\text{O}$  and  $\text{CuO}$  nanoparticles finally exhibit a promising, yet hardly elucidated potential to serve as chemical sensors, e.g. for CO, or as building blocks for supercapacitors and high-duty batteries.<sup>42,43,44</sup>



**Figure 5:** (a) Facet arrangement of an ideal  $\text{Cu}_2\text{O}$  crystallite as used in the studies described in Ref. [40]. (b) Time evolution of the energy-integrated photoelectron intensity from two  $\text{Cu}_2\text{O}$  cluster facets as measured with a transient PEEM. The data reveals a net electron flow from (111) to (100) facets. (c) Visualization of the photon-induced electron exchange between these two facets as a function of the pump-probe delay. The scale bar is always  $2 \mu\text{m}$ .

From a thermal-catalysis point of view, copper oxide nanoparticles are mostly relevant for CO oxidation,<sup>45</sup> steam reforming of methanol,<sup>46</sup> methanol synthesis from  $\text{CO}_2$ ,<sup>47,48</sup> and C-S cross-coupling reactions.<sup>49</sup> Their photocatalytic performance is typically explored in three model reactions, i.e., the hydrogen evolution process,<sup>50,51</sup> the  $\text{CO}_2$  reduction to methanol,<sup>52</sup> and the photo-induced degradation of organic molecules.<sup>53</sup> Insufficient knowledge on the termination of the active Cu-O phase hereby turned out to be the

main bottleneck for interpreting the catalytic data, a situation that demands for a surface-science specific view onto copper oxides.

Besides the nanoparticle route, bulk crystals and thin films have thus been utilized to explore the surface characteristics of Cu-O materials. The respective experiments take advantage of the large arsenal of surface-science methods to gain comprehensive and detailed information on the atomic structure, chemical composition and electronic properties of model-type oxide surfaces. Moreover, the well-defined geometry of low-index planes enables a direct correlation between experiment and DFT calculations, generating mechanistic insights into the structure-functionality relationship of copper oxides.

Such fundamental studies on the atomic configuration, the electronic and the optical behavior of well-defined copper oxide surfaces now stand in the focus of this review article. It combines state-of-the-art experimental and theoretical work, dealing mostly with the surface properties of  $\text{Cu}_2\text{O}$ . Moreover, it aims at clearing out several misconceptions on the thermodynamically preferred surface configuration, the defect landscape and the catalytically active sites of those surfaces. Our article is structured as follows. Chapter 2 deals with experimental approaches towards clean and well-defined  $\text{Cu}_2\text{O}$  surfaces, either by growing thin films on suitable metal supports or preparing respective cuts of a bulk crystal. As thin films are typically formed by copper oxidation, we emphasize kinetic and thermodynamic hindrances in the oxidation process. Such barriers often lead to self-terminated oxide growth, whereby the resulting ultrathin layers may be fundamentally different from the respective bulk surfaces. In fact, various thin-film phenomena related to  $\text{Cu}_2\text{O}$  actually arise from strong metal-oxide interactions and have been erroneously associated to copper oxide. To avoid such misinterpretations in future, we present a set of indicators that allow safe discrimination between ultrathin oxide precursors and genuine bulk-derived  $\text{Cu}_2\text{O}$  surfaces.

Chapter 3 provides a comprehensive introduction into low-index  $\text{Cu}_2\text{O}$  surfaces, as derived from the (111), (110) and (100) planes. The building principles of CuO surfaces are not explored at this point, as reliable experimental and theoretical insights into this phase are still missing. In chapter 4, we discuss the unique electronic and optical properties, especially of the  $\text{Cu}_2\text{O}(111)$  surface. The chapter aims at connecting mean-field properties as measured by non-local methods with the behavior explored by scanning probe microscopy, putting special emphasis on the role of surface defects on the local electronic, optical and adsorption response. The final chapter summarizes the state-of-the art knowledge on  $\text{Cu}_2\text{O}$  doping, highlighting the discrepancy between the theoretically anticipated behavior and phenomena that have actually been confirmed by experiment. A short summary recapitulates the most relevant properties of Cu-O surfaces and addresses questions and problems that presently hamper their technical utilization.

## 2. Copper oxidation

### 2.1. Introduction

Copper oxidation is one of the most intensively studied oxidation reaction and stands in the focus of research already for many decades.<sup>54,55</sup> This huge interest is based on several advantageous features of the reaction. First, there is the relatively low heat of oxidation ( $-170$  kJ/mol for  $2\text{Cu} + \frac{1}{2}\text{O}_2 \rightarrow \text{Cu}_2\text{O}$ ) that enables a detailed examination of the process at accessible time and temperature scales. Second, the reaction is known for its smooth progression that lacks large spatial dependencies. And last, it results in a small number of reaction products, essentially limited to  $\text{Cu}_2\text{O}$  and  $\text{CuO}$ . As a consequence, Cu oxidation reactions have been intensively examined with various experimental techniques, especially with microgravimetry (probing the weight increase upon oxidation),<sup>56</sup> optical and THz spectroscopy,<sup>57,58</sup> ellipsometry,<sup>59,60</sup> and conventional photoelectron-spectroscopy (XPS) that is particularly surface sensitive.<sup>61</sup> Apart from these in-situ approaches, snapshots of the sample morphology upon oxidation were revealed by electron microscopy and diffraction.<sup>62,63</sup> The so obtained experimental results were used to develop, confirm and refine model concepts for oxidation reactions in general and for Cu oxidation in particular.<sup>64</sup>

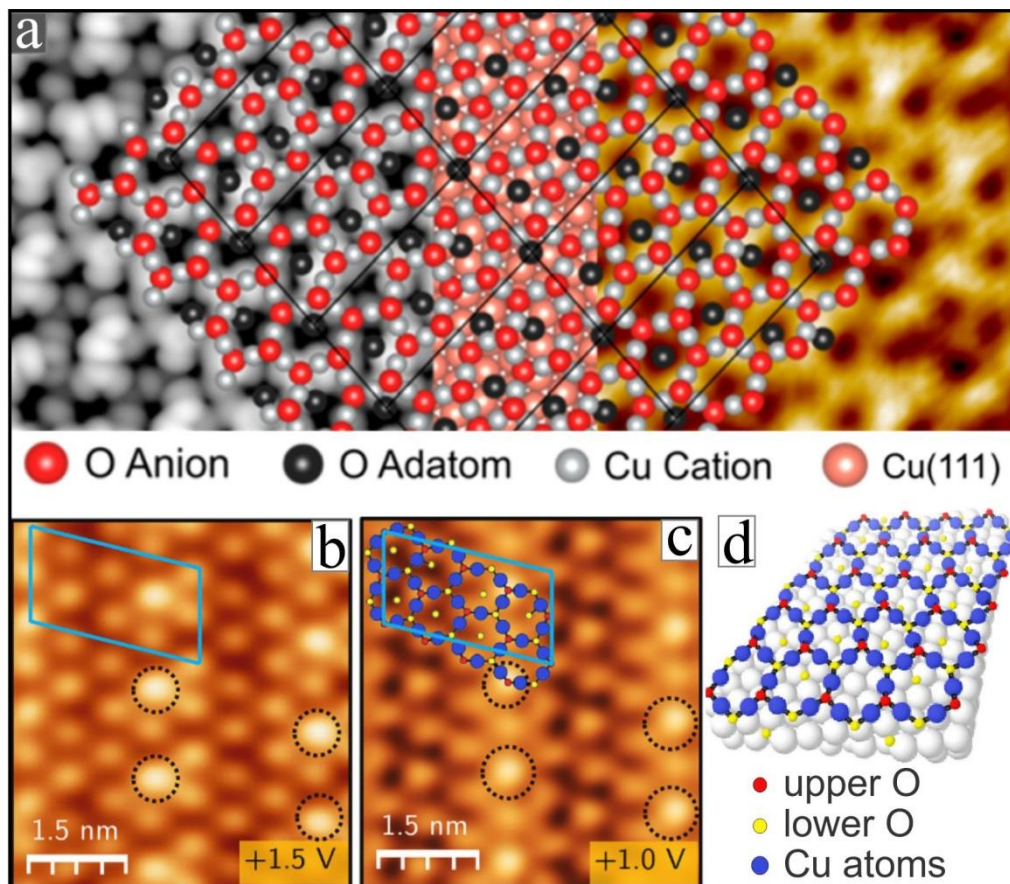
The most fundamental oxidation theory was devised by Tammann, Pilling and Bedworth already hundred years ago.<sup>65,66</sup> It treats oxidation processes as the diffusion of neutral particles, following the concentration gradient between the metal-oxide and the oxide-gas interface. Assuming a concentration-independent diffusion coefficient, the oxide thickness  $d$  grows with the square root of time, according to  $d(t) \sim \sqrt{t}$ . The Wagner theory, on the other hand, relates oxide formation to the diffusion of charged particles, which brings the electric field, the mobility and chemical potential of cations and anions into play.<sup>67</sup> At the assumption of locally constant concentration gradients, the model can be simplified again to a square-root dependence between film thickness and oxidation time,  $d(t) \sim \sqrt{t}$ .<sup>55</sup> In the limit of ultrathin oxide films, the Cabrera-Mott theory delivers the most reliable description of metal oxidation processes.<sup>68</sup> Its starting point is a spontaneous electron transfer from the metal-oxide to the oxide-gas interface, stimulated by a step in the vacuum potential. The electron exchange produces metal cations and oxygen anions at interface and surface, and leads to the development of an electric field across the oxide layer. The latter provides an electrostatic stimulus for the hopping motion of ions, being the prerequisite for the oxidation reaction. This mechanism gives rise to an inverse logarithmic relation between oxide thickness and time  $d(t)^{-1} \sim A - B \cdot \ln(t)$ , with  $A$  and  $B$  being parameters.<sup>55</sup> As tunneling is the major electron-transfer mechanism through the emerging oxide film, the Cabrera-Mott theory is valid only for layers thinner than 3-5 nm. Several attempts have been made to extend its validity by replacing electron tunneling with more long-ranged transport schemes, such as thermionic emission.<sup>69</sup> Moreover, direct logarithmic laws,  $d(t) \sim \ln(A+t)$ , can be

obtained when treating cationic and anionic diffusion with position-dependent activation barriers inside the emerging oxide film.<sup>70</sup>

## 2.2. Low-pressure oxidation of copper

In this review, we concentrate on surface-science relevant aspects of copper oxidation that are compatible with vacuum-based experiments, hence in line with the Cabrera-Mott theory. A careful look at low-pressure Cu oxidation is required here, as many studies that presumably address the surface properties of copper oxide were actually performed on ultrathin oxide precursors that neither mimic the structure nor the electronic properties of the genuine oxide material. The scientific history of these monolayer-thick oxide films started with oxidation experiments of Cu(111) performed at  $10^{-6}$  mbar  $O_2$  pressure.<sup>71,72</sup> Two distinct ultrathin precursor oxides were revealed by electron diffraction and scanning tunneling microscopy (STM) in those early experiments, the so called ‘29’ and ‘44’ structures, labelled according to the size of their unit cells with respect to the one of Cu(111) (Fig. 6). Given the mere dimension of those cells, a reliable structural analysis of the precursor oxides turned out to be difficult and is still subject of research.<sup>73</sup> Despite remaining ambiguities, Cu-O six-membered rings could be identified as the fundamental building blocks of both ad-layers, in line with the main structural motif of the bulk-cut  $Cu_2O(111)$  surface. The six-membered rings of the ‘29’ structure are hereby subject to pronounced distortions, being required to achieve registry with the Cu(111) surface, and contain an oxygen ion in the center.<sup>74</sup> The level of ring-distortion is reduced in the expanded ‘44’ configuration that already resembles a  $Cu_3O_2$  honeycomb structure with O ions located at the corners of the oxide rings.<sup>73</sup> The growth characteristics, defect properties and electronic structure of the two oxide precursors have been investigated in numerous follow-up studies, some of them highlighting feigned similarities to bulk-type  $Cu_2O$ .<sup>75,76,77</sup> However, neither the atomic structure nor key electronic aspects of the two oxide films, e.g. a real band gap, reflect respective bulk properties, which render the ‘29’ and ‘44’ layers an unsuitable model system for  $Cu_2O$ .

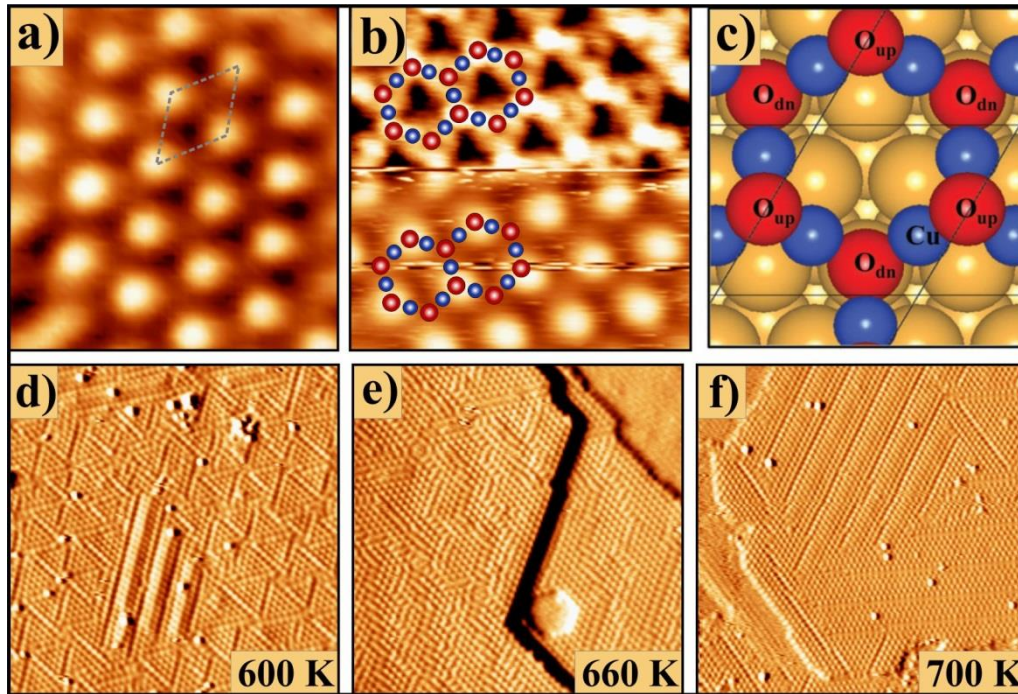
The ultrathin oxide precursors on Cu(111) gained nonetheless some relevance on their own, because of an exceptionally high reactivity in the low-temperature CO and  $H_2$  oxidation.<sup>78</sup> In fact, exposing the ‘44’ layer to ambient-pressure CO triggers an immediate reduction of the oxide precursor to metallic copper even at room temperature. Even the reaction fronts associated with this reduction process could be visualized in real space and real time, using time-resolved STM measurements.<sup>79</sup>



**Figure 6:** (a) Simulated STM image, atomic structure model and experimental STM data ( $U_B = -0.5$  V,  $3.5 \times 3.5$  nm<sup>2</sup>) of the ‘29’ Cu-O ad-layer prepared by Cu(111) oxidation.<sup>74</sup> (b) Experimental and (c) simulated STM image as well as (d) structure model of the ‘44’ Cu-O ad-layer on Cu(111).<sup>73</sup>

The self-terminated growth of ultrathin oxide precursors on Cu(111), observed in a wide range of oxygen pressures and temperatures, is usually linked to the interfacial lattice mismatch between metallic and oxidized copper, as additionally reflected in the large unit cells of the ‘29’ and ‘44’ films. Consequently, substrates with a more favorable lattice match with respect to bulk Cu<sub>2</sub>O(111) have been tested to synthesize oxide films that are not affected by growth limitations. An obvious first choice was Au(111), whose lattice parameter is 13% larger than that of Cu(111) and within 4% of the Cu<sub>2</sub>O(111) lattice constant.<sup>80,81</sup> Reactive Cu deposition in  $1 \times 10^{-6}$  mbar O<sub>2</sub> indeed results in several well-ordered Cu<sub>3</sub>O<sub>2</sub> structures, depending on the applied post-annealing conditions (Fig. 7).<sup>82</sup> All films feature a (2×2) superstructure with respect to Au(111), confirming the idea of reduced interfacial lattice strain. Similar to the ‘44’ layer on Cu(111), main building blocks are Cu-O six-membered rings arranged in a honeycomb configuration. Hereby, threefold-coordinated O ions, alternately bound to Au top and fcc-hollow sites, interconnect to Cu ions located in hcp-hollow positions (Fig. 7c). The O-ions assemble in two surface-parallel planes located 0.4 Å below and 0.9 Å above the Cu layer, whereby the upper plane governs the contrast in the STM images. The residual lattice mismatch between a freestanding Cu<sub>3</sub>O<sub>2</sub> honeycomb layer and Au(111) gets released

via a well-ordered dislocation network, the appearance of which changes with annealing temperature. Whereas a triangular domain pattern with 8 nm edge length is observed in low-temperature films (600 K), it evolves to a zig-zag and a stripe-pattern upon annealing to 650 and 750 K, respectively (Fig. 7d-f). In a combined STM and DFT study, even the atomic structure of these dislocation lines could be analyzed, giving insight into the underlying strain-relaxation mechanism.<sup>82</sup> Very similar results have been obtained in another Cu-O growth study on Au(111),<sup>81</sup> which focussed mainly on the competition between armchair and zigzag edges terminating the Cu<sub>3</sub>O<sub>2</sub> islands.



**Figure 7:** (a) STM image of the honeycomb Cu<sub>3</sub>O<sub>2</sub> monolayer film on Au(111) (0.5 V, 3 × 3 nm<sup>2</sup>). A tip change in (b) makes not only the (2×2) lattice of the O<sub>up</sub> ions but both oxygen species visible. (c) Structure model of the Au-supported Cu<sub>3</sub>O<sub>2</sub> monolayer. (d-f) STM images of differently annealed Cu<sub>3</sub>O<sub>2</sub> honeycomb films, showing the evolution of the strain relaxation patterns from (d) triangular, (e) zig-zag to (f) Au[110]-oriented stripe networks (10 × 10 nm<sup>2</sup>).<sup>82</sup>

A lattice parameter of 2.77 Å combined with a low oxygen affinity makes Pt(111) a suitable support to grow Cu-O thin films as well. Surprisingly, the low-temperature oxide layer displays identical properties to the oxide precursors formed on Cu(111), despite the substantially larger lattice parameter of Pt(111).<sup>83</sup> In fact, the well-known ‘29’ structure is found for films annealed to 550 K, and evolves to the ‘44’ configuration upon rising the temperature to 600 K (Fig. 8). While this observation comes unexpected at first glance, it gives additional evidence for the self-terminated growth of Cu-O films in vacuum-compatible preparation schemes. Similar to the findings on Au(111) and Cu(111), the precursor oxide only thickens to monolayer height on Pt(111), which is enough to reduce the surface energy of the metal substrate without building up interfacial lattice strain. In contrast to Au(111), however, Cu atoms that are not incorporated

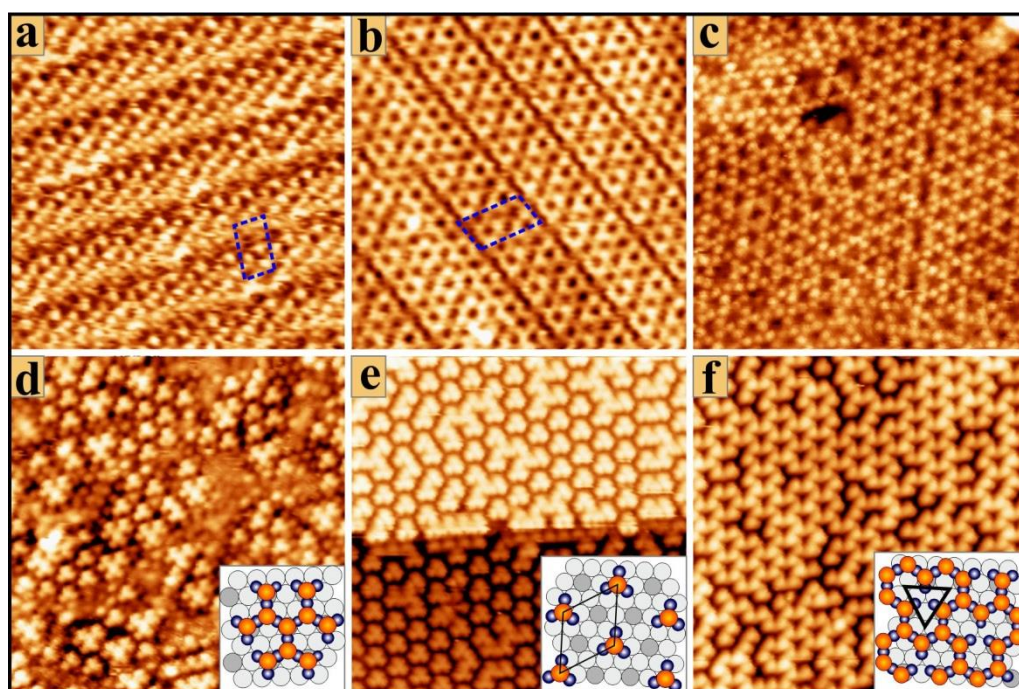
into the surface oxide accumulate at the Pt/oxide interface, where they generate an identical growth environment as encountered on Cu(111).<sup>71</sup> A similar behavior is not observed on the gold substrate that shows a high tendency for alloy formation with the excess copper.<sup>82,84</sup> As this alloy rapidly dissolves into the gold crystal, the initial Au(111) lattice parameter remains nearly unchanged and the Cu-O precursor oxide develops the strain-reduced (2×2) configuration in that case.

For the Cu-O growth experiments on Pt(111), the monolayer nature of the precursor oxide was also verified by XPS measurements.<sup>83</sup> The spectra demonstrate that most of the copper indeed remains metallic and accumulates in the form of Cu<sup>0</sup> at the Pt(111)/oxide interface. Only a small O *1s* peak reflects the Cu-O monolayer at the surface. The data confirm that growth of thick and bulk-like Cu<sub>2</sub>O films is inhibited even on lattice-matched substrates, such as Au(111) and Pt(111), independent of the amount of deposited Cu, of the oxidation temperature and the O<sub>2</sub> pressure as long as it stays below 10<sup>-3</sup> mbar. Based on these findings, a new mechanism for the self-terminated growth of Cu-O films was proposed.<sup>83,85</sup> Apparently, neither the interfacial lattice mismatch nor the moderate Cu oxidation enthalpy, being similar to the one of Ni for example, is responsible for the inhibited thickening of the precursor oxide. Instead, the unique porous structure of the oxide ad-layer hampers a continuous oxidation process, as incoming Cu atoms readily penetrate the Cu-O six rings and accumulated at the interface, where the access to gas-phase oxygen is blocked. Successful preparation of bulk-type Cu<sub>2</sub>O films thus requires oxygen pressures that are sufficiently high to pull the Cu atoms back to the surface in a Cabrera-Mott type scheme.<sup>68</sup> The correctness of this assumption will be proven in chapter 2.3, demonstrating successful growth of bulk Cu<sub>2</sub>O in a high-pressure O<sub>2</sub> atmosphere.

Although formation of bulk-type Cu<sub>2</sub>O turned out to be unsuccessful, reactive Cu deposition on Pt(111) nicely illustrates the growth complexity of metal-oxide thin films, as depicted in Fig 8.<sup>83</sup> Below 650 K deposition temperature, the experiments unraveled the ‘29’ and ‘44’ Cu-O precursor oxides due to Cu accumulation at the metal-oxide interface, as discussed before. The situation changes drastically upon sample annealing above 700 K, when Cu-Pt intermixing sets in and the lattice parameter of the substrate gradually increases from 2.55 Å for Cu(111) to 2.61 Å for a Cu<sub>3</sub>Pt(111) alloy.<sup>86</sup> The associated built-up of interfacial lattice strain triggers an order-disorder transition in the Cu-O precursor oxide that becomes manifest by rearranging the Cu-O six-membered rings into heavily distorted five-, six- and seven-membered rings (Fig. 8c). At the end of the phase transition, the surface oxide has become amorphous and any registry to the substrate is lost.

Surprisingly, further annealing to 750 K stimulates a second phase transition in the oxide ad-layer, whereby the Cu-O network breaks apart into localized Cu<sub>3</sub>O building blocks that perfectly arrange in a (2√3×2√3) superstructure (Fig. 8 d,e).<sup>83</sup> The discrete nature of these units removes the lattice strain and

renders the ad-pattern stable up to 900 K. Moreover, the ad-layer can be re-oxidized in  $5 \times 10^{-7}$  mbar  $O_2$ , whereby Cu from the  $Cu_3Pt$  alloy is pulled out of the metal support and reintegrates into a compact and closed-packed Cu-O network (Fig. 8f). Not unexpected, this process does not restore the original, highly strained honeycomb lattice, but three adjacent rings merge to a triangular pore with an O defect in the center. This new, more open Cu-O network represents an effective means to cope with the residual lattice strain at the interface.<sup>87</sup> The amorphization of the Cu-O precursor oxide upon high-temperature annealing has been reported for Cu(111) substrates, too.<sup>88</sup> Moreover, the unique ability of strained Cu-O networks on Pt(111) to release oxygen in a CO oxidation reaction has been addressed in the literature.<sup>89</sup> It should be noted in this regard that the high reaction rate reported in that study actually arises from the interplay of an easily reducible precursor oxide and the favorable catalytic properties inherent to Pt(111).



**Figure 8:** STM image of (a) the ‘29’ and (b) the ‘44’ Cu-O ad-layer on Pt(111). The oxide precursors match the ones grown on Cu(111), as excess copper accumulates at the metal-oxide interface. (c) Strain-induced amorphization of the oxide film due to formation of 5-, 6- and 7-membered rings. The effect is driven by alloy formation of interfacial Cu with the Pt substrate at higher temperature. All images are  $10 \times 10 \text{ nm}^2$  in size. (d) Decay of the compact oxide film at even higher temperature into isolated oxide units with star-like and (e)  $Cu_3O$  trimer-type configuration ( $9 \times 9 \text{ nm}^2$ ). The latter structure can be re-oxidized into an open Cu-O network (f). Characteristic building blocks of the different layers are depicted in the insets ( $Cu_{ox}$ : blue, O: orange, Pt: grey,  $Cu_{Pt}$ : dark grey).<sup>83</sup>

The various examples discussed in this paragraph aim at demonstrating that low-pressure oxidation of Cu does not allow to prepare thick copper oxide films. In contrast to many reports in the literature, vacuum-compatible preparation schemes are neither suited to prepare  $Cu_2O$  or  $CuO$  bulk-type films nor to analyze their specific surface properties. In the next section, we will therefore present how bulk-compatible oxide films of high quality can be fabricated with common surface-science preparation techniques.



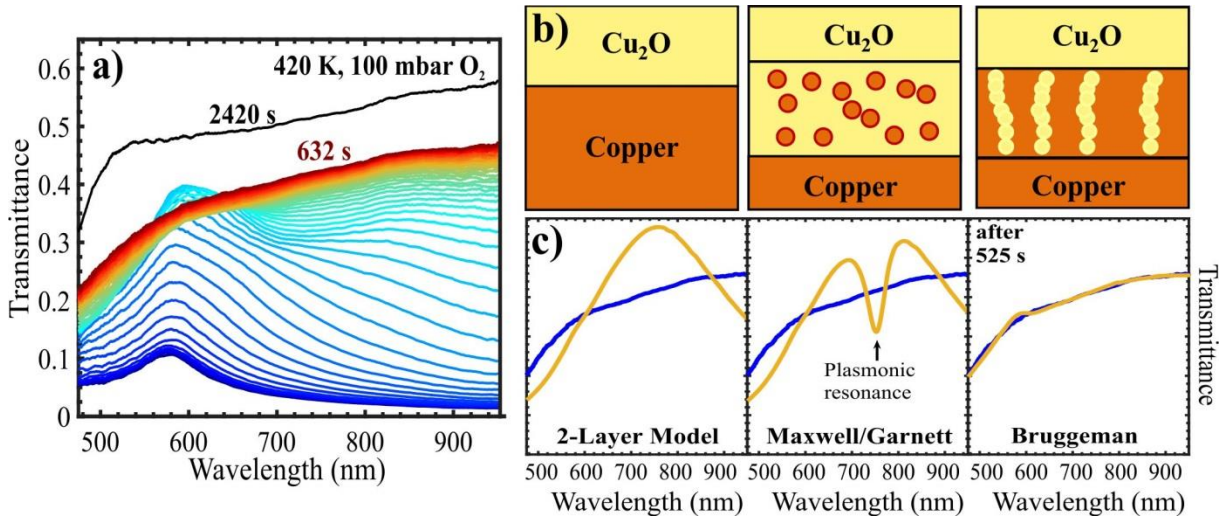
### 2.3. High-pressure copper oxidation

The oxidation of copper has evolved to a case study to explore the thermodynamics and kinetics of metal-oxygen interactions.<sup>90,91</sup> Early Cu-oxidation experiments date back already to the 1950s and revealed an inverse logarithmic growth rate for Cu<sub>2</sub>O in the low-temperature limit and at ambient O<sub>2</sub> pressure.<sup>92</sup> Over the years, this inverse logarithmic oxidation rate could be reproduced in many studies,<sup>93,94</sup> including recent XPS measurements with particularly high surface sensitivity.<sup>61,95</sup> All these experiments impressively validated the original idea of Cabrera and Mott, connecting metal oxidation in the thin-film limit to an emerging surface electric field that drives the reaction.<sup>68</sup> The probably most comprehensive experimental series was performed by Fujita et al. via ellipsometry.<sup>63</sup> The authors observed a crossover from an inverse logarithmic to a cubic and finally a parabolic growth rate for oxide thicknesses below 5 nm, below 50 nm and above 50 nm, respectively. The thin-film oxidation thus follows the Cabrera-Mott scheme,<sup>68</sup> while the universal parabolic law devised in Wagner's theory prevails in the limit of thick layers.<sup>67</sup> From an Arrhenius analysis, the main activation energies related to Cu oxidation were determined to ~30 and ~100 kJ/mol and correlated to surface and grain-boundary diffusion of copper in the limit of thin and thick films, respectively. The importance of Cu transport through grain-boundaries was further corroborated by Zhu et al., who reported activation energies of ~40 kJ/mol, being much too low for Cu diffusion in a compact bulk-type environment.<sup>56</sup>

In order to link the surface-science approach to copper oxides, as discussed in the previous chapter, to conventional oxidation studies, designated experiments are presented here that interrogate at what temperature and O<sub>2</sub> pressure the growth transition from ultrathin Cu-O precursor oxides to truly bulk-type films occurs. The measurements employed UV/Vis spectroscopy to probe the time-dependent change in optical transmittance when exposing a pre-deposited Cu film to O<sub>2</sub> pressures of up to 1 bar and temperatures of up to 800 K.<sup>96,97</sup> Apart from the actual oxidation, all experimental steps including sample preparation and characterization were carried out in an UHV environment to avoid parasitic effects. The robustness of such an optical approach enabled the in-situ monitoring of oxidation processes even at harsh chemical conditions that are unsuitable for classical surface-science techniques, such as XPS.

An exemplary series of transmission spectra, acquired during the oxidation of 50 nm Cu at 420 K and 100 mbar O<sub>2</sub>, is depicted in Fig. 9a.<sup>97</sup> The increasing transmittance due to gradual conversion of metallic Cu to dielectric Cu<sub>2</sub>O is readily observed (blue to red spectra). By fitting the experimental data to existing oxidation models, direct insight into the oxidation mechanism could be obtained. The optical simulations were carried out with the transfer-matrix method applied either to Cu<sub>2</sub>O-Cu bilayer or Cu<sub>2</sub>O-mixed Cu/Cu<sub>2</sub>O-Cu trilayer models (Fig. 9b).<sup>98</sup> While the former model assumes a planar metal-oxide reaction front, the latter accounts for an inhomogeneous interface between Cu and Cu<sub>2</sub>O components. Hereby, two arrange-

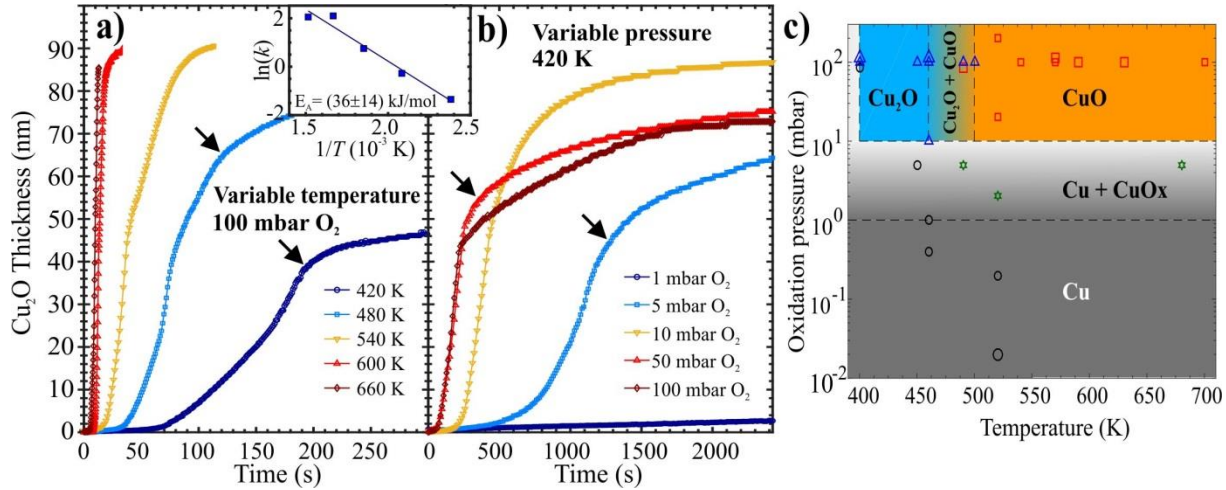
ments of oxide particles in the Cu host were tested, a random and a chain-like distribution, as accounted for in the Maxwell-Garnett and the Bruggeman mean-field schemes, respectively.<sup>99,100</sup> Only the latter enabled reliable fitting of all spectra in a transmission series with one set of parameters, demonstrating that Cu oxidation does not proceed homogeneously but along distinct reaction paths (Fig. 9c). Accompanying TEM experiments clearly confirmed this interpretation and provided direct evidence that polycrystalline Cu films oxidize along grain boundaries in the material.<sup>97</sup>



**Figure 9:** (a) Series of optical transmission spectra acquired during the oxidation of 50 nm polycrystalline copper at 420 K and 100 mbar O<sub>2</sub>. The spectra are color-coded according to their chronological order (blue to red), the top spectrum represents the final state of the sample after oxidation. (b) Two and three-layer models to simulate optical transmission spectra. The mixed layer in the center is described either with the Maxwell-Garnett or the Bruggeman approach, focusing on plasmonic inclusions and percolated particle chains, respectively. (c) Fit of the experimental spectrum taken 525 s after starting the oxidation to either a two-layer model or three-layer models described with the Maxwell-Garnett or Bruggeman scheme. Only the latter yields good agreement between theory and experiment.<sup>97</sup>

Having established a Cu oxidation model, the kinetics of the process was analyzed in a wide range of O<sub>2</sub> pressures and temperatures, as shown by the corresponding oxide growth curves in Fig. 10. Distinct kinks in all curves mark the point in time, when the reaction front reaches the backside of the sample and the process slows down (see arrows). By fitting the growth rates to a temperature-dependent Arrhenius behavior, the activation energy associated to Cu oxidation was determined. Over a wide range of O<sub>2</sub> pressures and Cu thicknesses, a barrier height of 40 kJ/mol was determined, a value that agrees well with theoretical diffusion energies of Cu atoms along grain boundaries (Fig.10, inset).<sup>56,101</sup> Conversely, bulk diffusion through a compact oxide lattice comes along with barriers above 100 kJ/mol, emphasizing again the pivotal role of defects and boundaries in realistic oxidation processes.<sup>63</sup> It is interesting to note that Cu oxidation is entirely controlled by the high mobility of Cu ions and their transport towards the reaction zone. Oxygen diffusion, on the other hand, requires much higher activation energies and consequently plays no role for the kinetics of oxidation. The importance of Cu diffusion has been impressively demonstrated in numerous oxidation studies on Cu nanoparticles.<sup>102,103</sup> In the course of such reactions, oxide material pref-

entially accumulates at the surface while a hole develops in the particle center. The resulting formation of hollow structures is commonly referred to as the Kirkendall effect and provides direct evidence for the dominance of cationic over anionic transport during copper oxidation.

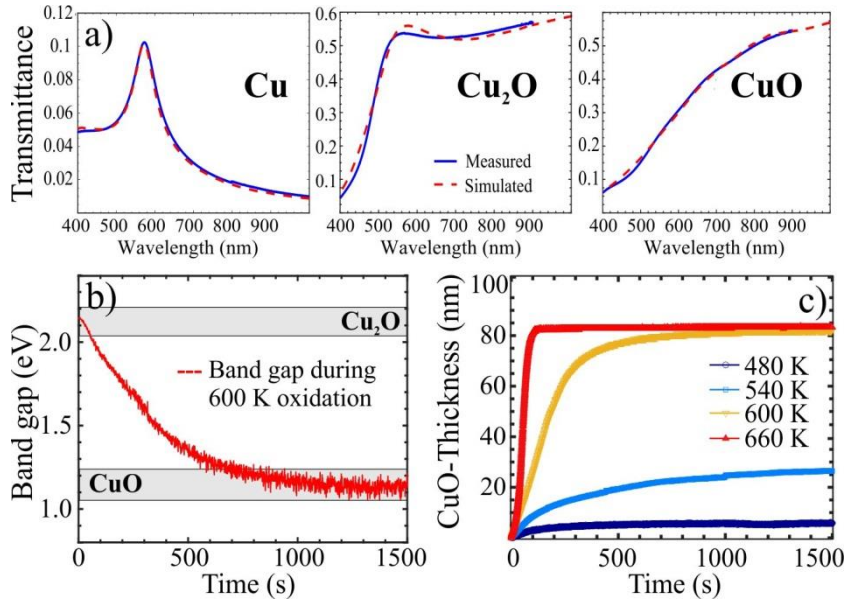


**Figure 10:** Cu<sub>2</sub>O growth curves measured as a function of (a) temperature ( $p_{\text{ox}} = 100$  mbar) and (b) O<sub>2</sub> pressure ( $T = 420$  K). The inset shows an Arrhenius plot of temperature-dependent oxidation rates and yields the activation energy of the oxidation process. (c) Formation diagram of Cu oxides, as derived from the growth studies presented in Figs. 9 and 10. Black, blue and red symbols stand for predominately bare Cu, Cu<sub>2</sub>O and CuO phases, respectively. Stability regions of the respective phases are depicted in matching colors; coexistence regions are shown with color gradients.<sup>96</sup>

Direct evidence for a reaction scheme that relies on Cu transport along grain boundaries was obtained from oxidation studies performed on nano-crystalline films with variable grain sizes.<sup>104</sup> The respective samples were fabricated by Cu deposition at increasing temperature, making use of Ostwald ripening processes to change the crystalline texture. As expected, a high oxidation speed was observed for Cu films grown at low-temperature, given their small average grain size, but gradually decreased with rising annealing temperature. For high-temperature films prepared at 700 K, only incomplete oxidation was observed as the large, defect-free Cu grains could not be converted into Cu<sub>2</sub>O fully within the time span of the experiment. The reaction rates deduced for differently annealed Cu films showed a nearly linear dependence on the total perimeter length of Cu grains, as measured with STM prior to oxidation. This correlation further corroborated the pivotal role of defect-mediated diffusion in Cu oxidation processes.

With increasing temperature, not only the Cu to Cu<sub>2</sub>O oxidation, but also the Cu<sub>2</sub>O to CuO phase transition was observed.<sup>105</sup> As CuO exhibits deviating dielectric properties, the two oxides are readily distinguished in transmission spectra (Fig. 11a). Moreover, a Tauc analysis of the data revealed the evolution of the oxide band gap during oxidation (Fig. 11b). The phase change from cuprous to cupric oxides sets in at 480 K and accelerates with increasing temperature (Fig. 11c). Fitting the optical data with the transfer-

matrix method indicates that the  $\text{Cu}_2\text{O}$  oxidation proceeds along a flat and homogenous reaction front,<sup>105</sup> and not along defect-mediated pathways as observed for Cu oxidation before.<sup>97</sup> The difference is readily rationalized with the nano-crystalline or even amorphous nature of the  $\text{Cu}_2\text{O}$  starting material. The higher oxidation temperature towards CuO, on the other hand, reflects the large activation barrier that needs to be overcome to change the Cu oxidation state from 1+ to 2+ and to squeeze extra oxygen into the already dense  $\text{Cu}_2\text{O}$  lattice. The effect was quantified with an Arrhenius analysis again, plotting the logarithmic CuO growth rates as function of the inverse temperature. As expected, the analysis yields a two times larger activation energy for CuO formation with respect to  $\text{Cu}_2\text{O}$  (79 versus 36 kJ/mol).<sup>105</sup>



**Figure 11:** (a) Experimental and simulated transmission spectra of pristine Cu (thickness 50 nm),  $\text{Cu}_2\text{O}$  and CuO films. (b) Time evolution of the gap size, reflecting changes in the  $\text{Cu}_2\text{O}/\text{CuO}$  ratio during the oxidation process. (c) CuO growth curves measured at the indicated temperatures ( $p_{\text{O}_2} = 100$  mbar).

The information gathered in various high-pressure Cu oxidation experiments was finally used to establish a copper-oxide formation diagram, covering a wide pressure and temperature range (Fig. 10c).<sup>96</sup> Its key message is that Cu oxidation beyond monolayer thickness is possible only for  $\text{O}_2$  pressures beyond 10 mbar. The associated pressure-dependent growth obstacle was identified in the effective Cu diffusion through the emerging Cu-O precursor oxide, separating the Cu metal from the gas-phase oxygen. Deep Cu oxidation only sets in when outward diffusion of Cu gets activated in a Cabrera-Mott-type scheme at high oxygen chemical potentials.<sup>91,103</sup> The growth temperature, on the other hand, primarily controls whether  $\text{Cu}_2\text{O}$  or CuO evolves in the oxidation process. While formation of phase-clean  $\text{Cu}_2\text{O}$  is highly favourable at oxidation temperatures below 450 K, CuO becomes the dominant phase above 500 K. In the intermediate temperature window, mixed oxidation states are stabilized, such as paramelaconite  $\text{Cu}_4\text{O}_3$ , although a detailed exploration of this transition range is still pending.

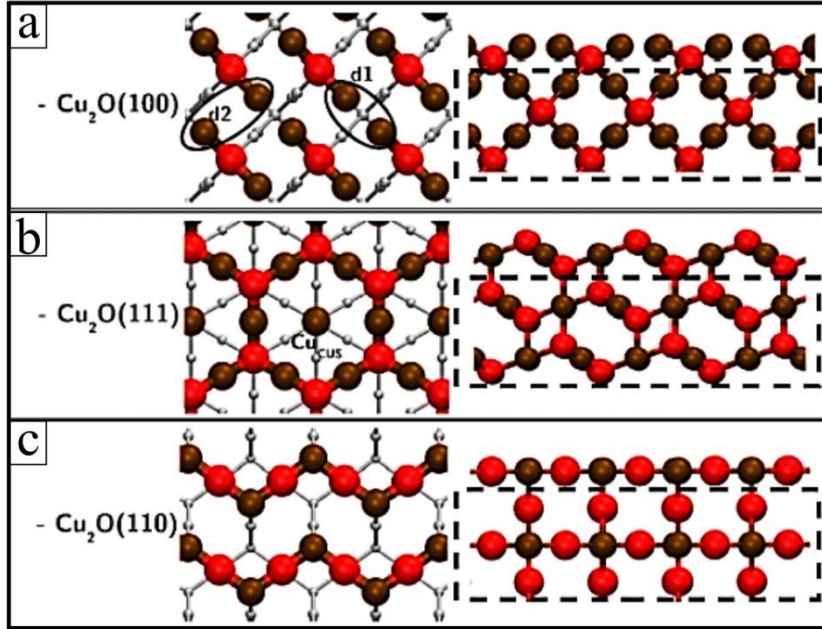
After this thorough discussion of Cu oxidation mechanisms, we take a closer look on the structural properties of low-index Cu-O surfaces in the next chapter. For the  $\text{Cu}_2\text{O}$  phase, we can resort to experimental results, acquired either on polished single crystals or oxide films grown on noble metal (111) surfaces, as well as to various DFT calculations. For  $\text{CuO}$ , mostly theoretical models are available, that could not be confirmed by high resolution diffraction and microscopy experiments so far. The available knowledge is therefore too premature to be compiled in this review article.

### 3. Copper oxide surfaces

The surface-science era of cuprous oxide started already in the 1990's with the seminal experiments of Cox and co-workers performed on  $\text{Cu}_2\text{O}$  single crystals.<sup>106</sup> These early diffraction and XPS studies identified several reconstructions for both, the (111) and (100) surface that stimulated a whole cascade of DFT calculations. However, reliable atomic structure models of the thermodynamically preferred  $\text{Cu}_2\text{O}(100)$  and (111) reconstructions could only be obtained 25 years later by combining high-resolution STM data of thin-film and bulk oxides with state-of-the-art DFT calculations. After a general introduction into the surface properties of  $\text{Cu}_2\text{O}$ , we will present the currently most reliable structure models for its (111) and (100) surface, whereas our understanding of the (110) plane remains fragmented at this point.

#### 3.1. Introduction

To provide first insights into the nature of low-index (100), (110) and (111) planes of  $\text{Cu}_2\text{O}$ , the respective bulk-cuts of the oxide lattice are depicted in Fig. 12. Along (100), pure copper and oxygen layers alternate ( $\dots/2\text{Cu}/\text{O}/\dots$ ), having a  $\pm 2$  formal charge per  $(1 \times 1)$  surface unit cell. Along the (110) direction, the alternation comprises mixed layers composed of  $2\text{Cu}$  and  $2\text{Cu}+2\text{O}$ , again with a total of  $\pm 2$  formal charges. Along (111), finally, the stacking is composed of neutral  $\text{O}/\text{Cu}_4/\text{O}$  trilayers. The number of oxygen-cation bonds cut upon surface formation is usually considered to be a good indicator of its relative stability. For the three orientations, two Cu-O bonds are cut per unit cell at both the (100) and (110) surface, while only a single bond gets disrupted between two subsequent trilayers with (111) orientation. Considering the associated surface-cell areas ( $a^2$ ,  $a^2\sqrt{2}$  and  $a^2\sqrt{3}$  for (100), (110) and (111), respectively, with  $a$  the bulk lattice parameter), the expected surface stability decreases from (111) to (110) and (100), i.e., the bulk-cut (111) surface would be the preferred oxide termination. Apparently, this criterion is insufficient to account for the observations, since the (110) surface is the least represented in  $\text{Cu}_2\text{O}$  nanoparticles.<sup>36,37</sup>



**Figure 12:** Atomic structure of the low-index bulk-cut surfaces of  $\text{Cu}_2\text{O}$ . Cu and O atoms are represented with dark and red balls, respectively.<sup>2</sup>

Several reasons may be invoked for this discrepancy. The first one is linked to surface polarity effects.<sup>107</sup> The (100) and (110) orientation yield Tasker-type III polar terminations and require  $\pm 1$  charge compensation per (1x1) unit cell.<sup>108</sup> The (111) orientation belongs to the Tasker-type II category and exhibits a non-polar termination if no O/4Cu/O trilayer is cut, but becomes polar otherwise. The compensating charges to reach electrostatic stability of polar surfaces may be provided by (i) substantial electron redistribution in the surface layers (electronic reconstruction), (ii) spontaneous desorption of surface ions changing the surface stoichiometry (non-stoichiometric reconstruction) or (iii) adsorption of charged species, such as hydroxyl groups from dissociative water adsorption.<sup>107,109</sup> The first mechanism is usually not favorable from an energetic point of view, because it involves an effective electron transfer across the band gap. In particular, in strongly ionic, wide-gap oxides, where charge transfer occurs from valence  $O\ 2p$  states to the cation-derived conduction band (CB), the energy costs are prohibitive and the mechanism is never observed. However, in  $\text{Cu}_2\text{O}$  with its moderate gap and Mott-Hubbard character, it may compete with the structural reconstruction and the adsorption mechanisms. At this point, one should distinguish between stoichiometry changes due to missing surface ions, altering the formal surface charge and thus the polarity, and reconstructions due to position changes of the surface ions, which preserve the surface charge and do not alter the polar character. As many erroneous statements are present in the literature, it is useful to recall the interrelation between surface relaxation and surface polarity. Relaxation effects always lower the surface energy compared to bulk-cut configurations and alter the surface dipole moment. However, whatever their amplitude, surface relaxation alone cannot compensate surface polarity. Indeed, the latter is

due to a divergence of the macroscopic dipole that can only be healed by additional surface charges but not by finite changes of the surface dipole moment.<sup>110</sup>

The second important parameter controlling the surface stability is the oxygen content. The stability of surfaces with different stoichiometry is typically assessed by comparing their relative Gibbs free energies. Depending on the experimental conditions, i.e., an oxygen-lean or oxygen-rich preparation environment, more Cu-rich or more O-rich terminations may be favored. The associated gain or loss in surface Gibbs energy then competes with other surface-energy contributions, e.g. the costs for bond breaking or polarity stabilization. Indeed, we will see in the following that different surface terminations and/or reconstructions may be observed under different surface preparation conditions.

And last, independent of the dominant polarity compensation mechanism either by electronic reconstruction or stoichiometry changes, the outermost layers have to accommodate excess electrons or holes. A peculiarity of  $\text{Cu}_2\text{O}$  is its Mott-Hubbard character, reflected in the presence of Cu orbitals at both sides of the band gap. The required excess charges thus localize mainly on the Cu atoms, yielding either an increase (excess holes) or decrease (excess electrons) of their oxidation state. In the latter case, formation of Cu dimers with quasi-metallic bonds between the two atoms is revealed on several (100) and (111) terminations, as detailed later.

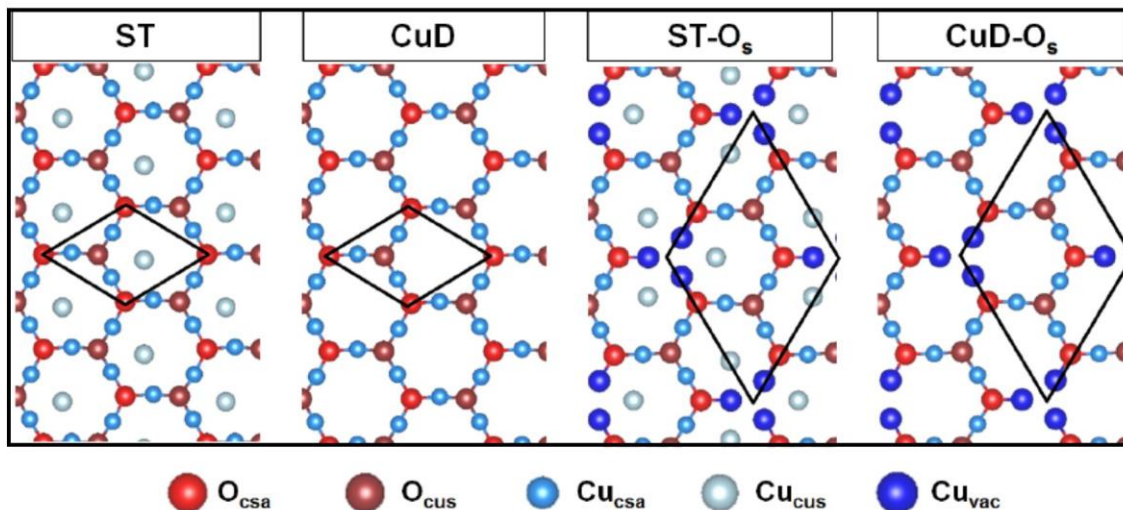
Before closing this section, some general statements on DFT calculations are useful. From a theory point of view,  $\text{Cu}_2\text{O}$  is a rather complex system. Already a correct treatment of the p-type conduction behavior of the bulk was shown to require an exchange-correlation functional, beyond the Generalized Gradient Approximation (GGA)<sup>6</sup> and even beyond GGA+U, in order to describe the transition between polaronic levels of the split Cu vacancies.<sup>111</sup> A similar conclusion was reached in a  $G_0W_0$  study, aiming at reproducing the direct/inverse optical band gap and the edge positions of  $\text{Cu}_2\text{O}$ .<sup>112</sup> The authors pointed out that the wave functions and energies, which served as inputs to the perturbative  $G_0W_0$  approach, had to be calculated at the hybrid level. They explained this with the unique electronic structure of  $\text{Cu}_2\text{O}$ , i.e., the mixed *s-p-d* character of its band-edge states, which requires electrons in all orbitals to be treated with exact exchange and not only the *d* states as in the DFT+U approach. Despite these findings, most existing simulations of  $\text{Cu}_2\text{O}$  surfaces are based on either GGA or GGA+U functionals. One purely technical reason is the prohibitive cost of hybrid calculations in the case of large unit cells. The GGA method hereby exaggerates the covalent nature of the Cu-O and Cu-Cu bonds, and therewith largely underestimates the gap width (~0.5 versus 2.15 eV in the experiment) and the costs for electronic reconstructions at polar  $\text{Cu}_2\text{O}$  surfaces. The GGA+U method has similar drawbacks since it is unable to significantly open the band gap (0.5–0.8 eV for *U* parameters between 2–8 eV). We will see in the following that GGA calculations predict a polar Cu-deficient (111) surface to be more stable than the stoichiometric, non-polar one in the en-

ture stability range of bulk  $\text{Cu}_2\text{O}$ . In contrast, the stoichiometric termination is favored when using hybrid Heyd-Scuseria-Ernzerhof (HSE) functionals over a wide span of oxygen-lean conditions under which bulk  $\text{Cu}_2\text{O}$  is thermodynamically stable.<sup>113</sup>

### 3.2. The $\text{Cu}_2\text{O}(111)$ surface

#### 3.2.1 Termination: Theory and experiment

Among all low-index planes of cuprous oxide, the (111) surface plays an exceptional role given its potentially non-polar and thermodynamically stable nature. Not surprisingly, pristine  $\text{Cu}_2\text{O}$  nanocrystals often take octahedral shapes, reflecting the dominance of (111) crystal facets.<sup>34,36</sup> The surface-science exploration of macroscopic  $\text{Cu}_2\text{O}(111)$  planes was initiated by Schulz and Cox on appropriately cut single crystals.<sup>106</sup> Using electron diffraction, they identified two distinct surface terminations, a simple hexagonal ( $1\times 1$ ) pattern and a  $(\sqrt{3}\times\sqrt{3})R30^\circ$  superstructure. The former was prepared by ion bombardment and subsequent vacuum annealing at 1000 K and did only show associative  $\text{O}_2$  adsorption at low temperature. It was therefore assigned to the quasi-ideal, stoichiometric surface (ST-surface, Fig. 13). The  $(\sqrt{3}\times\sqrt{3})R30^\circ$  termination, on the other hand, got stabilized after multiple adsorption/desorption cycles, e.g. of propene, whereby the desorption process was suggested to trigger oxygen removal from the surface. The reconstructed surface was consequently associated with an ordered array of oxygen vacancies ( $\text{ST-O}_s$  with  $1/3$  O defects per unit cell, Fig. 13), even though ultraviolet photoelectron spectroscopy did not reveal a reduced oxygen content with respect to the stoichiometric ( $1\times 1$ ) surface. The concept that the  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstruction of  $\text{Cu}_2\text{O}(111)$  is due to an oxygen deficiency nonetheless governed the experimental and theoretical studies of the coming years.

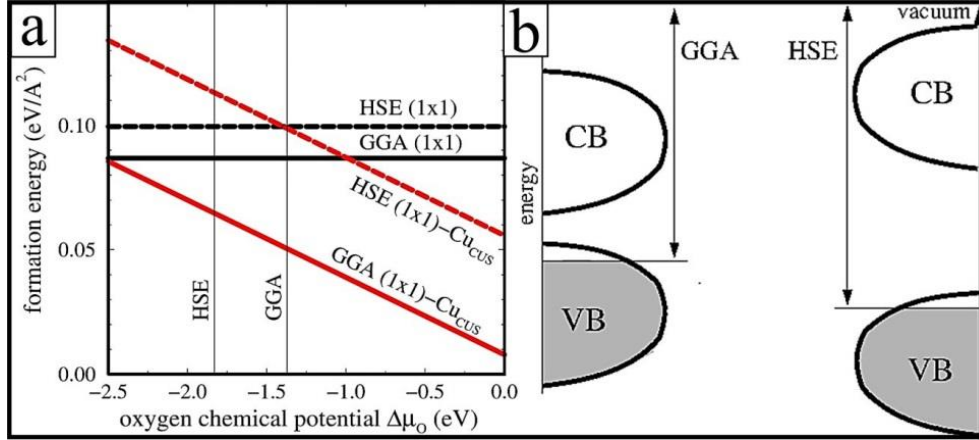




**Figure 13:** Atomic models of the most studied  $\text{Cu}_2\text{O}(111)$  terminations composed of coordinatively saturated (csa) and unsaturated (cus) ions. **ST:** Stoichiometric ( $1\times 1$ ) surface, **CuD:** Cu-deficient ( $1\times 1$ ) surface with  $\text{Cu}_{\text{cus}}$  vacancies, **ST- $\text{O}_s$ :** ( $\sqrt{3}\times\sqrt{3}$ ) $\text{R}30^\circ$  surface with  $\frac{1}{3}$  of the O ions missing, **CuD- $\text{O}_s$ :** ( $\sqrt{3}\times\sqrt{3}$ ) $\text{R}30^\circ$  surface with  $\text{Cu}_{\text{cus}}$  and  $\frac{1}{3}$   $\text{O}_{\text{cus}}$  vacancies. In the two ( $\sqrt{3}\times\sqrt{3}$ ) $\text{R}30^\circ$  configurations, Cu atoms close to the O vacancy ( $\text{Cu}_{\text{vac}}$ ) are represented with dark blue balls.<sup>114</sup>

In the following years, elucidation of the surface atomic structure of  $\text{Cu}_2\text{O}(111)$  relied solely on DFT calculations. Starting point was always the non-polar, bulk-cut (111) surface, made of an interwoven network of Cu-O six-membered rings with a coordinatively unsaturated  $\text{Cu}_{\text{cus}}$  ion in the ring center and unsaturated  $\text{O}_{\text{cus}}$  ions in the outermost positions (Fig. 13: ST configuration). In a first comprehensive GGA study, a large number of stoichiometric Cu- and O-rich as well as Cu- and O-depleted  $\text{Cu}_2\text{O}(111)$  terminations was investigated, all of them computed on ( $1\times 1$ ) surface unit cells.<sup>115</sup> The thermodynamically favored configuration at O-rich conditions was found to be the Cu-deficient one (CuD surface, Fig. 13), obtained by removing the  $\text{Cu}_{\text{cus}}$  ions from the stoichiometric (111) surface. At O-poor conditions, the lowest energy was realized by a Cu-rich surface, in which additional  $\text{Cu}_{\text{ad}}$  atoms bind to the unsaturated  $\text{O}_{\text{cus}}$  ions of the stoichiometric termination. With the same GGA approach, large relaxation effects were found on the Cu-rich termination, including Cu-Cu dimer formation, intermixing of the outermost layers, and large charge reduction of the surface copper ions.<sup>116</sup> With a DFT+U approach, the Cu-deficient termination (CuD) was predicted the most stable in a wide range of oxygen chemical potentials,<sup>117</sup> although the stoichiometric ( $1\times 1$ ) surface was close in energy, especially at O-poor conditions.

However, as both, Cu and O removals give rise to polar surface terminations, the validity of the GGA and DFT+U approaches was questioned and the relative stability of stoichiometric (ST) versus Cu-deficient (CuD) terminations was revisited by means of hybrid calculations.<sup>113</sup> In contrast to the earlier GGA and DFT+U predictions, the CuD termination appeared unfavorable in HSE calculations due to an increased cost of polarity compensation, shifting its stability region towards significantly more O-rich environments (Fig. 14a). As a consequence, the HSE approach produced a qualitatively different surface stability picture, in which the stoichiometric ( $1\times 1$ ) termination remains favored over a relatively large span of oxygen-lean conditions at which bulk  $\text{Cu}_2\text{O}$  is thermodynamically stable. This pronounced deviation between GGA and HSE calculations was linked to the different description of the oxide electronic structure in the two approaches. More precisely, the hybrid approach was found to better account for the surface ionization potential and the electron affinity, both largely affecting the costs of polarity compensation via the electronic reconstruction mechanism. The findings emphasize the intrinsic susceptibility of GGA(+U) approaches to artificially over-stabilize polar oxide terminations, which may also concern other  $\text{Cu}_2\text{O}$  surface orientations.<sup>113</sup>

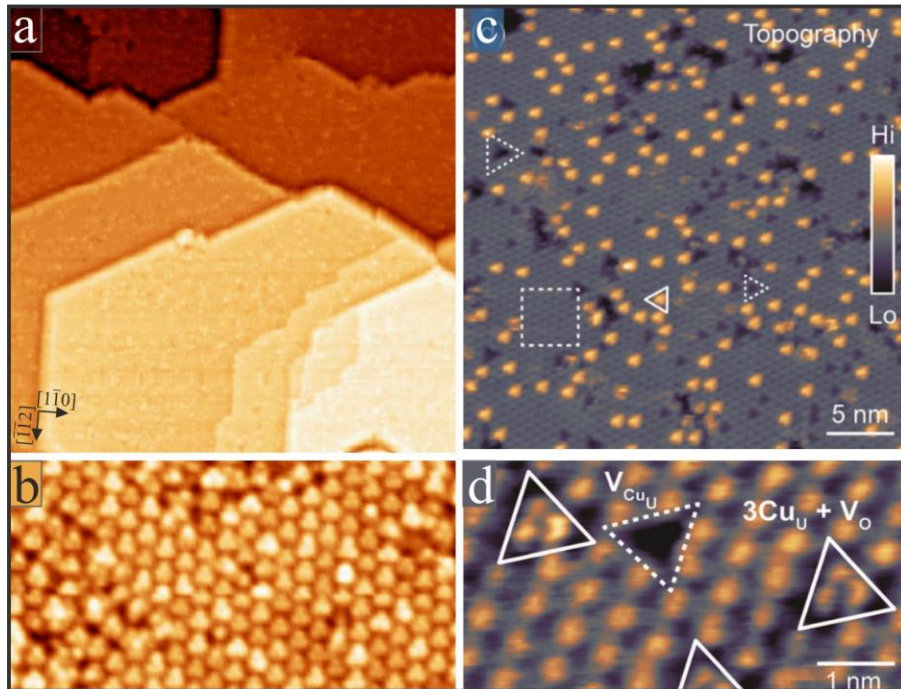


**Figure 14:** (a) GGA and HSE formation energies of the (1×1)-Cu<sub>2</sub>O(111) stoichiometric and Cu-deficient terminations as a function of oxygen chemical potential. The vertical lines demonstrate the stability range of the Cu<sub>2</sub>O bulk phase. (b) The schematic Cu<sub>2</sub>O band structure displays the improved description of the ionization potential in the HSE approach. Since the ionization potential of Cu<sub>2</sub>O is 0.8 eV larger in HSE than GGA calculations, the associated downward shift of the VB with respect to the vacuum level reduces the stability range of the Cu-deficient surface.<sup>113</sup>

Inspired by the early results of Cox et al.,<sup>106</sup> several O-depleted terminations have been tested with GGA/GGA+U approaches to describe the more complex ( $\sqrt{3}\times\sqrt{3}$ )R30° reconstruction, e.g. configurations with  $\frac{1}{3}$  of the O<sub>cus</sub> ions being removed and the Cu<sub>cus</sub> ions being either present or absent (ST-O<sub>s</sub> and CuD-O<sub>s</sub>, Fig. 13).<sup>113,117</sup> All such O-depleted surfaces appeared energetically unfavorable under realistic oxygen conditions and could not compete with the Cu<sub>cus</sub>-deficient (CuD) and the stoichiometric (ST) termination. Also, the more Cu-rich ( $\sqrt{3}\times\sqrt{3}$ )R30°-O<sub>cus</sub>+3Cu<sub>cus</sub> surface turned out to be less stable than the (1×1)-Cu<sub>cus</sub> termination.<sup>118</sup> Better insights into the surface reconstruction could only be gained when high-resolution STM measurements of Cu<sub>2</sub>O(111) became available. The first atomically resolved images of a Cu<sub>2</sub>O(111) crystal surface were provided by Önsten et al.<sup>119</sup> Similarly to the early results of Cox and coworkers,<sup>106</sup> a (1×1) surface was revealed upon annealing in  $2\times 10^{-6}$  mbar of oxygen, while vacuum annealing resulted in a sharp ( $\sqrt{3}\times\sqrt{3}$ )R30° superstructure. However, the switch between (1×1) and ( $\sqrt{3}\times\sqrt{3}$ )R30° termination was not fully reproducible and turned out to depend heavily on the preparation history of the crystal.

The STM signature of the ( $\sqrt{3}\times\sqrt{3}$ )R30° reconstruction was a regular array of triangular protrusions, coexisting with small (1×1) patches on the oxide surface. Importantly, the maxima showed up with bias-independent size and shape, suggesting a topographic and not an electronic origin. However, the authors kept an interpretation based on O vacancies,<sup>119</sup> although the pronounced bias-dependent appearance of anionic defects was long recognized in the STM community.<sup>120</sup> Atomically-resolved STM images of a Cu<sub>2</sub>O(111) single crystal performed by Nilius and coworkers essentially reproduced those early results, revealing large oxide terraces homogeneously covered with a ( $\sqrt{3}\times\sqrt{3}$ )R30° array of triangular protrusions (Fig. 15 a,b).<sup>121</sup> Only a single study on bulk Cu<sub>2</sub>O(111) deviated from the ones described before.<sup>122</sup> De-

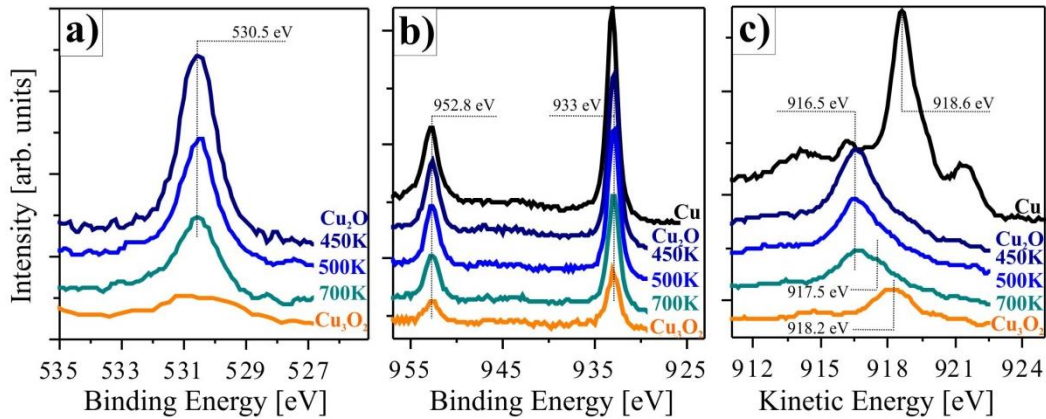
spite similar preparation conditions (sputtering and annealing in  $2 \times 10^{-6}$  mbar  $O_2$ ),<sup>119,121</sup> the oxide crystal showed a clear  $(1 \times 1)$  pattern in LEED and a corresponding close-packed hexagonal lattice in STM (Fig. 15 c). A few triangular protrusions, similar to the ones forming the  $(\sqrt{3} \times \sqrt{3})R30^\circ$  pattern, were found to be scattered over the surface. Consequently, the detected termination was assigned to the stoichiometric  $(1 \times 1)$  surface with the low-coordinated  $Cu_{cus}$  ions being present, and therefore followed the respective HSE prediction.<sup>113</sup> Moreover, the authors successfully identified two characteristic defects in the surface, i.e.,  $Cu_{cus}$  vacancies showing up as voids in the Cu-O six-membered rings and  $O_{cus}$  vacancies that appeared as unique atomic triples due to an inward relaxation of the three adjacent Cu ions (Fig. 15 d).<sup>122</sup>



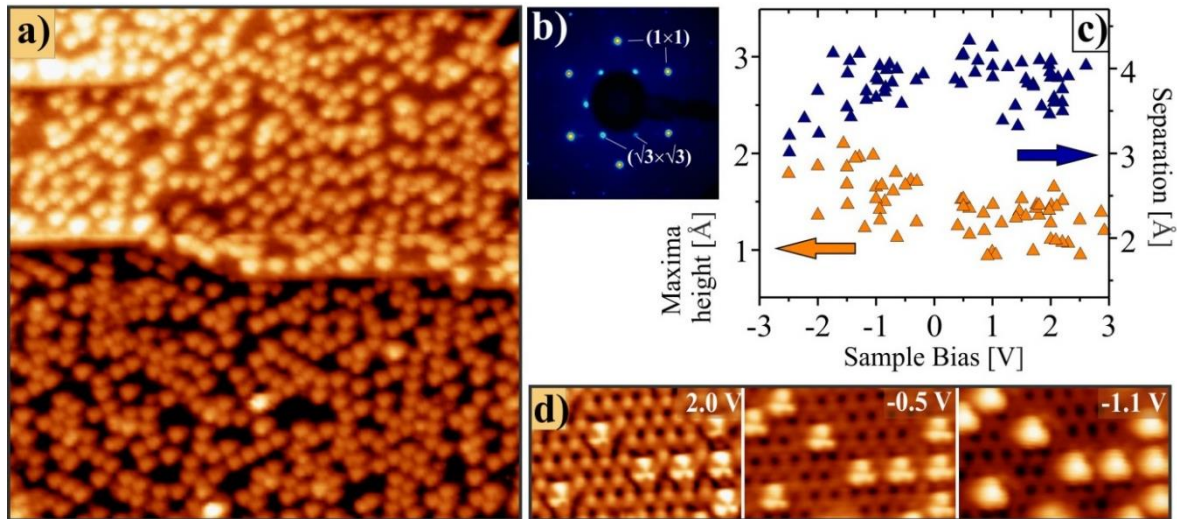
**Figure 15:** (a) Overview ( $125 \times 125 \text{ nm}^2$ ,  $U_B = 3.8 \text{ V}$ ) and (b) atomically-resolved STM topographic image of the  $(\sqrt{3} \times \sqrt{3})R30^\circ$  reconstructed surface of bulk  $Cu_2O(111)$  ( $20 \times 10 \text{ nm}^2$ ,  $-2.3 \text{ V}$ ). The array of triangular protrusions is readily detected.<sup>121</sup> (c) Overview ( $35 \times 35 \text{ nm}^2$ ,  $-1.5 \text{ V}$ ) and (d) atomically-resolved STM topographic image of  $(1 \times 1)$  terminated  $Cu_2O(111)$  ( $6 \times 3 \text{ nm}^2$ ,  $1.5 \text{ V}$ ). The up- and down-oriented triangles mark O- and Cu-vacancies in the surface, respectively.<sup>122</sup>

Further insights into the  $Cu_2O(111)$  surface termination came from several surface-science studies performed on metal-supported oxide films. To avoid oxidation obstacles, as addressed in chapter 2.2, 10 nm copper was deposited onto sputtered and annealed  $Au(111)$ <sup>123</sup> and  $Pt(111)$  substrates,<sup>124</sup> oxidized at 50 mbar  $O_2$  at 450 K and post-annealed in  $10^{-4}$  mbar  $O_2$  in those experiments. The bulk-like character of the resulting films was confirmed with XP and Auger spectroscopy, showing identical energy positions and line shapes as observed for bulk samples (Fig. 16). The spectroscopic fingerprints of  $Cu_2O$  generally comprise the O  $1s$  (530.5 eV) and Cu  $2p$  peaks (933 / 952.8 eV), whereby the latter alone are insufficient to distinguish between  $Cu^0$  or  $Cu^+$  oxidation states. This missing information is provided by Cu  $L_3VV$  Auger

transitions that emerge at 918.6 (main peak) and 917 eV for metallic Cu and CuO, respectively, but shift to 916 eV for Cu<sub>2</sub>O.<sup>124,125,126</sup> In correspondence to bulk crystals, the oxide thin films reproducibly displayed a  $(\sqrt{3}\times\sqrt{3})R30^\circ$  superstructure in LEED and a respective array of  $(\sqrt{3}\times\sqrt{3})$  protrusions in STM. Moreover, the topographic height of the triangular maxima was precisely determined to 1.5 Å, independent of the STM imaging conditions (Fig. 17). The nano-protrusions were therefore related to structural elevations and not to electronic effects. Despite the high quality of all those experimental studies, the question on the nature and composition of the  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstruction remained pending.

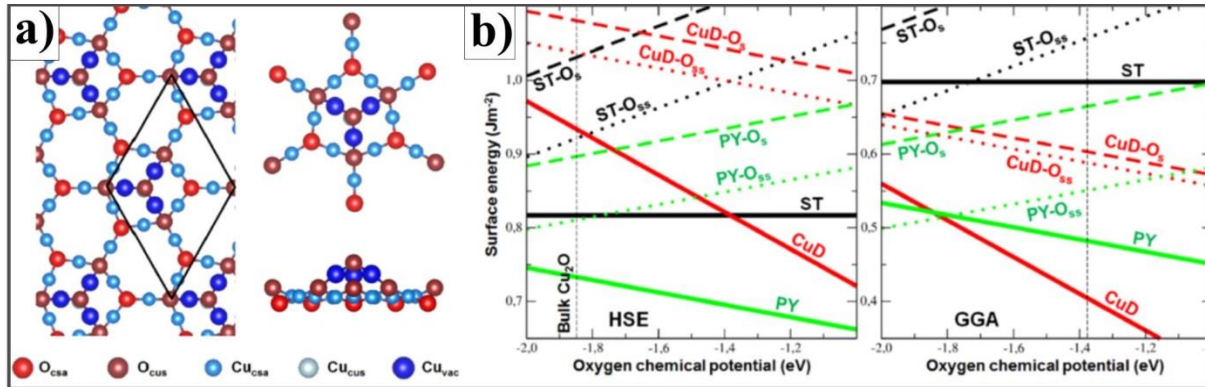


**Figure 16:** XP spectra of 10 ML Cu on Au(111) exposed to different oxidation conditions. The panels display (a) the O  $1s$  states, (b) the Cu  $2p$  states and (c) the Cu  $L_3VV$  Auger transitions. While the black curve is representative for Cu metal, the blue and orange ones were taken after high- and low-pressure oxidation of the samples, respectively. The low-pressure Cu<sub>3</sub>O<sub>2</sub> film was post-annealed to 650 K; the annealing temperature of the high-pressure samples is indicated in the panels. Only the XP fingerprint of the high-pressure films matches the one of Cu<sub>2</sub>O bulk crystals.<sup>123</sup>



**Figure 17:** (a) STM image of a bulk-like  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstructed Cu<sub>2</sub>O film on Au(111) ( $35\times 35\text{ nm}^2$ ,  $U_B = -2.0\text{ V}$ ). The surface is densely covered with characteristic triangular maxima. (b) LEED pattern of the Cu<sub>2</sub>O(111) surface, showing the fundamental  $(1\times 1)$  spots together with the  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstruction ( $E_{\text{kin}} = 21\text{ eV}$ ). (c) Topographic height and mutual distance of the triangular maxima as a function of bias voltage. Apart from small changes with STM polarity, the protrusions exhibit a bias-independent contrast. (d) Isolated triangular maxima of the  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstruction, demonstrating their bias-independent appearance in STM ( $7.5\times 4\text{ nm}^2$ ).<sup>123</sup>

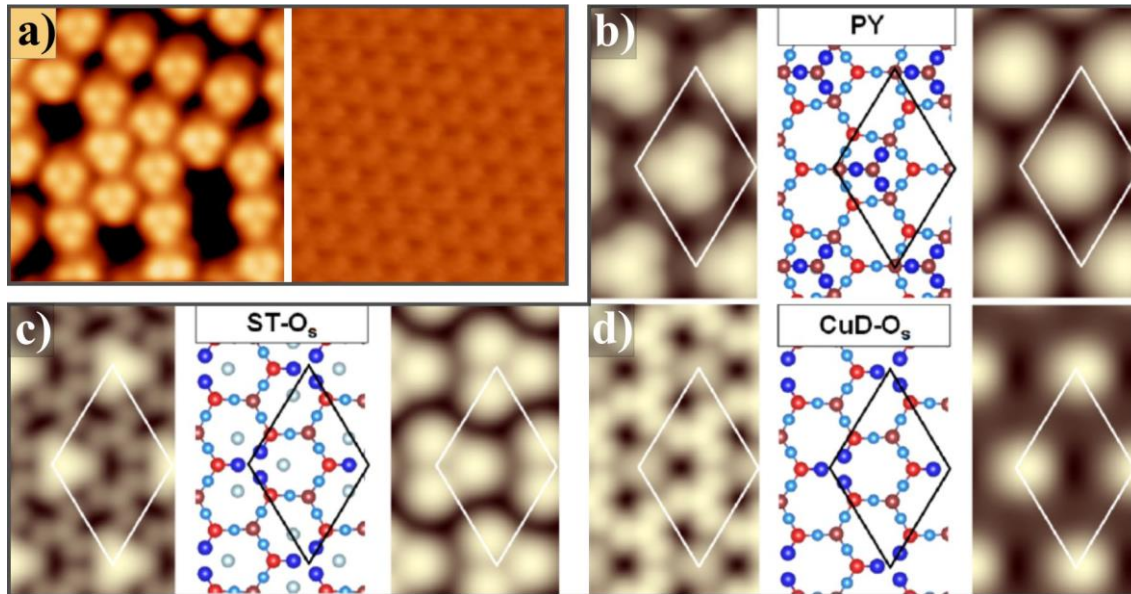
The riddle of the  $\text{Cu}_2\text{O}(111)$  surface reconstruction was finally solved in a joined STM/DFT-HSE study.<sup>114</sup> Starting point was the experimental registry of coexisting  $(1\times 1)$  and  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  lattices, as seen in LEED, and the apparent STM height of the detected triangular protrusions ( $1.5 \text{ \AA}$ , Fig. 17). On that basis, various surface models were constructed, e.g., the removal  $1/3$  of the low-coordinated surface  $\text{O}_{\text{cus}}$  ions either from the stoichiometric (ST) or Cu-deficient (CuD) termination, or the addition of different Cu-O complexes in the center of every third  $\text{Cu}_6\text{O}_6$  surface ring. Surface energies of all models were evaluated at the HSE level, revealing a clear preference for a novel surface structure in a wide range of oxygen chemical potentials that was coined the nano-pyramidal reconstruction (PY, Fig. 18). In this structure, the trifold protrusions are made of  $\text{Cu}_4\text{O}$  units positioned in the center of every third  $\text{Cu}_6\text{O}_6$  surface ring of a  $\text{Cu}_{\text{cus}}$ -deficient (CuD) surface. Hereby, three Cu ions form a triangle that is capped by a terminating O species, while the fourth one locates in the original position of the  $\text{Cu}_{\text{cus}}$ . The thermodynamic preference for this reconstruction largely arises from the chemical saturation of the low-coordinated surface  $\text{O}_{\text{cus}}$  atoms that obtain a fourth binding partner. The terminating  $\text{O}_{\text{cus}}$  species on top of the  $\text{Cu}_4\text{O}$  units binds strongly to their three Cu neighbors, resulting in a high level of chemical saturation. The  $\text{Cu}_4\text{O}$  pyramids populate every third six-membered surface ring, as they simultaneously saturate surface  $\text{O}_{\text{cus}}$  ions in three neighboring rings. It is worth pointing out that, similarly to the CuD termination in Fig. 13, the non-stoichiometry of the PY surface makes its calculated stability very sensitive to the correct account for the surface electronic structure. Consequently, the relative stabilities predicted by HSE and GGA approaches qualitatively differ, confirming the inability of GGA to assess the energetics of  $\text{Cu}_2\text{O}$  surfaces (Fig. 18).



**Figure 18:** (a) Top and side views of the nano-pyramidal reconstruction (PY) of the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$   $\text{Cu}_2\text{O}(111)$  surface with a  $\text{Cu}_4\text{O}$  unit in the center of every third  $\text{Cu}_6\text{O}_6$  surface ring.<sup>114</sup> (b) Calculated HSE (left) and GGA (right) surface energies of various  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$ - $\text{Cu}_2\text{O}(111)$  model reconstructions plotted as a function of the oxygen chemical potential. The labels ‘ $-\text{O}_s$ ’ and ‘ $-\text{O}_{ss}$ ’ refer to configurations with surface and subsurface oxygen vacancies, respectively. Energies of stoichiometric  $(1\times 1)$  terminations (ST) are plotted for reference.

In a second step, the authors simulated STM images of all considered surface models and compared them with measured STM data (Fig. 19).<sup>114,123</sup> For the fundamental  $(1\times 1)$  lattice, being occasionally observed as minority phase next to the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstruction, chemically saturated ( $\text{O}_{\text{csa}}$ ) and unsaturated ( $\text{O}_{\text{cus}}$ )

oxygen ions were resolved in the  $\text{Cu}_6\text{O}_6$  rings. A uniformly dark contrast in the ring center at positive and negative polarity further suggested the absence of  $\text{Cu}_{\text{cus}}$  ions in the surface layer (Fig. 17d). This conclusion is corroborated by simulated STM images of the stoichiometric  $(1\times 1)$  surface that exhibits a clear contrast reversal as a function of bias, while the  $\text{CuD}$  reconstruction does not.<sup>113</sup> For the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  phase, an excellent match between high-resolution STM images and the nano-pyramidal reconstruction was obtained with respect to shape, position and bias-dependence of the triangular protrusions (Fig. 19b). For an O-depleted surface with 1/3 of the  $\text{O}_{\text{cus}}$  ions missing, on the other hand, the appearance of unique  $\text{Cu}_3$  triples surrounding the vacancies on the ring perimeter was predicted, in contrast to experimental findings (Fig. 19c).<sup>127</sup> Finally, a  $\text{Cu}_{\text{cus}}$  and  $\text{O}_{\text{cus}}$ -depleted surface results in simulated STM images that are governed by the ring-structure of the  $\text{Cu}_2\text{O}(111)$  surface with localized protrusions marking the O defects in filled and empty state images, respectively (Fig. 19d). Although not observed on regular surfaces, this signature is in line with isolated O defects that occasionally occur in the oxide films, and indeed display the predicted bias-dependent contrast.<sup>114</sup> In general, the measured STM data of an ideal  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstructed  $\text{Cu}_2\text{O}(111)$  surface with its bias-independent array of triangular protrusions is clearly incompatible with both,  $\text{O}_{\text{cus}}$  and  $\text{C}_{\text{cus}}$ -depleted surface termination.<sup>106,119,122,123</sup>



**Figure 19:** (a) Close-up STM images of the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstruction and a  $(1\times 1)$  minority phase of  $\text{Cu}_2\text{O}(111)$ , shown on an identical height scale ( $U_{\text{B}} = -1.1$  V,  $5\times 5$  nm<sup>2</sup>). Simulated constant-current STM images and corresponding atomic representations of (b) the pyramidal, (c) the vacancy  $\text{ST-O}_s$  and (d) the vacancy  $\text{CuD-O}_s$  model of a reconstructed  $\text{Cu}_2\text{O}(111)$  surface at negative (left) and positive bias (right).

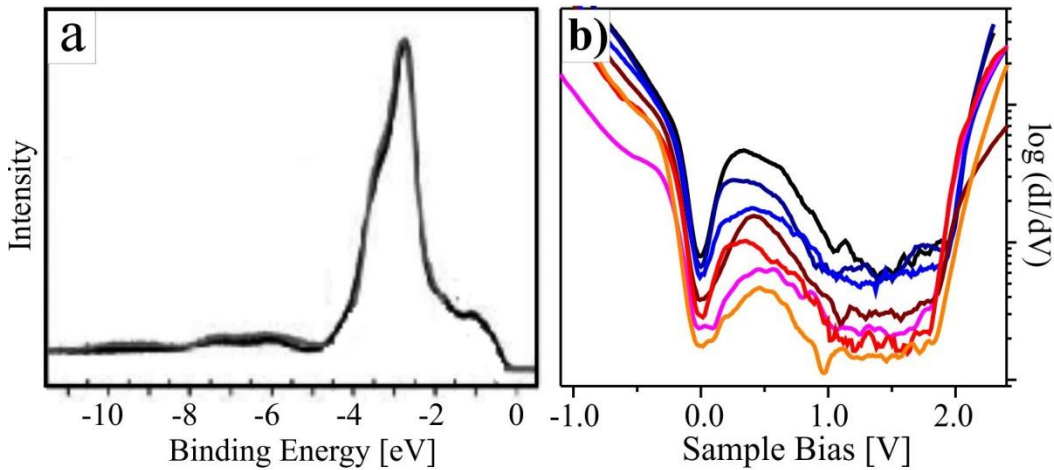
As a final note, oxygen vacancies in the  $\text{Cu}_2\text{O}(111)$  surface plane turned out to be instable in DFT calculations due to their tendency to migrate subsurface and to localize below the  $\text{Cu}_{\text{cus}}$  cations. The energy difference between a surface and a sub-surface O vacancy was estimated to  $\sim 0.3$  eV with GGA<sup>128</sup> and to  $\sim 0.6$  eV with HSE,<sup>114</sup> which renders accumulation of O defects in the very surface plane unlikely. These theo-

retical results falsify the established interpretation of  $\text{Cu}_2\text{O}$  experiments that assumes a well-ordered array of surface O defects to be present on the  $\text{Cu}_2\text{O}(111)$  surface.<sup>119,129</sup> In contrast, the nano-pyramidal reconstruction model is supported by its outstanding thermodynamic stability, a perfect match to high-resolution STM data, but also by a convincing agreement between calculated and experimental electronic properties, as discussed next.

### 3.2.2. Electronic properties

#### A. Band gap and in-gap electronic states

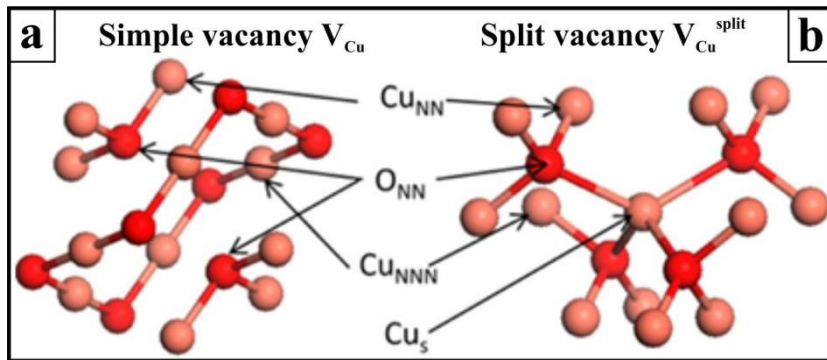
X-ray and ultraviolet photoelectron spectroscopy (PES) was employed to map the VB structure of  $\text{Cu}_2\text{O}(111)$ .<sup>106,130</sup> The experiments unambiguously revealed the p-type character of the material, as the VB onset essentially coincides with the Fermi level (Fig. 20a). As far as bulk effects were concerned, the main features in the PES intensity could be interpreted with help of a combined HSE+ $G_0W_0$  approach.<sup>112</sup> The small peak between 0 and -2.0 eV was assigned to the Cu 3d states hybridized with the O 2p orbitals, while the pronounced maximum between -2.0 and -4.0 eV is governed by the non-bonding part of the Cu 3d states. The center of gravity of the O 2p band only locates below -6.0 eV. At the band edges, the density of states includes contributions from the Cu 4s and O 3s orbitals. Since the energies of the s orbitals are usually not corrected by the DFT+U method, it becomes clear why the resulting band gap is hardly larger than the GGA one and why hybrid functionals are necessary to significantly shift the band edges. However, the dominant character of the VB and CB edge is Cu 3d and Cu 4s, respectively, rendering  $\text{Cu}_2\text{O}$  a typical example for a Mott-Hubbard insulator.<sup>131</sup>



**Figure 20:** (a) VB structure of  $\text{Cu}_2\text{O}(111)$  measured with PES.<sup>130</sup> (b) STM conductance spectra taken at different positions of thick (upper three curves, 2 nm) and thin (lower four curves, 1 nm)  $\text{Cu}_2\text{O}$  films grown on Au(111). The spectra are displayed in logarithmic representation to highlight the small in-gap intensity. The VB and CB onsets are readily identified at 0 and +1.9 eV, respectively.<sup>134</sup>

Theoretical studies of the  $\text{Cu}_2\text{O}(111)$  surface electronic structure have been performed on the basis of either GGA,<sup>115,116,118</sup> DFT+U,<sup>117,122,132</sup> or HSE methods.<sup>113,133</sup> They consistently disclose the semiconducting nature of the stoichiometric (ST) surface that exhibits a  $\text{Cu}_{\text{cus}}$  gap state with a position sensitive to the employed exchange-correlation functional.<sup>113</sup> Also for the oxygen-deficient  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  ST- $\text{O}_s$  termination, a semiconducting character is revealed with the empty  $\text{Cu}_{\text{cus}}$  state still being present in the gap. In contrast, the top of the VB is intersected by the Fermi level in Cu-deficient terminations, producing a metallic electronic structure. Experimentally, mostly the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstructed  $\text{Cu}_2\text{O}(111)$  surface was investigated. In surface sensitive O  $1s$  core level spectra, two oxygen species were identified, being localized in the bulk and surface of the crystal, respectively.<sup>130</sup> Given the pronounced inhomogeneity of the  $\text{Cu}_2\text{O}(111)$  surface, as caused by different reconstructions and defect features, averaging XPS techniques are unsuitable to provide information on the local electronic properties and their interplay with the atomic structure. For this purpose, STM differential conductance ( $dI/dV$ ) spectroscopy is the method of choice to examine the surface electronic structure of bulk and thin-film  $\text{Cu}_2\text{O}(111)$ .<sup>121,134</sup>

Respective spectra consistently show the band gap of the material, with the VB top located at the Fermi level ( $E_F$ ) and the CB onset at +1.9 eV, in line with the p-type nature of cuprous oxide (Fig. 20b).<sup>1</sup> Moreover, the measured gap size was found to be identical in thin-film and single-crystal data and agreed with literature values, too.<sup>121,134</sup> This correspondence emphasizes once more that high-pressure  $\text{Cu}_2\text{O}$  films grown on metal supports can be used as model systems for the bulk material. In addition, STM spectra taken on different  $\text{Cu}_2\text{O}(111)$  samples systematically revealed a finite  $dI/dV$  intensity in the lower part of the band gap (Fig. 20b). Due to small signal strength, this in-gap intensity is recognized best in logarithmic representations of the  $dI/dV$  traces. While the conductance peak is centered at  $\sim 0.5$  eV in thin-film  $\text{Cu}_2\text{O}$ , it narrows and downshifts to 0.3 V in spectra taken on bulk samples. Several scenarios have been considered to rationalize this unique in-gap intensity, for example resonant tunneling into Cu vacancy states and polaronic effects in the electron transport.<sup>111,134</sup> In order to clarify this point, we discuss spectroscopic fingerprints of the two Cu defects in bulk  $\text{Cu}_2\text{O}$  first (Fig. 21).





**Figure 21:** Local structure surrounding (a)  $V_{\text{Cu}}$  and (b)  $V_{\text{Cu}}^{\text{split}}$  defects in  $\text{Cu}_2\text{O}$ , as derived from DFT calculations. In the split vacancy,  $\text{Cu}_s$  moves towards the center of the vacancy where it tetrahedrally coordinates to the four nearest neighbour O atoms ( $\text{O}_{\text{NN}}$ ).  $\text{Cu}_{\text{NN}}$  are the Cu atoms nearest to  $\text{Cu}_s$ .<sup>11</sup>

The p-type conductance behavior of  $\text{Cu}_2\text{O}$  has been convincingly linked to the low formation energy of Cu vacancies in the lattice, which gives rise to low-lying acceptor states just above the VB edge.<sup>7</sup> Two types of bulk Cu defects have been identified by DFT calculations.<sup>6,11,12</sup> The so-called simple vacancy evolves from removing one Cu atom from the lattice and inducing a small relaxation of the two neighbouring low-coordinated  $\text{O}_{\text{cus}}$  ions (Fig. 21a). In the split vacancy, a neighbouring Cu moves towards the defect position until it reaches tetrahedral coordination with four adjacent O ions (Fig. 21b). While the structural parameters seem settled for the two defect types, their formation energies and thus their thermodynamic preference are still subject of controversy. In most theoretical approaches, the simple vacancy is energetically preferred over the split one, whereby differences in the formation energy range from 0.83 eV<sup>12</sup> to 0.06 eV,<sup>6</sup> depending on the DFT functional used in the calculations. In a designated HSE work, much higher formation enthalpies were determined, i.e., 1.3 (O-poor) and 1.15 eV (O-rich) for the simple  $V_{\text{Cu}}$  defect and 1.6 (O-poor) and 1.4 eV (O-rich) for the split vacancy, respectively.<sup>11</sup> Only in one work, the  $V_{\text{Cu}}^{\text{split}}$  defect was found to be lower in energy.<sup>135</sup> Unfortunately, the experimentally determined defect formation energies exhibit an even larger spread, ranging from 0.39 to 0.97 eV/defect, depending on the growth procedure of the  $\text{Cu}_2\text{O}$  samples.<sup>136,137,138</sup> This uncertainty renders a clear assignment of the experimental fingerprints to either simple or split Cu vacancies impossible.

More relevant for explaining the  $dI/dV$  intensity in the  $\text{Cu}_2\text{O}$  band gap (Fig. 20b) is however the position of the defect state induced by a given Cu vacancies. Although advanced hybrid functional DFT approaches have been exploited, the calculated single-particle defect energies show a substantial scattering as well. Scanlon et al. found in-gap energy levels of 0.52 and 1.12 eV for the simple and split vacancies in a bulk environment,<sup>12</sup> respectively, while Isserhoff and Carter determined those states to be just above  $E_{\text{F}}$  for the simple defect and at 0.57 eV for the split one.<sup>11</sup> These numbers need to be compared with the activation energies determined from temperature-dependent conductivity measurements on high-quality  $\text{Cu}_2\text{O}$  samples, using an Arrhenius approach (Fig. 2a). The relevant experiments clearly disclosed different conductance regimes, governed by a relatively high barrier of 0.4 eV above 500 K, which drops to 0.22 eV in the temperature range from 200 to 500 K and finally reaches 0.16 eV below 250 K.<sup>10</sup> The associated activation energies have been tentatively linked to the  $V_{\text{Cu}}^{\text{split}}$  induced acceptor level (0.4 eV), the simple  $V_{\text{Cu}}$  state (0.22 eV) and to a conductance mechanism mediated by nitrogen dopants in the  $\text{Cu}_2\text{O}$  lattice (0.16 eV). Alternative techniques, such as deep-level transient spectroscopy and photo-luminescence measurements, confirmed this range of acceptor activation energies. However, substantial scattering of the data

between 0.15–0.65 eV with respect to the VB top again prevented unambiguous assignment of the conductance channel to either simple or split Cu vacancies.<sup>139,140,141,142</sup>

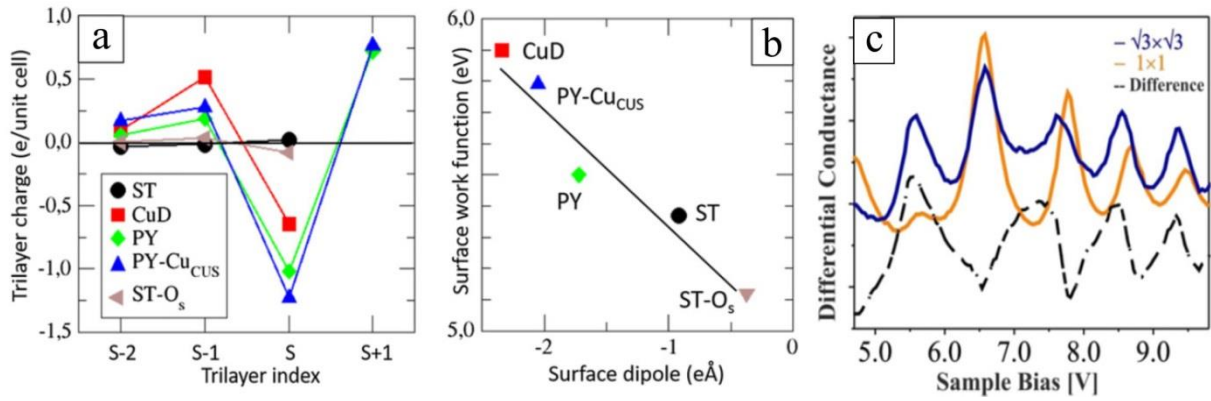
In principle, the asymmetric in-gap dI/dV intensity detected in STM conductance spectra of Cu<sub>2</sub>O(111) would be compatible with the presence of two gap states, as introduced by two unique Cu defect types (Fig. 20b). In fact, the in-gap maximum can be de-convoluted into two Gaussians centered at 0.4 and 0.75 V, bias values that fairly agree with DFT predictions of the two bulk defect levels.<sup>11,12</sup> Despite these similarities, an assignment of the in-gap dI/dV maxima to resonant tunneling into defect states provided by simple and split Cu vacancies appears implausible for the following reasons. First, with STM spectroscopy as a local probe, it should be possible to identify and differentiate single Cu defects in the surface. However, the in-gap dI/dV response was found to be homogeneously distributed across the entire Cu<sub>2</sub>O(111) surface. Second, the detected asymmetry of the in-gap intensity is similar at all spectral positions, although simple and split vacancies should exhibit a certain distribution in the film. And third, the intensity of the dI/dV signal varies distinctively with layer thickness in case of Cu<sub>2</sub>O films, and can be manipulated via the tunneling current in spectra acquired on Cu<sub>2</sub>O bulk crystals.<sup>121</sup> Especially the last observation is in conflict with an interpretation based on resonant tunneling into oxide defect states but rather suggests electric-field effects in the tip-sample junction to be responsible for the in-gap dI/dV intensity. Consequently, an additional aspect needs to be considered for explaining the finite conductance signal in the Cu<sub>2</sub>O band gap, namely intrinsic and extrinsic band-bending effects in the reconstructed Cu<sub>2</sub>O(111) surface. The origin of surface band-bending and its impact on the electronic structure of different Cu<sub>2</sub>O(111) terminations is discussed in the next paragraph.

### ***B. Band-bending effects***

Surface band-bending may follow two fundamental schemes, the first one initiated by a deviating stoichiometry of different oxide reconstructions with respect to bulk cuprous oxide (intrinsic band bending), the second one being introduced by an incomplete screening of the tip-electric field at the dielectric surface (tip-induced band bending).

The previously considered Cu<sub>2</sub>O(111) reconstructions (Fig. 13), all come with a distinct chemical composition of the surface oxide layers. Only the stoichiometric (1×1) surface (ST) is charge neutral, while the O-deficient ST-O<sub>s</sub> with 1/3 of the surface O<sub>Cus</sub> ions being removed has two excess electrons per ( $\sqrt{3}\times\sqrt{3}$ ) unit cell. The Cu-poor terminations, on the other hand, are all electron-deficient, with the nano-pyramidal (PY) and the Cu-deficient (CuD) reconstruction lacking one and three electrons per ( $\sqrt{3}\times\sqrt{3}$ ) cell, respectively. An intermediate charge state is adopted in the PY-Cu<sub>Cus</sub> phase, which derives from the pyramidal reconstruction with the Cu<sub>Cus</sub> ions below each nano-pyramid being removed. In that surface, formally two

electrons are missing per  $(\sqrt{3}\times\sqrt{3})$  cell with respect to the stoichiometric case. To deduce the real charge distribution in the surface and the emergence of surface dipoles, screening effects of the formal charge imbalances need to be taken into account. Cuprous oxide, as a prototypical p-type conductor, features high hole mobility, while excess electrons tend to localize in the Cu orbitals of the surface atoms. The screening response and the resulting charge distribution in surface and sub-surface layers of  $\text{Cu}_2\text{O}(111)$  are displayed in the calculated charge profiles shown in Fig. 22.<sup>133</sup> An essentially flat profile is obtained for the stoichiometric termination (ST), as expected from its charge neutrality. A similarly flat profile is found for the Cu-rich  $\text{ST-O}_s$  termination as well, showing that surface oxygen vacancies do not trigger a considerable subsurface electron redistribution. Indeed, the excess electrons left behind by the missing oxygen atom remain mostly localized on the three nearest Cu neighbors. Conversely, in the Cu-deficient terminations (CuD, PY, and PY- $\text{Cu}_{\text{cus}}$ ), the holes created at the VB top around  $E_F$  produce a positive charging which propagates into the subsurface layers S-1, S-2, and beyond. These positive charges are balanced by a negatively charged surface trilayer (S and S+1 layers), as depicted in Fig. 22a.

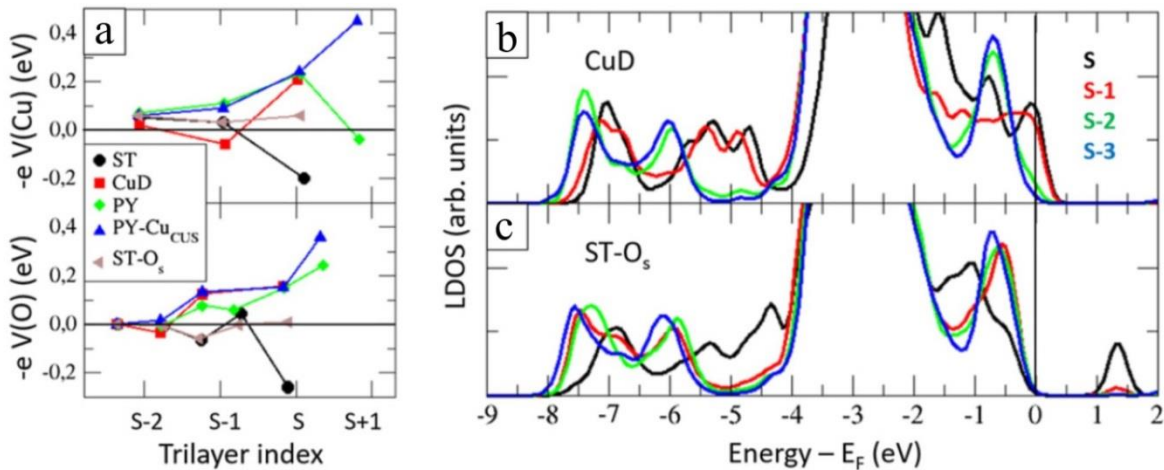


**Figure 22:** (a) Calculated charge profiles of trilayers in different  $\text{Cu}_2\text{O}(111)$  terminations. Indices  $S$ ,  $S-1$ , and  $S-2$  refer to the surface, subsurface, and sub-subsurface trilayer, respectively.  $S+1$  includes all atoms above the surface plane of the ST surface. (b) Work function of various  $\text{Cu}_2\text{O}(111)$  terminations calculated as a function of their total surface dipoles. (c) Series of field emission resonances (FERs) measured on  $(\sqrt{3}\times\sqrt{3})$  and  $(1\times 1)$  patches of  $\text{Cu}_2\text{O}(111)$  films. The black curve shows the difference of the two spectra.<sup>133</sup>

The subsurface propagation of positive charges produces a surface dipole moment that in turn affects the work function  $\phi$  of the different  $\text{Cu}_2\text{O}(111)$  terminations (Fig. 22b). In correspondence to the basic Helmholtz formula, surface dipole and work function follow a nearly linear relationship with the CuD having the largest  $\phi$  value due to its electron-rich surface configuration. Experimentally, the local surface potential of the coexisting CuD and PY terminations has been determined via the positions of field emission resonances (FERs) in the STM junction. The latter correspond to bound electronic states in a potential well formed between vacuum barrier and sample surface.<sup>143</sup> From the results shown in Fig. 22c and a fit of the resonance positions to a triangular particle-in-a-box model, work function values of 5.85 and 5.4 eV were obtained for the  $(1\times 1)$  and  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  surface, respectively. The results reflect the lower work

function of the PY termination with respect to that of CuD, in agreement with the higher Cu-deficiency of the latter. In fact, there is even a quantitative agreement between calculated and experimental  $\phi$  values.

Figure 23 displays the relationship between the surface-charge distribution in different Cu<sub>2</sub>O(111) terminations and the electrostatic potentials experienced by Cu and O ions in successive trilayers. The potential shifts are hereby representative for both, the positions of the core levels and the center of gravity of the oxide VB (Fig. 23b). The qualitatively different behavior at O-poor and Cu-poor terminations is best seen in the response of the coordinatively saturated ions (Fig. 23a). While O-poor surfaces display a flat profile, the Cu-poor terminations are characterized by an upward shift of the potential due to hole migration towards subsurface layers, as discussed before. The up-shift of the potential also gives rise to an upward band bending in the Cu-deficient Cu<sub>2</sub>O(111) surfaces that disappears for stoichiometric and O-deficient configurations (Fig. 23b,c). An additional up-shift of the atomic levels arises for coordinatively unsaturated ions and originates from the reduced electrostatic potential associated to their low coordination. We note that there is an ongoing discussion in the literature that advocates exactly the opposite trend namely downward band bending on a hypothetical O-deficient  $(\sqrt{3}\times\sqrt{3})R30^\circ$  surface.<sup>129,144</sup> However, many assumptions in those works are based on an incorrect surface model. Moreover, DFT calculations predict a unique defect state induced by O vacancies in the upper part of the Cu<sub>2</sub>O band gap (see gap state at 1.5 eV in Fig. 23c). A corresponding resonance could never be detected in dI/dV spectra of  $(\sqrt{3}\times\sqrt{3})R30^\circ$  reconstructed Cu<sub>2</sub>O(111), rendering an ordered array of O defects an unlikely reason for the observed surface reconstruction.

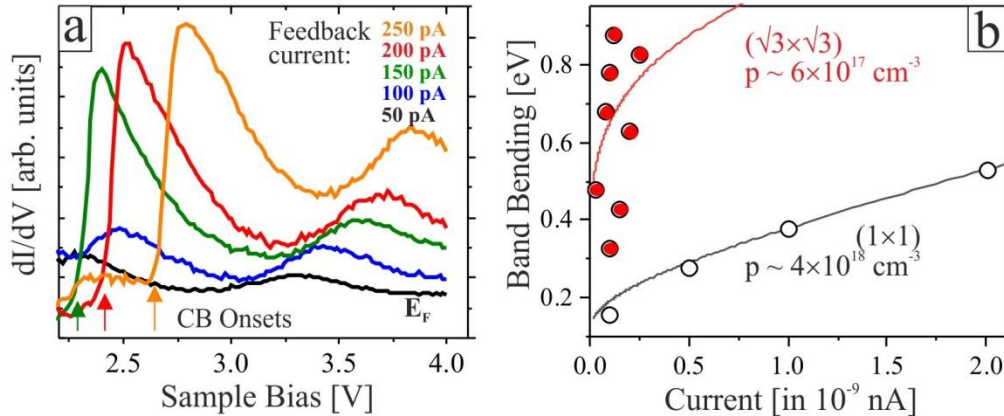


**Figure 23:** (a) Relative positions of atomic levels at the saturated O ( $-eV(\text{O})$ ) and Cu ions ( $-eV(\text{Cu})$ ) in  $S$ ,  $S-1$ ,  $S-2$  and  $S+1$  trilayers of different Cu<sub>2</sub>O(111) terminations. Density of states of (b) the CuD and (c) the ST-O<sub>s</sub> termination projected on Cu atoms in the indicated trilayers.<sup>133</sup> The upward band bending in Cu-deficient surface reconstructions is clearly revealed.

The upward bending of surface bands induced by the nano-pyramidal Cu<sub>2</sub>O reconstruction now provides a reliable explanation for the in-gap intensity detected in the lower part of the Cu<sub>2</sub>O gap at 0.5 eV (Fig.

20b).<sup>134</sup> The p-type nature of  $\text{Cu}_2\text{O}$  puts the Fermi level to the VB top already in a bulk environment. The upward band bending at the Cu-deficient  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstruction further pushes  $E_F$  into the VB, producing an empty-state pocket at the band edge. While tunneling into this pocket is inefficient at zero bias, given the vanishing electric field in the tip-sample junction, an electron current can be detected at small positive bias, as electrons propagate from filled states in the tip towards empty states in the VB pocket. The result is a finite  $dI/dV$  intensity in the lower part of the oxide band gap, as reproducibly detected in  $dI/dV$  spectra of the reconstructed  $\text{Cu}_2\text{O}(111)$  surface (Fig. 20b).

Additional proof for this band-bending model comes from modulations of the in-gap intensity in STM spectroscopy measurements either with oxide thickness for supported  $\text{Cu}_2\text{O}$  films or with the tip electric field in the case of bulk crystals.<sup>121,134</sup> In both cases, the intrinsic band bending due to a non-stoichiometric surface is reinforced by the electric field from the STM tip that penetrates deep into the dielectric oxide material. The consequence is a larger in-gap peak for thicker  $\text{Cu}_2\text{O}$  films, as the diminishing screening response of the metal support promotes band-bending in the oxide layer, hence the size of the empty VB pocket. On bulk  $\text{Cu}_2\text{O}$  with its low free-carrier density, tip-induced band-bending effects become evident at the CB onset as well. Here, a continuous shift of the CB edge from its zero-field position at 2.0 V to above 3.0 V is observed upon rising the tunneling current, hence the tip electric field (Fig. 24a). By fitting this shift to the Poisson equation, describing electric-field screening by the carriers of a dielectrics, an approximation of the carrier density in the  $\text{Cu}_2\text{O}$  surface is obtained (Fig. 24b). Interestingly, the  $\text{CuD}$   $(1\times 1)$  surface has a much better screening ability than the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  pyramidal reconstruction, in perfect agreement with the higher Cu-deficiency of the former.

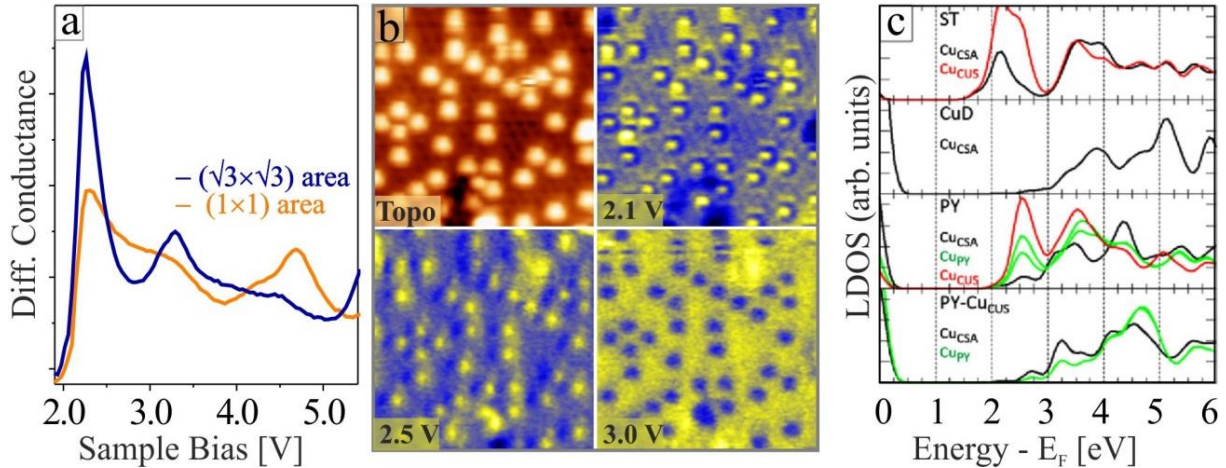


**Figure 24.** (a) Bias-dependent  $dI/dV$  intensity measured at constant-current conditions on bulk  $\text{Cu}_2\text{O}(111)$ . The CB onset of the oxide, readily recognized by the sudden conductance rise, experiences an upshift with increasing tunneling current, hence with larger electric fields (see arrows). (b) Tip-induced band bending calculated for two carrier concentrations (solid lines) in comparison with experimental values obtained on  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  and  $(1\times 1)$  reconstructed patches of a  $\text{Cu}_2\text{O}(111)$  bulk crystal (red and black dots, respectively). The carrier densities required to reproduce the measured screening response are given in the plots.<sup>121</sup>

### C. Properties of the $\text{Cu}_2\text{O}(111)$ conduction band

STM conductance spectra acquired on different  $\text{Cu}_2\text{O}(111)$  surface reconstructions revealed different  $dI/dV$  intensity courses in the region of the oxide CB. While the band onset shows up by a sudden increase of the  $dI/dV$  intensity at 2.1 V in the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  reconstructed regions, it is less pronounced in the  $(1\times 1)$  minority phase (Fig. 25a).<sup>133</sup> A similar behavior is observed in  $dI/dV$  maps of the oxide surface. The  $\text{Cu}_4\text{O}$  maxima of the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  phase turn bright and develop a sombrero shape, i.e., a bright center surrounded by a dark ring, directly at the CB onset at 2.1 V. As the bias increases, the contrast diminishes and even inverts at  $\sim 3.0$  V, when the  $\text{Cu}_4\text{O}$  maxima exhibit lower conductance than the environment (Fig. 25b).

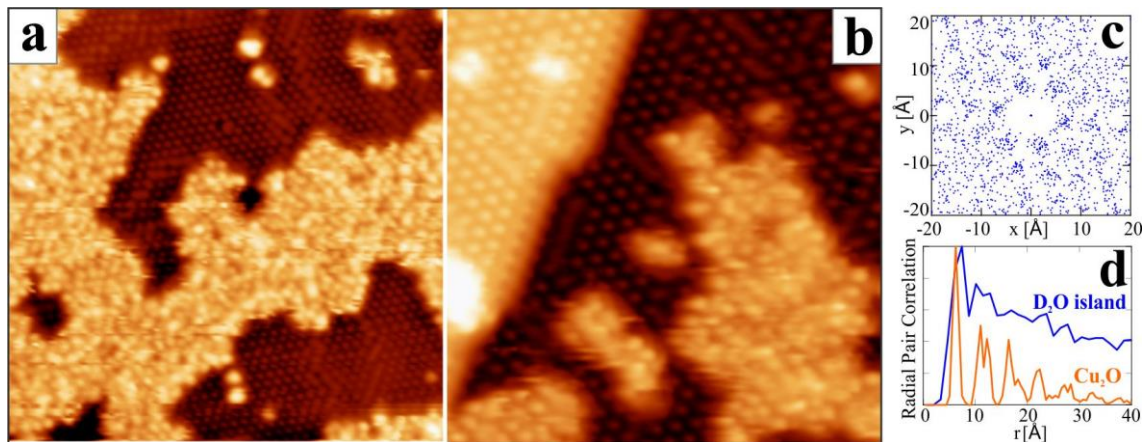
These peculiarities in the  $dI/dV$  intensity can be related to the energy course of the Cu-projected local density of states (LDOS). It exhibits a characteristic dip at  $\sim 3.0$  eV (Fig. 25c), arising from different CB onsets in different oxide regions. The stoichiometric (ST) and pyramidal (PY) phase show low-lying band onsets due to a characteristic LDOS peak at 2.5 eV, related to the presence of  $\text{Cu}_{\text{cus}}$  surface species. In contrast, no  $\text{Cu}_{\text{cus}}$  atoms are available in the  $\text{CuD}$  and  $\text{PY-Cu}_{\text{cus}}$  terminations, and the band onset consequently up-shifts to 3.0 eV. It is the missing LDOS peak at 2.5 eV that reduces the  $dI/dV$  intensity at the CB onset of the  $(1\times 1)$  but not of the  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  termination of  $\text{Cu}_2\text{O}(111)$  (Fig. 25a).<sup>133</sup>



**Figure 25:** (a) Differential conductance ( $dI/dV$ ) spectra covering the CB onset in  $(\sqrt{3}\times\sqrt{3})\text{R}30^\circ$  and  $(1\times 1)$  regions of the  $\text{Cu}_2\text{O}(111)$  surface. (b) Topography and conductance maps of  $\text{Cu}_2\text{O}(111)$  taken at bias values around the CB onset ( $I = 50$  pA,  $12 \times 12$  nm<sup>2</sup>). (c) LDOS of the CB region, projected onto inequivalent surface Cu atoms at the ST,  $\text{CuD}$ , PY, and  $\text{PY-Cu}_{\text{cus}}$  termination.<sup>133</sup>

### 3.2.3. Adsorption behavior and reactivity

Given its thermodynamic stability, the  $\text{Cu}_2\text{O}(111)$  surface has been subject of numerous adsorption studies performed by spectroscopic and imaging techniques. Early experimental studies by Cox and coworkers date back to the 1990's, and addressed the effect of oxygen adsorption to the  $(1\times 1)$  termination.<sup>106</sup> For low and moderate  $\text{O}_2$  exposure ( $<10^4$  L), no  $\text{O}_2$  uptake was revealed, indicating the chemical inertness of the  $(1\times 1)$  surface. Using STM and XPS, the adsorption of water and  $\text{SO}_2$  on a  $(\sqrt{3}\times\sqrt{3})$  reconstructed  $\text{Cu}_2\text{O}(111)$  surface was examined by Önsten and co-workers later.<sup>145</sup> Water adsorption at 150 K resulted in a pronounced O  $1s$  peak due to molecular adsorption and a weak OH signal compatible with 10% dissociative interactions. Upon annealing to 180 K, the OH coverage increased to 20%, while the molecular water completely desorbed. Water adsorption at room temperature turned out to be ineffective. In contrast,  $\text{SO}_2$  binds in the form of  $\text{SO}_3$  to the  $\text{Cu}_2\text{O}(111)$  surface, as deduced from a new O  $1s$  component at 531 eV in XPS.<sup>145</sup> At 150 K, the saturation coverage of 40% is reached, declining to 9% at room temperature. These observations have been corroborated by XP spectra covering the S  $2p$  core level region. Both,  $\text{H}_2\text{O}$  and  $\text{SO}_2$  adsorption has been tentatively related to the activity of twofold under-coordinated O ions, as produced by Cu defects in the surface.<sup>145</sup> Moreover, two STM studies dealt with the interaction of water with copper oxide surfaces, however, only addressed the ultrathin precursor oxide grown on metal substrates. In a first work, magic water clusters composed of one or few cyclic  $\text{H}_2\text{O}$  hexagons have been prepared by low-temperature water deposition plus 300 K annealing on the oxide surface.<sup>146</sup> The individual water clusters could be resolved by STM, their internal structure was rationalized by means of DFT+U calculations. In a second experiment, the water was dosed at 100 K and organized on the oxide surface by gradual annealing.<sup>147,148</sup> At 155 K, desorption of the water multilayer was detected via thermal desorption spectroscopy, while the monolayer remained bonded up to 175 K, a temperature compatible with physisorptive interactions. High resolution STM images of the latter revealed  $\text{H}_2\text{O}$  monolayer islands without apparent long-range order (Fig. 26 a,b). Pair correlation functions calculated from these images revealed, however, a hexagonal short-range order of the individual water molecules with a mean distance of 6 Å, i.e., in registry with the  $\text{Cu}_2\text{O}(111)$  lattice (Fig. 26 c,d). Also, the  $\text{H}_2\text{O}$  assembly into distorted six-membered molecular clusters was clearly revealed in this study. Further experiments investigated methanol adsorption and desorption processes on  $\text{Cu}_2\text{O}(111)$  and  $(100)$  surfaces, as a means to explore CH- and CO- bond breaking reactions on oxide surfaces.<sup>149</sup> Dissociative methanol bonding was revealed already at temperatures as low as 140 K and led to the formation of mixed layers on the oxide surface, comprising methoxy, formaldehyde and  $\text{CH}_x\text{O}_y$  species. Hereby, the  $(111)$  surface was found to be more reactive than its  $(100)$  counterpart.



**Figure 26:** High-resolution STM images of water islands on  $\text{Cu}_2\text{O}(111)$  thin films (a) ( $28 \times 28 \text{ nm}^2$ ) and (b) ( $15 \times 15 \text{ nm}^2$ ). (c) 2D and (d) radial pair-correlation function of water related maxima and the bare  $\text{Cu}_2\text{O}$  surface, as calculated from the STM image in panel (a). Despite local disorder, the water molecules follow the registry of the  $\text{Cu}_2\text{O}(111)$  surface and adopt the same binding periodicity.<sup>147</sup>

True atomistic insights into  $\text{Cu}_2\text{O}(111)$  adsorption properties, especially into binding sites and interaction mechanisms, have been generated by different DFT studies. The theoretical exploration of  $\text{Cu}_2\text{O}(111)$  was initiated by a DFT+U study on  $\text{CO}_2$  adsorption to stoichiometric, as well as  $\text{Cu}_{\text{cus}}$  and  $\text{O}_{\text{cus}}$ -deficient terminations.<sup>150</sup> On the stoichiometric surface, the energetically preferred binding scenario is a linear, neutral  $\text{CO}_2$  in tilted configuration, attached to a chemically unsaturated  $\text{Cu}_{\text{cus}}$  ion ( $E_{\text{B}} = 0.4 \text{ eV}$  with dispersion). In the presence of surface defects, bent  $\text{CO}_2$  geometries were found, indicative for a charge transfer towards the molecule. However, the presence of defects results in an overall decrease of the mean adsorption energy, and the removal of the  $\text{Cu}_{\text{cus}}$  ions suppresses the most active sites for  $\text{CO}_2$  adsorption.

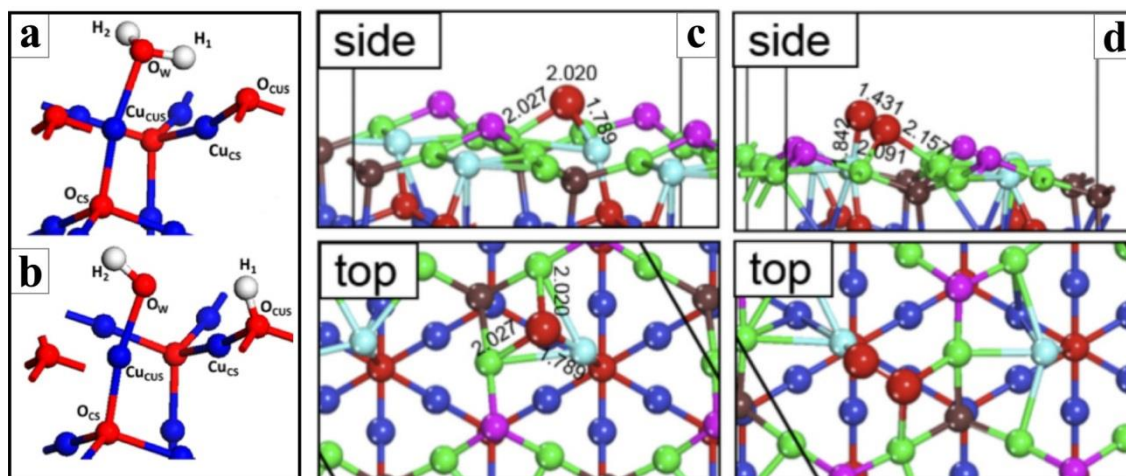
A rather similar DFT binding scenario was uncovered for water on the  $\text{Cu}_2\text{O}(111)$  surface.<sup>151</sup> Here, attachment of the water oxygen to low-coordinated  $\text{Cu}_{\text{cus}}$  ions produces the most effective, associative binding configuration ( $E_{\text{B}} = -1.1 \text{ eV}$ ), whereas hydrogen bonding to  $\text{O}_{\text{cus}}$  ions is less favorable (Fig. 27). Dissociative binding can be discarded, as the individual OH and H binding contributions do not compensate the energy costs of the water splitting. As discussed for the  $\text{CO}_2/\text{Cu}_2\text{O}$  adsorption system before, a  $\text{Cu}_{\text{cus}}$  depleted surface becomes inactive for water adsorption and is chemically inert. Two further DFT-based studies essentially reproduced the  $\text{H}_2\text{O}$  adsorption behavior discussed before.<sup>152,153</sup> Again, the  $\text{Cu}_{\text{cus}}$  surface ions were found to be the preferred adsorption sites in the low-coverage regime, while binding to low-coordinated  $\text{O}_{\text{cus}}$  ions solely takes place upon approaching monolayer coverage. As expected, population of less-preferred binding sites at higher coverage is accompanied by a gradual reduction of the mean binding energy that downshifts from  $-1.7$  to  $-1.1 \text{ eV}$  when going from one to eight  $\text{H}_2\text{O}$  molecules per unit cell, respectively. Dissociative binding scenarios of water become important only in presence of O vacancies in the  $\text{Cu}_2\text{O}(111)$  surface.<sup>154</sup> We note that the thermodynamically preferred nano-pyramidal reconstruction of



$\text{Cu}_2\text{O}(111)$  actually lacks  $\text{Cu}_{\text{cus}}$  surface ions,<sup>114</sup> i.e., the primary water binding site. The topic of water adsorption to realistic  $\text{Cu}_2\text{O}(111)$  surfaces thus requires careful revision both, from experiment and theory.<sup>146</sup>

A comparative study on oxygen adsorption to all three low-index  $\text{Cu}_2\text{O}$  planes was presented in Ref. 155. On the (111) surface, atomic oxygen preferentially binds to hollow positions formed by three Cu surface ions, two  $\text{Cu}_{\text{csa}}$  and one  $\text{Cu}_{\text{cus}}$ . A similar position is adopted by the  $\text{O}_2$  molecule, with one O atom located above the  $\text{Cu}_{\text{cus}}$  ion and the other one on a  $\text{Cu}_{\text{csa}}\text{-Cu}_{\text{csa}}$  bridge site. Dissociation of the molecule is preferred by 0.25 eV, whereby both atoms propagate towards adjacent Cu hollow sites. Given its high symmetry and chemical saturation, the  $\text{Cu}_2\text{O}(111)$  surface shows the lowest incentive for  $\text{O}_2$  dissociation, while 1.16 eV and even 2.43 eV excess energy are released upon  $\text{O}_2$  splitting on the  $\text{Cu}_2\text{O}(110)$  and (100) surface. In both cases, the dissociation involves low-coordinated  $\text{Cu}_{\text{cus}}$  ions and results in a substantial reconstruction of the oxide top layer.<sup>155</sup> Again, the calculations neglect more recent atomic models of  $\text{Cu}_2\text{O}$  surface reconstructions, and cannot rely on an experimental verification of the proposed binding scenarios.

Finally, metal adsorption to the  $\text{Cu}_2\text{O}(111)$  surface has been identified as a promising pathway to produce single-site catalysts.<sup>156</sup> A systematic DFT screening of the bonding behavior of transition metal atoms to  $\text{Cu}_2\text{O}(111)$  revealed that especially the noble metals Pd, Pt and Au show a high tendency to bind as single atoms due to a highly negative binding energy and a positive dissolution energy on the oxide surface. The first successful preparation of a single-atom catalysts is reported in Ref. 157. In this experiment, Copthalocyanine molecules were dosed onto a O-deficient  $\text{Cu}_2\text{O}(111)$  surface and decomposed via oxygen-annealing, whereby the central Co atom gets released and attaches to an O vacancy site.



**Figure 27:** Optimized adsorbate geometries on stoichiometric  $\text{Cu}_2\text{O}(111)$  with  $(1\times 1)$  periodicity, (a) datively bonded water at 0.5 ML coverage and (b) dissociated water at 1 ML coverage.<sup>151</sup> (c) Atomic and (d) molecular oxygen adsorption to  $\text{Cu}_2\text{O}(111)$  ( $\text{Cu}_{\text{cus}}$ : light blue,  $\text{Cu}_{\text{csa}}$ : green, surface O: purple, other O: brown, red).<sup>155</sup>

### 3.3. The Cu<sub>2</sub>O(100) surface

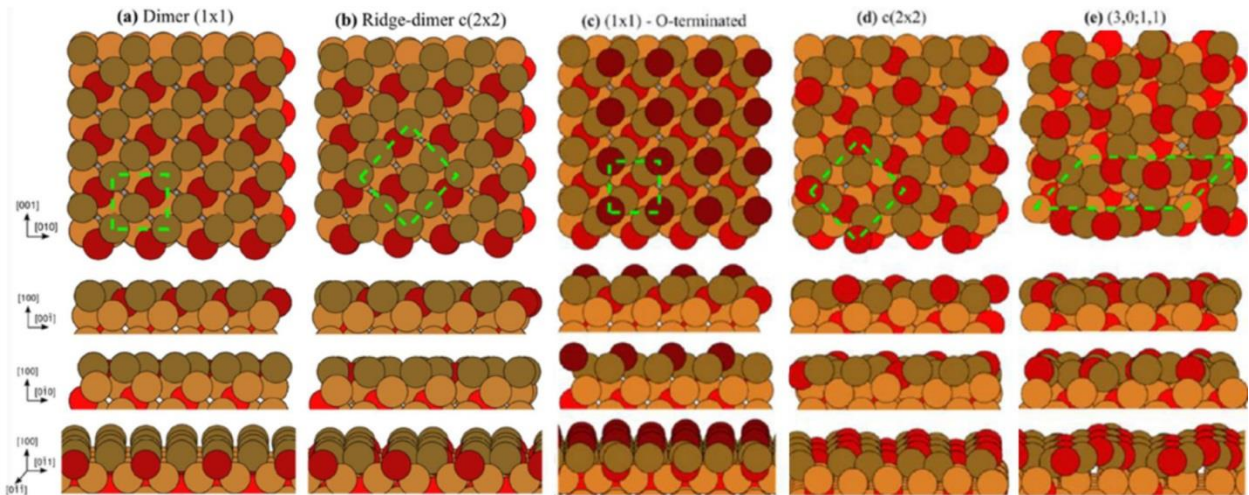
#### 3.3.1 Termination: Theory and experiment

As stated earlier, the (100) surface of Cu<sub>2</sub>O is a Tasker-type III polar surface, as positively charged 2 Cu<sup>+</sup> and negatively charged O<sup>2-</sup> atomic planes alternate in the direction perpendicular to the surface.<sup>2</sup> The bulk-cut (100) surface can thus be either O- or Cu-terminated, but is expected to undergo reconstructions to remove the macroscopic dipole and lower the surface energy. The ideal, bulk-cut surface can be seen as made of a square network of Cu<sub>4</sub>O tetrahedrons with 4.3 Å periodicity, comprising two O ions above and two O ions below the Cu plane (Fig. 12). Already early diffraction experiments by Schulz and Cox unraveled the large susceptibility of Cu<sub>2</sub>O(100) for structural reconstructions.<sup>106,158</sup> Upon ion sputtering and vacuum annealing at 500 K, a faint (3√2×√2)R45° superstructure was revealed in electron diffraction, although there were many missing spots in the LEED pattern. The surface was tentatively assigned to the Cu terminated phase, produced by oxygen desorption from the surface at the O-poor preparation conditions. At slightly lower annealing temperature (450 K), a (√2×√2)R45° developed, indicative for partial removal of the oxygen top-layer. A surface with (1×1) registry could only be obtained upon heavy oxygen dosage of 10<sup>9</sup> L, suggesting the development of an O-terminated Cu<sub>2</sub>O(100) surface. The differentiation between Cu-rich and O-rich surfaces was further corroborated by XPS measurements, revealing a distinct drop in the Cu-to-O ratio from 1.6 to 1.3 at annealing temperatures above 800 K.<sup>106</sup>

The underlying atomic structure of the bulk-cut (1×1) Cu-terminated surface was examined in a first DFT-GGA work performed by McClenaghan et al.<sup>159</sup> They proposed the bulk-cut termination to be charge-compensated via an electronic reconstruction mechanism, implying partial filling of the Cu conduction states. Indeed, the authors found a reduced charge at the surface Cu<sub>cus</sub> atoms, being equivalent to roughly 1/3 of the bulk value. Moreover, strong relaxation effects take place, resulting in the formation of Cu dimers at the surface and between the first and third layers (Fig. 28). Upon relaxation, the Cu-Cu distances in the surface and perpendicular to it shrink from 3.02 Å to 2.37 Å and 2.46 Å, respectively. The dimerization is associated with a splitting of the compensating Cu states, transforming the local electronic structures from metallic to semiconducting. Subsequent GGA,<sup>115,160</sup> and DFT+U simulations<sup>117</sup> on this (1×1) termination essentially reported the same dimerized structure. Working in a (2×2) unit cell, Le et al. additionally showed that slightly more energy may be gained by forming pairs of dimer rows (ridge-dimer reconstruction in Fig. 28b).<sup>160</sup> In addition, the (1×1) O-terminated surface, comprising one bridging surface oxygen per unit cell, was studied with a GGA approach,<sup>115</sup> and a moderate inward relaxation of the top-most O ions was found. This termination is favored over the (1×1) Cu-terminated one in a large span of O-moderate and O-rich conditions, relevant to most UHV experiments. Removing a single Cu<sub>csa</sub> or O<sub>csa</sub>

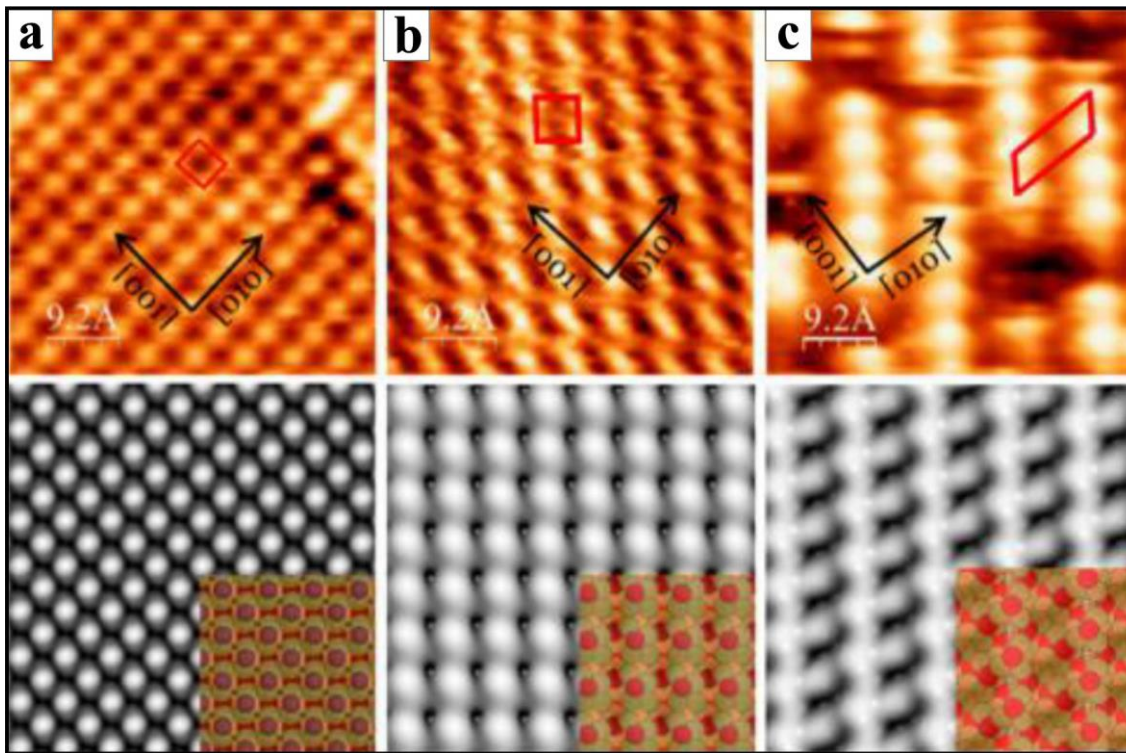
in the smallest (1×1) Cu- or O-terminated surface, respectively, is in most cases thermodynamically unfavorable with respect to the ideal configuration. Only a Cu-termination with one half of the Cu atoms missing, which corresponds to a polar compensated configuration, displays a lower energy than the corresponding ideal surface. The semiconducting electronic structure of this surface was disclosed in Ref. 161.

Within this first period of time, the experimentally detected  $(3\sqrt{2}\times\sqrt{2})R45^\circ$  superstructure of  $\text{Cu}_2\text{O}(100)$  was only addressed by simulations of bulk-cut terminations in the experimental unit cells, using either a GGA approach,<sup>160</sup> a molecular dynamics GGA simulation,<sup>161</sup> or a DFT+U calculation.<sup>117</sup> The first study found that the  $(3\sqrt{2}\times\sqrt{2})R45^\circ$  is unstable and relaxation leads to a  $(\sqrt{2}\times\sqrt{2})R45^\circ$  surface pattern displaying rows of paired Cu dimers (Fig. 28b). Overall, the dimer characteristic did not change significantly with respect to that obtained in the (1×1) cell and no major energy gain was found upon increasing the unit-cell size. Consequently, no convincing explanation for the superstructure pattern detected in diffraction experiments was provided. In parallel, DFT+U calculations were employed to explore the reconstruction of the O-terminated surface by removing one-half of the surface anions in a  $(\sqrt{2}\times\sqrt{2})R45^\circ$  unit cell.<sup>117</sup> By reducing the formal charge of the surface plane by half, such a reconstruction perfectly heals the polarity of the ideal oxygen termination. The  $(\sqrt{2}\times\sqrt{2})R45^\circ$  structure was found to be the most stable in typical O environments of an UHV experiment, while the transition towards an unreconstructed (1×1) O-surface was predicted at excessively O-rich conditions. This  $(\sqrt{2}\times\sqrt{2})R45^\circ$  reconstruction nevertheless has an energy nearly twice as large as that of the non-polar (1×1) (111) termination ( $1.17 \text{ J/m}^2$  vs  $0.67 \text{ J/m}^2$ ), in agreement with the abundance of (111) with respect to (100) facets observed for  $\text{Cu}_2\text{O}$  nanoparticles.<sup>35,36,37,38</sup>



**Figure 28:** Top and side views of various models of the  $\text{Cu}_2\text{O}(100)$  surface: (a) dimer rows and (b) pairs of dimer rows on the Cu-termination, (c) (1×1) O-termination, (d)  $c(2\times 2)$  and (e) (3,0;1,1) reconstructed Cu-termination. Oxygen: Red and purple balls, Copper: dark and light brown.<sup>162</sup>

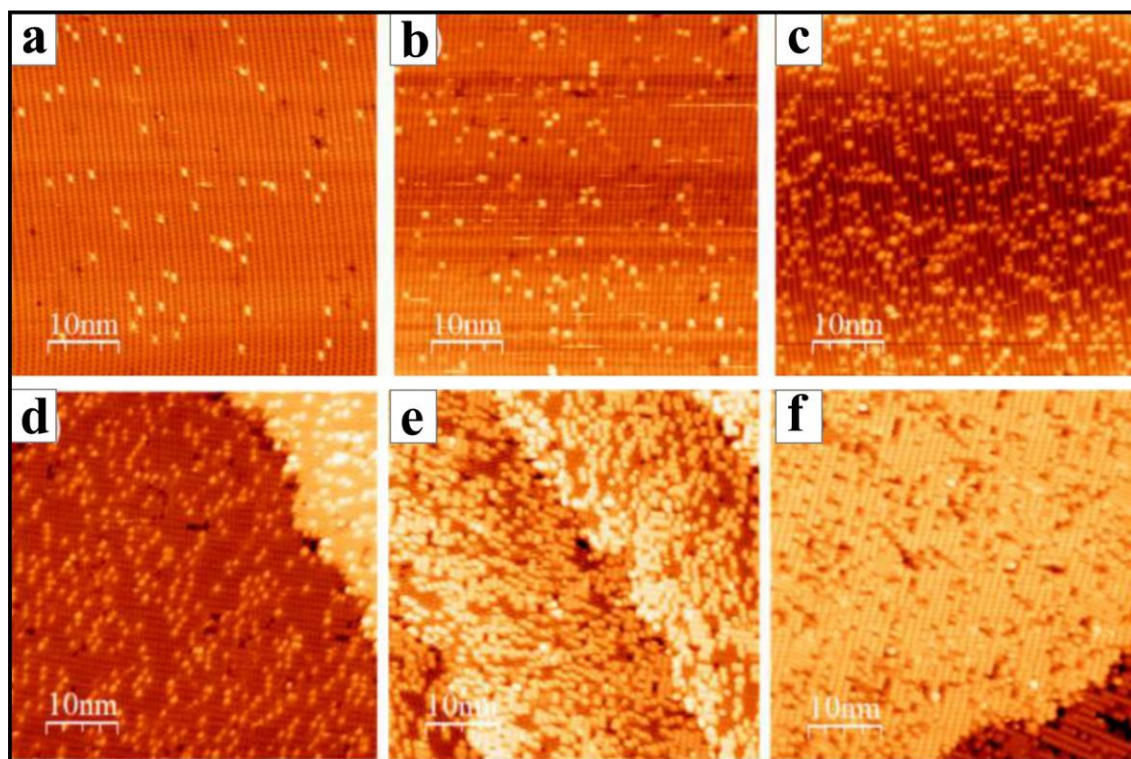
As in the case of  $\text{Cu}_2\text{O}(111)$ ,<sup>114</sup> an improved experimental description of the  $\text{Cu}_2\text{O}(100)$  atomic structure became possible only with the availability of high-resolution STM images. In a systematic STM and LEED study, the group of Weissenrieder et al. explored the nature of the  $\text{Cu}_2\text{O}(100)$  surface in a wide range of pressure and temperature conditions.<sup>149,162</sup> Three terminations were identified in the phase diagram. The most abundant one is the  $(3,0;1,1)$  reconstruction, defined here in matrix representation, that could be stabilized by moderate vacuum and oxygen annealing in a temperature window from 850 to 970 K (Fig. 29a). The  $(3,0;1,1)$  surface with its two  $90^\circ$  rotational domains does not match the  $(3\sqrt{2}\times\sqrt{2})\text{R}45^\circ$  phase initially proposed by Cox.<sup>106</sup> The  $(3,0;1,1)$  surface always coexists with a  $c(2\times 2)$  reconstruction assigned to the  $(\sqrt{2}\times\sqrt{2})\text{R}45^\circ$  Cu-terminated surface. The latter becomes dominant in vacuum-preparation schemes especially after elongated sputter and anneal cycles. Finally, a simple  $(1\times 1)$  phase could be prepared by 900 K annealing in  $10^{-5}$  mbar  $\text{O}_2$ , pointing towards an O-terminated surface (Fig. 29c). We note, however, that the employed thermodynamic conditions to trigger a transition from the reconstructed  $(\sqrt{2}\times\sqrt{2})\text{R}45^\circ$  to the unreconstructed  $(1\times 1)$  O-terminated surface are not as oxygen-rich as predicted in Ref. 117 ( $\Delta\mu_{\text{O}} = -1.7$  eV versus  $-1.1$  eV).



**Figure 29:** STM images ( $46\times 46 \text{ \AA}^2$ ) of the three surface reconstructions found on  $\text{Cu}_2\text{O}(100)$ : (a)  $(1\times 1)$  collected at  $V = -1.8$  V,  $I = 0.5$  nA. (b)  $c(2\times 2)$ ,  $V = 1.1$  V,  $I = 0.1$  nA, and (c)  $(3,0;1,1)$ ,  $V = 2.8$  V,  $I = 0.3$  nA. Simulated STM images and atomic structure models are displayed in the lower row. Bright areas correspond to protrusions.<sup>162</sup>

For all three terminations, the atomically resolved STM images formed the basis for a DFT+U modelling, including relaxation of the two outermost atomic layers with a molecular dynamics approach.<sup>162</sup> The pro-

posed atomic models (Fig. 28) derive directly from bulk-cut O- or Cu-terminated  $\text{Cu}_2\text{O}(100)$  surfaces. Those for the  $(1\times 1)$  O- or Cu-terminations as well as for the two  $c(2\times 2)$  terminations (with simple Cu dimers or ridge-dimers) are essentially in agreement with the previously quoted findings.<sup>115,117,159,160</sup> The  $(3,0;1,1)$  model is a strongly relaxed Cu-terminated surface, at which every second subsurface oxygen moves to the surface, while simultaneously the subsurface  $\text{Cu}^+$  cations dimerize along the  $[011]$ -direction. The vertical separation between the topmost O and Cu planes diminishes, and the overall surface develops a wavy corrugation with  $3\times 4.3 \text{ \AA}$  periodicity in agreement with the STM data. The presence of unsaturated oxygen atoms at the surface is in line with a low-energy shoulder next to the  $O1s$  peak in XP spectra that could be reproduced in simulations of the core level shifts as well.<sup>162</sup> All models of relaxed Cu-terminated surfaces, whether  $(1\times 1)$ ,  $c(2\times 2)$ , or  $(3,0;1,1)$ , are extremely close in energy, which is not surprising since they differ by size and symmetry of the unit cells, allowing for more or less relaxation, but not by their intrinsic composition. Since all of them are polar, compensated by the electronic reconstruction mechanism, and considering how the results of hybrid calculations have changed our view onto such surfaces, additional HSE simulations are requested to complement our understanding of the  $(100)$ -oriented surfaces.<sup>113</sup>



**Figure 30:** STM images of the clean  $\text{Cu}_2\text{O}(100)$  surface (2.4 V, 0.12 nA) with increasing density of defects after (a) annealing at 650 °C for 10 min, (b) at 650 °C for 40 min, and (c) at 700 °C for 20 min. (d) STM images of the as-prepared  $\text{Cu}_2\text{O}(100)$  surface (2.4 V, 0.12 nA) and after (e) 4 min and (f) 6 min electron bombardment ( $E_{\text{kin}} = 80 \text{ V}$ , current: 5  $\mu\text{A}$ ).<sup>163</sup>

In a subsequent study, also defects on well-prepared Cu<sub>2</sub>O(100) surfaces have been addressed in detail.<sup>163</sup> The most abundant defect type shows up as a 1.6 Å-high protrusion in empty-state STM images, and tends to form rows aligned with the oxide [011] direction. Its concentration can be systematically altered by vacuum annealing and soft electron bombardment of the sample ( $E_{\text{kin}} = 80$  eV, Fig. 30). Based on accompanying DFT calculations, the defects were assigned to oxygen vacancies located in the valleys between two rows of terminal O ions of the (3,0;1,1) Cu<sub>2</sub>O(100) surface. The vacancy formation energy was estimated to 2.04 eV, which is about 17% smaller than for the topmost O ions in the unreconstructed O-terminated surface. Despite the pronounced p-type character of Cu<sub>2</sub>O, no signatures for Cu vacancies were revealed in that study.<sup>163</sup>

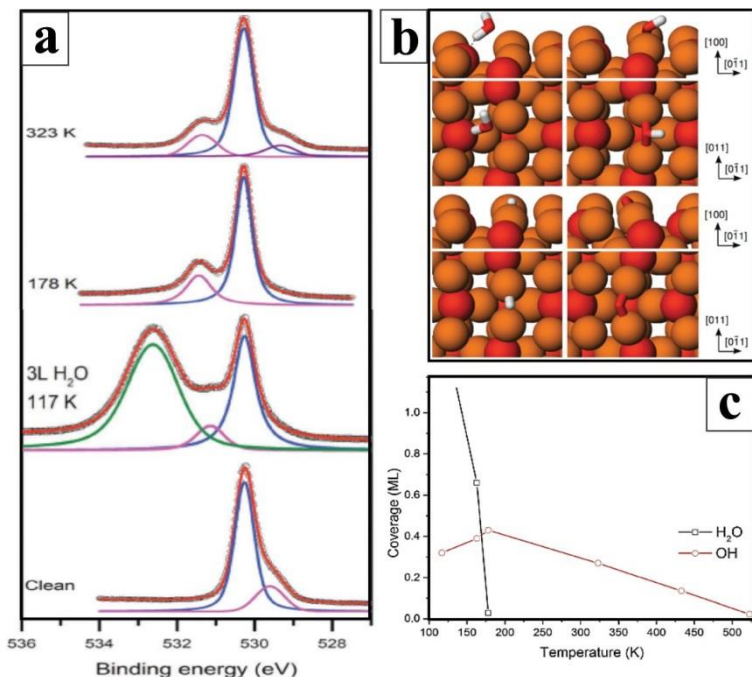
### 3.3.2 Adsorption behavior and chemical reactivity

Although numerous adsorption studies on cuprous oxide have been reported in the literature, we will concentrate here only on those performed on well-defined (100) surfaces with known termination. The era of adsorption experiments was again opened by Cox and coworkers with a set of thermal desorption spectroscopy (TDS) studies. Upon water dosing on the (3√2×√2)R45° reconstructed surface, two main desorption peaks were distinguished, a high-temperature one at 465 K and a low-temperature one that gradually downshifts from 210 to 165 K with increasing coverage.<sup>164</sup> The former peak exhibits first-order desorption behavior and yields a H<sub>2</sub>O binding energy of 1.27 eV, compatible with a Mars-van Krevelen-type desorption scheme involving lattice oxygen. The low-energy desorption follows a second-order scheme and has been explained with the recombination of surface OH and hydride species. The formation of copper hydrides due to attachment of atomic hydrogen to low-coordinated Cu<sub>cus</sub> species has been proposed in an independent work.<sup>165</sup> In addition, carbon monoxide (CO) exposure to the (3√2×√2)R45° reconstructed Cu<sub>2</sub>O(100) gave rise to multiple peaks in TDS, appearing at 280, 220, 180 and 140 K at low coverage and shifting downward in temperature as the coverage increased.<sup>158</sup> The four desorption peaks are compatible with CO binding energies of 0.69, 0.54, 0.46 and 0.36 eV, respectively. Although the precise CO binding sites could not be identified in that early study, due to a lack of theoretical support, the high-energy adsorption has been explained with CO attachment to surface Cu<sup>+</sup> species according to the Blyholder scheme. Interestingly, the measured binding energy is even higher than that on a Cu(100) metal surface.<sup>166</sup>

The picture of molecular adsorption to Cu<sub>2</sub>O(100) surfaces has sharpened substantially in a series of combined experimental / theoretical papers that were published in the late 2010's by Weissenrieder and Brinck. They were initiated by revisiting the water binding characteristics to Cu<sub>2</sub>O(100).<sup>167</sup> Main finding of the study was the high susceptibility of the surface to water dissociation and OH formation even at low temperature (Fig. 31). Respective XPS data revealed that already water dosage at 117 K results in an OH

coverage of 0.3 ML, measured with respect to the (1×1) surface, while additional water binds associatively. Upon rising the temperature to 180 K, the OH surface coverage increased to 0.4 ML while the molecular water desorbed. The OH coverage gradually declined again with increasing temperature due to recombinative water desorption, however, residual hydroxyls could be detected on the surface until 500 K, in line with the early results of Cox.<sup>164</sup> The process of water adsorption and dissociation is accompanied by a transformation of the initial (3,0;1,1) reconstruction into a (1×1) phase.

The underlying reaction mechanism has been clarified by DFT calculations.<sup>167</sup> Molecular water preferentially adsorbs to Cu-hollow sites by forming a hydrogen bond to an adjacent surface O species in the reconstructed surface (Fig. 31b). At low coverage, water dissociation is exothermic, and the hydroxyls get stabilized in Cu-Cu bridge positions. The associated binding energies are substantial and can reach 1.1 eV on the most favorable positions. Similar binding sites are adopted by protons that arise from heterolytic water splitting. However, also homolytic H<sub>2</sub>O bond cleavage is active on Cu<sub>2</sub>O(100), whereby a hydrogen molecule desorbs and the oxygen adatom remains on the surface. The associated accumulation of surface oxygen was now suggested to trigger the lift-off of the (3,0;1,1) reconstruction and to stabilize the O-terminated (1×1) surface.



**Figure 31:** (a) Photoelectron spectra of O 1s for 3 L H<sub>2</sub>O adsorption onto Cu<sub>2</sub>O(100) at 100 K and subsequent annealing to the indicated temperatures. The clean spectrum was obtained from the surface prior to H<sub>2</sub>O exposure. (b) Favored DFT adsorption geometries of H<sub>2</sub>O (top left), OH (top right), H (bottom left) and O (bottom right) on Cu<sub>2</sub>O(100). (c) Estimated coverage of H<sub>2</sub>O and OH on the Cu<sub>2</sub>O(100) surface as a function of the annealing temperature.<sup>167</sup>

Also, methanol adsorption was studied on the reconstructed  $\text{Cu}_2\text{O}(100)$  surface by means of XPS and DFT.<sup>149</sup> Already at low-temperature dosage of the hydrocarbons, the XPS signature of low-coordinated surface O species disappeared, indicating a transformation of the (3,0;1,1) into an O-terminated (1×1) surface. Moreover, two new peaks emerged on the high-binding side of the O *1s* state, blue-shifted by ~1.0 and ~1.9 eV with respect to the bulk oxide peak. By means of DFT fingerprinting, they have been assigned to methoxy ( $\text{CH}_3\text{O}$ ) and methanol ( $\text{CH}_3\text{OH}$ ) species bound to the oxide surface, a conclusion that got further supported by an appropriate splitting of the experimental C *1s* state. While methanol desorbed from the surface already below 200 K, the methoxy species were stable up to 640 K. The findings are in good agreement with calculated adsorption energies of -1.1 eV and -2.6 eV for methanol and methoxy, respectively, with Cu-Cu bridge sites in the non-reconstructed (1×1) surface being the preferred binding positions. Interestingly, methanol dissociation was found to be unfavorable on the reconstructed (3,0;1,1) surface, explaining the observed transformation into the ideal (1×1) phase.<sup>149</sup> Rather similar conclusions were drawn on the basis of ethanol adsorption experiments on  $\text{Cu}_2\text{O}(100)$ .<sup>168</sup>

In a subsequent study from the same authors, the low-temperature oxidation of  $\text{Cu}_2\text{O}(100)$  to CuO was monitored in a high-pressure XPS experiment.<sup>169</sup> In correspondence to earlier water adsorption studies, the high susceptibility of  $\text{Cu}_2\text{O}(100)$  to hydroxylation was found to play a pivotal role in the oxidation reaction. CuO formation proceeds as long as hydroxyl species, arising from moisture in the rest gas, are present at the surface and correspondingly stops at monolayer CuO coverage when all OH groups are consumed. Further thickening of the CuO film via  $\text{Cu}_2\text{O}$  oxidation can only be achieved at much higher reaction temperatures, as clearly demonstrated in earlier XPS<sup>125</sup> and optical transmission experiments.<sup>96</sup>

Finally, several purely theoretical studies addressed the adsorption and reaction characteristics of the  $\text{Cu}_2\text{O}(100)$  surface. As experimental verification of the proposed interaction models is still pending, we only mention those studies at this point. Rahman and coworkers explored the overall chemical reactivity of  $\text{Cu}_2\text{O}(100)$ , putting special emphasis on the role of low-coordinated  $\text{Cu}^+$  surface ions and of potential CO poisoning effects during chemical reactions.<sup>160,170</sup> The binding behavior of water<sup>171</sup> and  $\text{O}_2$  molecules<sup>155</sup> was addressed as well, although the (3,0;1,1) reconstruction was not taken into account in these works. Finally, photo-catalytic pathways to convert  $\text{CO}_2$  into useful hydrocarbons on  $\text{Cu}_2\text{O}(100)$  were examined in a recent study of the Muniz group.<sup>172</sup>



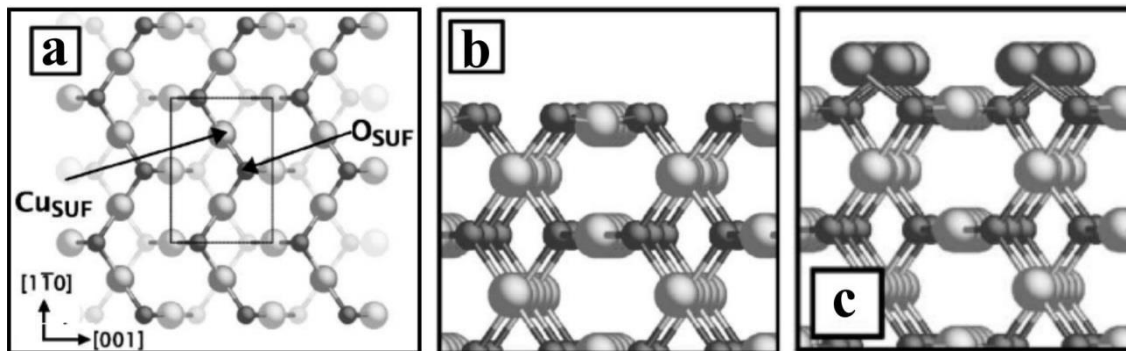
### 3.4. The Cu<sub>2</sub>O(110) surface

#### 3.4.1. Termination: Theory and experiment

From all low-index Cu<sub>2</sub>O surfaces, the (110) is the least explored one, mostly because of two reasons. In nanoparticles, the (110) surface typically takes the smallest area contribution and always coexists with sizeable (111) and (100) facets.<sup>35,36,37,38</sup> And, high-resolution microscopic measurements, employing either STM or TEM, have not been reported on (110)-cut single crystal surfaces up to this point. Atomic scale information on well-prepared Cu<sub>2</sub>O(110) surfaces is therefore hardly available, and given the lack of experimental input, also the amount of reliable theoretical analyses is finite.

Several research groups succeeded in preparing Cu<sub>2</sub>O nanoparticles with dodecahedral shape, hence with a considerable contribution of (110) facets.<sup>173,174,175</sup> Common synthesis routes are hydro- and solvo-thermal preparations, whereby capping agents with tailored adsorption properties promote the development of the desired crystal facets, e.g. polyvinylpyrrolidone and oleic acid for (111) and (110) facets, respectively.<sup>37,53</sup> Scanning electron microscopy and electron diffraction data of individual (110) facets revealed a rectangular surface atomic structure, comprising a  $3.0 \times 4.3 \text{ \AA}^2$  unit cell.<sup>173</sup> In an alternative approach, thick (110) oriented Cu<sub>2</sub>O films were grown by pulsed laser deposition and plasma-assisted Cu oxidation on MgO(110) single crystals, making use of a favorable epitaxial relationship.<sup>176,177</sup> Although the film quality was not sufficient to gain atomic scale information, Kelvin probe and conductivity measurements provided insights into band-bending effects on this particular oxide facet.

Given the lack of high resolution measurements, truly atomic-scale insights into the Cu<sub>2</sub>O(110) surface composition still rely mostly on DFT calculations. The reference was set by the comprehensive GGA work of Stampfl and coworkers, already discussed before.<sup>115</sup> Based on the ideal lattice, they considered the two bulk-cut (1×1) surface terminations of mixed Cu<sub>2</sub>O<sub>2</sub> and pure Cu<sub>2</sub> composition (Fig. 12). The by far most stable surface was the mixed Cu<sub>2</sub>O<sub>2</sub> termination, comprising zig-zag rows of fourfold coordinated Cu and threefold coordinated O ions (Fig. 32a). Vertically, the topmost layer sinks into the surface by 6.3% (Fig. 32b). The Cu-terminated surface, on the other hand, is composed of  $[\bar{1}\bar{1}0]$  oriented Cu zigzag rows that exclusively coordinate to oxygen ions in the subsurface plane. It displays an outward relaxation of the Cu-top plane by 4.6% with respect to the bulk lattice and turns out to be less stable than the mixed termination in the whole range of oxygen chemical potentials (Fig. 32c). Structural models for both terminations, similar to those discussed above, were later derived from a DFT+U approach with the same conclusion on the high stability of the Cu<sub>2</sub>O<sub>2</sub> termination.<sup>117</sup>



**Figure 32:** DFT structure models of the  $\text{Cu}_2\text{O}_2$ -terminated  $\text{Cu}_2\text{O}(110)$  surface (a) top and (b) side view along  $[1\bar{1}0]$ . (c) Side view of the Cu-terminated  $\text{Cu}_2\text{O}(110)$ .<sup>115</sup>

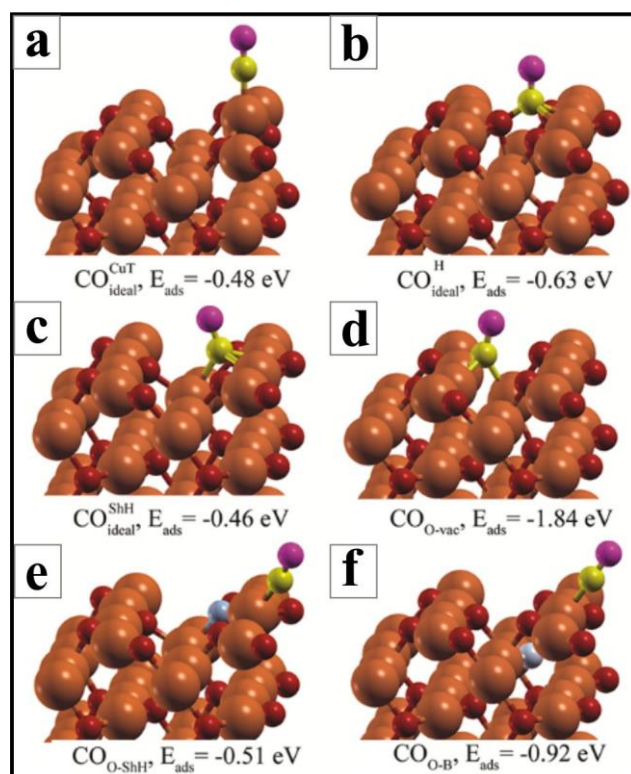
Due to the alternation of layers with  $\pm 2$  formal charges in the  $(1 \times 1)$  unit cell, these two bulk-cut terminations are polar. In the absence of non-stoichiometric reorganizations, an electronic reconstruction needs to take place that involves the reduction of the surface charges by 1. As expected, the Fermi level intersects a state of mixed Cu  $3d - \text{O } 2p$  character in the simulated  $\text{Cu}_2\text{O}_2$  termination (formal charge -2), creating the hole with +1 formal charge to heal polarity.<sup>115</sup> In contrast, the simulated removal of either an O or a Cu atom from the topmost  $\text{Cu}_2\text{O}_2$  layer leads to a destabilization of the termination. The modified surface composition in that case could not solve the polarity issue, as the formal charges of the surface layer become equal to 0 or -3, respectively, rather than the needed  $\pm 1$  value. At the Cu-terminated surface (formal charge +2), a truly compensated configuration was obtained by removing one of the two Cu atoms in the  $(1 \times 1)$  unit cell, as analyzed in a later DFT+U study.<sup>132</sup> It was found to be more stable than the  $\text{Cu}_2\text{O}_2$  termination and exhibits a semiconducting electronic structure with a 0.3 eV wide band gap.

In absence of hints from atomically resolved experiments, theoretical simulations have been restricted to  $(1 \times 1)$  unit cells only. Unexpected surface structures and reconstructions may well be revealed in the future, if it becomes possible to grow thick and well-ordered  $\text{Cu}_2\text{O}$  films oriented along  $(110)$ .

### 3.4.2. Adsorption behavior and reactivity

A main motivation to study molecular adsorption on  $\text{Cu}_2\text{O}(110)$  is the prospect that this oxide termination might be particularly active in thermal and photo-conversion of  $\text{CO}_2$  into useful chemicals. So far, insights into the field were mostly gained by DFT calculations limited to unreconstructed bulk-cut surface models, either pristine or with oxygen vacancies, while experimental data are still scarce given the ill-defined nature of the oxide compounds. In a DFT study by Li et al.,  $\text{CO}_2$  activation was found to be initiated via charge transfer from the  $\text{Cu}_2\text{O}$  surface, resulting in the formation of  $\text{CO}_2^-$  anion radicals.<sup>178</sup> Low-coordinated Cu ions next to an O vacancy were identified as active sites in this process. In fact,  $\text{CO}_2$  ad-

sorption preferentially takes place to O-vacancies in the  $\text{Cu}_2\text{O}(110)$  surface, whereby one O atom moves into the vacancy and the carbon coordinates to two surface Cu ions ( $E_B = -0.09$  eV). Upon  $\text{CO}_2$  dissociation, the O atom remains in the vacancy, while the resulting CO molecule binds with  $-0.63$  eV to an adjacent hollow position formed by two surface Cu and one surface O atom (Fig. 33). The associated activation barrier for dissociation was calculated to be  $0.25$  eV, being easily accessible in thermal and photo-driven processes.<sup>178</sup> In the same work, the binding of atomic oxygen to  $\text{Cu}_2\text{O}(110)$  was studied. Here, two preferred binding sites were identified, an asymmetric hollow position between two native surface O ions ( $-0.43$  eV) and a bridge site located in between two subsurface Cu atoms ( $-0.4$  eV).<sup>178</sup> The topic of  $\text{CO}_2$  reduction towards methanol was addressed later again, yet with the focus on the oxide defect structure and its impact on the preferred reaction pathway.<sup>179</sup>



**Figure 33:** DFT-relaxed geometries and adsorption energies of a CO molecule on ideal and defective (110) surfaces: (a) C atom at the CuT site of the ideal surface, (b) C atom at the H site of the ideal surface, (c) C atom at the ShH site of the ideal surface, (d) C atom at the O vacancy site of the O-deficient surface, (e) C atom at the CuT site of the O-excess surface with additional O at ShH sites, (f) C atom at the CuT site of the O-excess surface with additional O at the B site. Brown and red spheres represent the Cu and O atoms of the native oxide, respectively. Yellow and purple spheres represent the C and O atoms of the adsorbed CO molecule, respectively. Blue spheres display additional O atoms on the O-excess surfaces.<sup>178</sup>

With a similar environmental focus, NO reduction induced by CO oxidation was theoretically explored on  $\text{Cu}_2\text{O}(110)$  in a DFT+U approach.<sup>180</sup> The NO preferentially binds with the N-terminal to Cu–Cu bridge sites on protruding chains of the Cu–O termination, adopting an adsorption energy of  $-0.76$  eV. The CO, on the other hand, bridges two Cu–O chains, with the C atom simultaneously coordinating to an O ion in

one chain and a Cu ion in the adjacent one ( $E_B = -0.34$  eV). For both molecules, the binding energy more than triples in presence of surface O defects, whereby either the N or C terminal enters the vacancy site, respectively. The NO reduction via CO oxidation now follows a multistep reaction, proceeding via  $\text{CO}_2$  plus  $\text{O}_{\text{vac}}$  formation according to an Eley-Rideal mechanism, NO splitting by annihilating the O vacancy, assembling the N adatom with a second NO, and dissociating the so generated  $\text{NO}_2$  via an  $\text{O}_{\text{vac}}$  mediated process into desorbing  $\text{N}_2$  and atomic oxygen filling the vacancy. Although the overall process is exothermic, a number of energetically unfavorable transition states need to be populated in the reaction course.<sup>180</sup> Similarly, DFT calculations on water interacting with  $\text{Cu}_2\text{O}(110)$  revealed only weak adsorption ( $E_B = -0.39$  eV) and a small trend towards dissociation in absence of structural defects in the oxide surface.<sup>181</sup> Finally, the adsorption of more complex organic molecules, such as chlorophenol,<sup>182</sup> bromobenzene and aniline,<sup>183</sup> to  $\text{Cu}_2\text{O}(110)$  was studied in a number of DFT calculations. Obviously, all these theoretical results should be considered as tentative, since they rely on assumed compositions and atomic structures of bulk-cut surface models on which the reactions would take place.

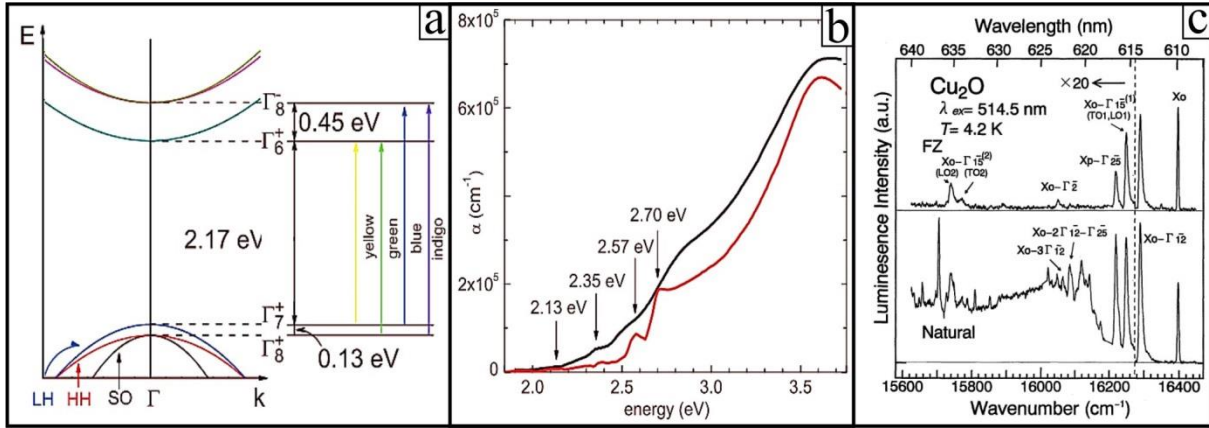
## 4. Optical properties of cuprous oxide

The optical behavior of bulk  $\text{Cu}_2\text{O}$  has been extensively studied in the past decades and a plethora of publications is available on this topic.<sup>20,184</sup> As the surface properties of  $\text{Cu}_2\text{O}$  stand in the center of this review, we will only summarize the most relevant bulk aspects here and focus on means to study the optical characteristics of  $\text{Cu}_2\text{O}$  surfaces in the main part of this section.

### 4.1. Optical properties of bulk $\text{Cu}_2\text{O}$

Bulk cuprous oxide has a direct, yet dipole forbidden band gap of 2.15 eV, which compares to 1.35 eV for cupric oxide.<sup>1</sup> Four fundamental optical transitions involving the spin-orbit split VB and CB can be detected across the  $\text{Cu}_2\text{O}$  band gap (Fig. 34a).<sup>185</sup> They are named according to their central absorption wavelength as yellow, green, blue and indigo series (Fig. 34b). Hereby, especially the yellow series stands in the focus of research, as it supports two fundamental types of excitons, the para- and ortho-exciton.<sup>186</sup> While the former has singlet character, i.e., an opposite spin orientation for electron and hole, the latter is of triplet nature, hence the effective electron and hole spins are parallel to each other. Consequently, there is a spin barrier for radiative recombination of the para- but not for the ortho-excitons. Due to the relatively small dielectric screening in  $\text{Cu}_2\text{O}$ , both excitons are characterized by large ground-state binding energies of about 140 meV and relatively small exciton radii (7 Å).<sup>187</sup> Para-excitons are 12 meV more stable

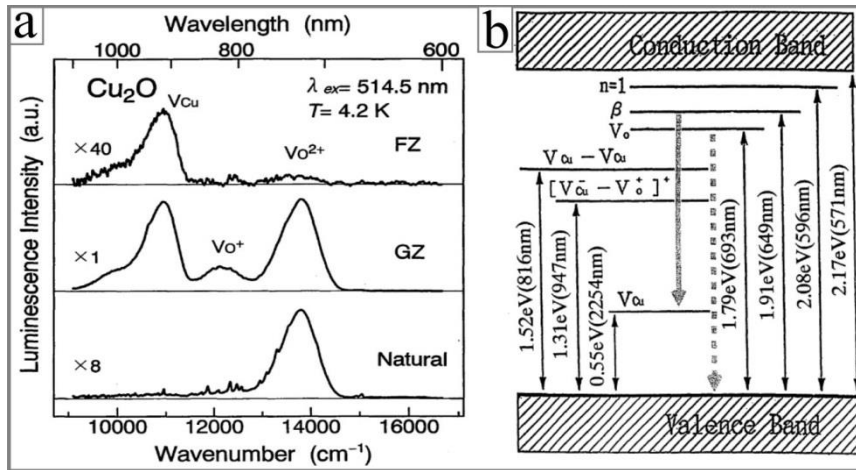
than their ortho-counterparts, reflecting the impact of spin exchange. Both  $\text{Cu}_2\text{O}$  excitons have an optically dark  $1s$  ground state, as the hot electron resides in a Cu  $4s$  derived state at the CB edge, while the hole locates in states with Cu  $3d$  character at the VB top. The difference in orbital momentum quantum number of the two states thus amounts to  $\Delta l = 2$ , rendering radiative exciton decay dipole forbidden. Nonetheless, a weak luminescence peak at 610 nm wavelength, arising from the recombination of  $1s$  ortho-excitons ( $X_0$ ) can be detected in bulk  $\text{Cu}_2\text{O}$  at 4.2 K (Fig. 34c).<sup>26</sup> The involvement of phonons in exciton recombination partially releases the dipole selection rules for ortho-excitons, resulting in various phonon-assisted luminescence bands in  $\text{Cu}_2\text{O}$ , with the negative-parity  $\Gamma_{25}^-$ ,  $\Gamma_{15}^-$ ,  $\Gamma_{12}^-$  and  $\Gamma_2^-$  phonons producing the highest emission yields (Fig. 34c). For the  $\Gamma_{12}^-$  phonon of 13.6 meV energy, the competition between Stokes ( $X_0 - \Gamma_{12}^-$ ) and Antistokes processes ( $X_0 + \Gamma_{12}^-$ ) has been analyzed to obtain an internal measure of the oxide temperature upon laser excitation.<sup>187</sup> Para-excitons remain optically dark even under phonon involvement, given the prohibitive spin constraint.



**Figure 34:** (a) Energy-band diagram of  $\text{Cu}_2\text{O}$  around the  $\Gamma$ -point. Possible interband transitions and the underlying band splittings are shown in the inset. (b) Absorption spectra of an as-grown  $\text{Cu}_2\text{O}$  film (black line) and a film annealed at  $930^\circ\text{C}$  (red line). The edges of the different exciton series are marked by arrows.<sup>1</sup> (c) Contributions of different lattice phonons to the radiative decay of  $\text{Cu}_2\text{O}$  ortho-excitons from the yellow series. The zero-phonon line ( $X_0$ ) is relatively weak.<sup>26</sup>

The dipole forbidden nature of the  $\text{Cu}_2\text{O}$  band gap is also responsible for long decay times of the oxide excitons, reaching more than 500 ns for para-excitons at 20 K.<sup>23,188</sup> With  $\sim 15$  ns, the lifetime of ortho-excitons is much shorter, as those effectively convert to para-excitons via spin-flip scattering.<sup>17,24</sup> Long lifetimes promote the observation of  $\text{Cu}_2\text{O}$  excitons in high Rydberg states, even if the underlying Rydberg energy of 92 meV is smaller than the ground-state exciton binding energy.<sup>26,189</sup> In fact, excitons up to the 25<sup>th</sup> Rydberg level could be detected in natural  $\text{Cu}_2\text{O}$  crystals at 1.2 K (Fig. 3), whereby the mean exciton diameter increases from  $\sim 1$  nm to  $\sim 1$   $\mu\text{m}$  when going from the 2<sup>nd</sup> to the 25<sup>th</sup> excited state.<sup>18</sup> The large spatial extension renders Rydberg excitons particularly susceptible to perturbations by external elec-

tric fields, as reflected in the splitting of the  $n^{\text{th}}$  exciton peak in  $n$ -field dependent sub-states.<sup>190</sup> Moreover, excitons with high angular momentum could be detected, demonstrating small deviations of the  $\text{Cu}_2\text{O}$  lattice from ideal cubic symmetry.<sup>142</sup> Finally, long exciton lifetimes make  $\text{Cu}_2\text{O}$  crystals an ideal model system to study Bose-Einstein condensation of excitons.<sup>20</sup> As the critical phase-transition temperature depends on the exciton density to the power of  $2/3$ , especially the long lived para-excitons seem ideally suited to observe exciton condensates at experimentally accessible temperatures.<sup>19</sup> Although heavily explored in the past 30 years, unambiguous evidence for Bose-Einstein condensation of excitons could not be provided so far. The main obstacle is the so-called Auger decay of excitons that leads to a dramatic decrease of the exciton lifetime at high exciton densities.<sup>17</sup> In that process, two excitons collide whereby the first one recombines while the second decays into two unbound carriers. The associated lifetime  $\tau$  scales with the inverse exciton density times the Auger constant  $A = 7 \times 10^{-17} \text{ cm}^3/\text{ns}$  that is particularly large in  $\text{Cu}_2\text{O}$ .<sup>21</sup> Very recent experiments suggest that Bose-Einstein condensation of  $\text{Cu}_2\text{O}$  excitons may nonetheless be observable at very low temperatures of about 500 mK.<sup>20,191</sup>



**Figure 35:** (a) Defect luminescence measured for three  $\text{Cu}_2\text{O}$  crystals by photo-luminescence spectroscopy. (b) Electron recombination scheme across the  $\text{Cu}_2\text{O}$  band gap, highlighting the role of the different  $\text{Cu}_2\text{O}$  defects for the observed luminescence.<sup>26</sup>

In addition to excitonic modes, two defect-mediated luminescence channels should be discussed in the context of  $\text{Cu}_2\text{O}$  bulk crystals (Fig. 35a). The first one relates to Cu vacancies, being the main defect type in  $\text{Cu}_2\text{O}$  due to their low formation energy and responsible for the p-type conductivity of the material.<sup>7</sup> The associated acceptor states are located 0.2-0.4 eV above the VB edge, whereby the scattering arises from different defect configurations (simple or split Cu vacancies) and variations in the overall sample quality.<sup>11,13,192</sup> The initial and final state for defect recombination are now trapped  $\text{Cu}_2\text{O}$  excitons and the acceptor level inside the band gap, explaining the sizeable redshift of the  $\text{V}_{\text{Cu}}$  emission with respect to the free exciton (920 versus 610 nm) (Fig. 35b). In fact,  $\text{V}_{\text{Cu}}$ -mediated emission bands are prominently detect-

ed in  $\text{Cu}_2\text{O}$  crystals and high-quality films, reflecting the abundance of such defects in the p-type oxide.<sup>10,26</sup> Conversely, the  $V_{\text{Cu}}$  band is often suppressed in materials with poor crystalline order due to an abundance of non-radiative decay channels. The correlation between crystalline order, radiative lifetime and luminescence response for different  $\text{Cu}_2\text{O}$  emission channels is discussed in detail in the next section.

The other prominent defect luminescence arises from O vacancies in the  $\text{Cu}_2\text{O}$  lattice (Fig. 35a). Also here, two defect configurations are distinguishable, a double- ( $V_{\text{O}}^{2+}$ ) and a single-positively charged vacancy ( $V_{\text{O}}^+$ ), producing two emission bands at  $\sim 750$  and  $850$  nm, respectively.<sup>26,193,194</sup> While in the former case, the two electrons left behind by the desorbing oxygen species are annihilated by two holes from the p-type conductor, one excess electron remains in the defect site in the second case. The two charge states give rise to different initial-state energies of the  $V_{\text{O}}$  transition, both located just below the CB edge.<sup>195,196</sup> The final state is always a hole in the oxide VB around the Fermi energy. From the intensity ratio of the two  $V_{\text{O}}$ -related emission bands, conclusions on the degree of p-type conductivity of the respective  $\text{Cu}_2\text{O}$  samples can be drawn. In contrast to the  $V_{\text{Cu}}$  luminescence, the  $V_{\text{O}}$ -related channels are less sensitive to structural disorder and prevail also in thin films and powder samples, as shown in the next chapter.

Detailed insights into the time-dependent optical properties of  $\text{Cu}_2\text{O}$  crystals were provided by transient optical experiments and, more recently, by pump-probe techniques. Already early approaches revealed a radiative lifetime of the ortho-excitons of 10-15 ns, limited by their effective conversion to optically dark para-excitons.<sup>186</sup> The para-excitons, on the other hand, decay mostly via defect scattering on a time scale of 500 ns at low temperature.<sup>23,188</sup> For the radiative lifetime of the  $\text{Cu}_2\text{O}$  defect luminescence, two different regimes have been identified. While  $V_{\text{O}}$  luminescence decays within 3 ps, the radiative lifetime of the  $V_{\text{Cu}}$  emission is almost  $50\times$  longer.<sup>197</sup> The deviating response reflects different stimulation schemes of the defects. The  $V_{\text{O}}$  excitation mostly happens via free carriers in the oxide CB, giving rise to short decay times. Conversely,  $V_{\text{Cu}}$  defects are excited by mobile excitons and consequently mimic their long radiative lifetime. Moreover, the decay time of the  $V_{\text{O}}$  luminescence exhibits a large temperature dependence and decreases to zero above 100 K, when the optical recombination channel gets blocked. The radiative lifetime of  $V_{\text{Cu}}$  defects, on the other hand, only moderately depends on temperature.<sup>26</sup>

Finally, the promising role of  $\text{Cu}_2\text{O}$  as cathode material for photoelectrochemical (PEC) splitting of water shall be highlighted here. In contrast to standard oxide materials used for this purpose,  $\text{Cu}_2\text{O}$  has a number of advantages. Its band alignment is perfectly suited to sustain both, the hydrogen and oxygen evolution reaction.<sup>198</sup> The  $\text{Cu}_2\text{O}$  band gap is smaller than that of typical photo-catalysts, such as  $\text{TiO}_2$  or  $\text{ZnO}$ , and a larger portion of the solar radiation can thus be harvested. And, optical stimulation gives rise to long lived excitonic states, suitable to promote PEC water splitting. The main disadvantage of the oxide material is its low stability in a liquid environment, especially at acid conditions far away from the point of zero charge. The reason is the  $\text{Cu}^+$  to  $\text{Cu}^0$  reduction potential that directly overlaps with the potential range of

water spitting, and leads to  $\text{Cu}_2\text{O}$  decomposition during the PEC reaction.<sup>199</sup> Hereby,  $\text{Cu}_2\text{O}(100)$  and  $(110)$  facets exhibit lower stability than their  $(111)$  counterparts, explaining the dramatic reshaping in favor of  $(111)$  crystal terminations observed for  $\text{Cu}_2\text{O}$  nanoparticles.<sup>200</sup> The consequence is a continuous decline of the reaction rate during a PEC process. Many attempts have been made to overcome this problem, for example, by stabilizing the  $\text{Cu}_2\text{O}$  surface with ultrathin protective layers of  $\text{ZnO}$  or  $\text{SiO}_2$ ,<sup>201</sup> or by adding metallic copper as a reservoir to maintain the oxide stoichiometry.<sup>202</sup> However, none of these approaches convincingly resolved the stability issues of  $\text{Cu}_2\text{O}$  and technologically matured solutions for using  $\text{Cu}_2\text{O}$  as cathode material in PEC water splitting are not in sight so far. The next section sheds light on experimental techniques to explicitly probe the optical response of  $\text{Cu}_2\text{O}$  surfaces with the aim to correlate structural and optical properties with high spatial and spectral resolution.

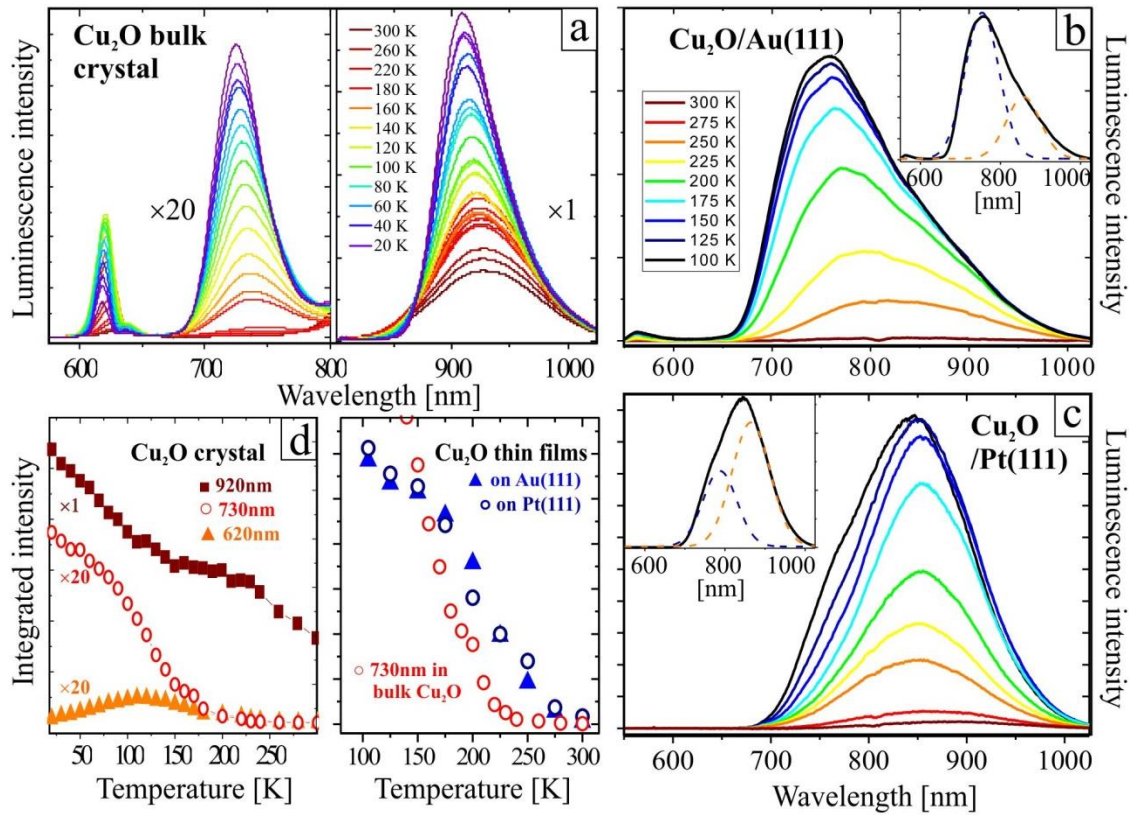
#### *4.2. Optical properties of $\text{Cu}_2\text{O}$ thin-films and surfaces*

In many aspects, oxide thin films grown on single-crystalline metal supports turned out to be versatile model systems to explore the physics and chemistry of the respective bulk materials.<sup>203,204,205</sup> Especially surface properties, such as the thermodynamic preference for certain terminations, the adsorption behavior, or the occurrence of surface states, are perfectly reproduced in oxide films even of reduced thickness. However, large deviations are revealed when it comes to the optical response of low-dimensional oxides, reflecting the susceptibility of optical excitations to structural disorder and non-radiative decay channels. The effect is particularly strong for  $\text{Cu}_2\text{O}$  films and powders, due to the long lifetime and high diffusivity of the underlying excitonic modes. To demonstrate the impact of reduced dimensionality, the low-temperature luminescence of  $\text{Cu}_2\text{O}/\text{Pt}(111)$  and  $\text{Cu}_2\text{O}/\text{Au}(111)$  thin films will be compared with the one of single crystals in the following.<sup>124</sup> While both systems show identical behavior regarding chemical composition, diffraction pattern, electronic response and surface termination, their photoluminescence (PL) upon 532 nm laser irradiation is distinctively different (Fig. 36).

The bulk crystal features the characteristic optical bands discussed in section 4.1, namely an asymmetric peak at 620 nm due to phonon-assisted exciton decay, as well as two defect peaks at 730 and 920 nm related to oxygen and copper vacancies in the lattice, respectively.<sup>26</sup> All three emission channels come with their own temperature dependence (Fig. 36d). The probability for radiative recombination of ortho-excitons rises with decreasing temperature, as thermal exciton-breakup into unbound electrons and holes becomes increasingly unlikely. The trend reverses at  $\sim 125$  K, when the ortho-excitons transform into non-radiative para-excitons that are lower in energy.<sup>17</sup> The  $V_{\text{O}}$  related emission channel only opens below 230 K, as electrons are back-promoted from the defect state into the CB at higher temperature. For the  $V_{\text{Cu}}$  decay, on the other hand, the final state gets blocked by thermal electrons from the VB, resulting in a de-



creasing emission yield at increasing temperature again.<sup>26,188</sup> The coexistence of Cu and O vacancies in the lattice hereby indicates incomplete equilibration of the two fundamental defect types in natural crystals.<sup>192</sup>



**Figure 36:** Temperature-dependent PL spectra of (a) a  $\text{Cu}_2\text{O}$  crystal and (b) 65 nm  $\text{Cu}_2\text{O}$  films grown on Au(111) and (c) Pt(111) substrates. The insets in (b) and (c) show the deconvolution of the emission into two maxima centered at 750 and 850 nm. (d) Evolution of the integral intensity with temperature for the various emission bands observed on  $\text{Cu}_2\text{O}$  bulk (left) and thin films (right).<sup>124</sup>

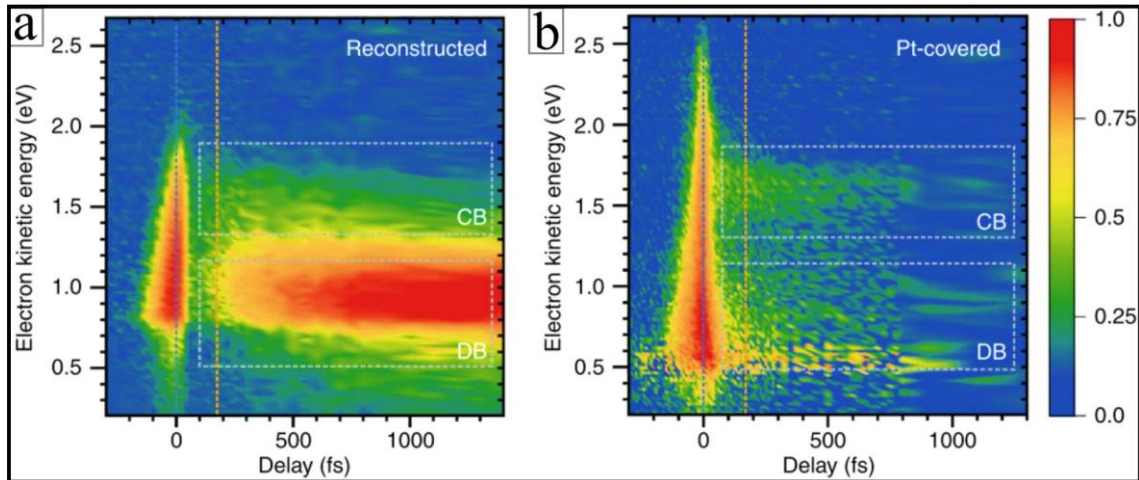
The luminescence response of  $\text{Cu}_2\text{O}$  films is distinctively different, not only in the experiment described in Ref. 124, but also in numerous other studies on thin-film and powder samples.<sup>193,194,206</sup> The films discussed here were 65 nm thick, hence bulk-compatible, and deposited onto Pt(111) and Au(111) supports with matching lattice parameters. The corresponding PL spectra are governed by an asymmetric band between 700 and 900 nm that can be de-convoluted into two maxima centered at  $\sim 750$  and  $\sim 850$  nm, respectively (Fig. 36b,c). While the short-wavelength peak dominates for Au(111) supported films, the long-wavelength one governs the  $\text{Cu}_2\text{O}/\text{Pt}(111)$  emission. Following the earlier discussion, the 750 nm maximum corresponds to an optical recombination channel mediated by double-charged oxygen vacancies ( $\text{V}_{\text{O}^{2+}}$ ), while the redshifted peak at 850 nm is induced by its single-charged counterpart ( $\text{V}_{\text{O}^+}$ ).<sup>195</sup> This interpretation is further supported by the temperature-dependent emission yield that follows the one observed for  $\text{V}_{\text{O}}$  emission from bulk crystals (Fig. 36d). According to the stronger  $\text{V}_{\text{O}^{2+}}$  emission, the  $\text{Cu}_2\text{O}/\text{Au}(111)$  films have more p-type character, as more holes are available to annihilate the excess electrons left behind by the desorbing O species. Conversely, the Pt(111) supported films exhibit a reduced

hole concentration, and statistically one electron survives in the vacancy. The deviating behavior reflects the larger tendency for copper/gold alloying, producing a sink for Cu atoms on Au(111) that does not exist on the Pt substrate.<sup>84</sup> The Au(111) supported films have consequently a higher Cu-deficiency and are more p-type, rationalizing their different optical response (Fig. 36).<sup>124</sup>

Even more interesting is the absence of the free-exciton and  $V_{Cu}$ -related emission for  $Cu_2O$  films, although both are prominently detected for oxide single crystals. This observation is commonly linked to the reduced crystallinity of low-dimensional oxides but provides interesting insights into the nature of optical transitions in  $Cu_2O$  as well. As summarized in section 4.1, band-gap transitions in  $Cu_2O$  are dipole forbidden, which gives rise to long radiative lifetimes and large diffusion lengths of the oxide excitons.<sup>23,25,188</sup> These optical modes have thus a high probability to undergo non-radiative recombination, especially at the surface / interface of  $Cu_2O$  nanocrystals and films, which is why the free-exciton emission is largely suppressed in those systems. The same holds for the  $V_{Cu}$  emission, as exciton trapping at Cu vacancies forms the initial state for optical recombination also in this case. The  $V_O$  luminescence, on the other hand, is mediated by hot electrons in the oxide CB and no exciton formation is required here. Moreover, the radiative lifetime of the O-vacancy channel is substantially shorter than the exciton mediated pathway (3 ps versus ~100 ns at low temperature), which renders the former less sensitive to defects and structural disorder.<sup>188,197</sup> Given this asymmetry, the luminescence of  $Cu_2O$  films and nanocrystals is almost entirely governed by O defects, as clearly discernable in the PL spectra of Fig. 36.

In addition, pump-probe techniques were employed to investigate the transient optical response of  $Cu_2O$  surfaces.<sup>129,207</sup> In a first experiment on  $Cu_2O(100)$ , electrons were stimulated across the band gap with 2.5 eV pump pulses and the resulting electron population was interrogated after a given time delay with 4.5 eV probe pulses (Fig. 37a).<sup>207</sup> Surprisingly, the CB population decayed within 200 fs at the expense of a sizeable in-gap electron population centered at ~1.5 eV above the VB top. Only a lower lifetime limit of ~1 ns could be determined for electrons in this gap state. Moreover, the trapping was blocked after depositing a Pt ad-layer onto the oxide, suggesting that the relevant gap states are located close to the surface (Fig. 37b). The nature of these defect states was tentatively related to Cu vacancies, although the measured energy position obviously deviates from calculated level energies of the  $V_{Cu}$  defects.<sup>7,11,12</sup> In a second experiment, the time-resolved optical response of a  $(\sqrt{3}\times\sqrt{3})$ -reconstructed  $Cu_2O(111)$  surface was probed.<sup>129</sup> Also here, ultrafast trapping of conduction electrons in a defect state was detected, in which they remained for more than 100 ps with negligible population decay. The position of the trap state was determined to 0.2-0.4 eV above the VB top, hence much lower than on  $Cu_2O(100)$  and close to the anticipated  $V_{Cu}$  defect state.<sup>11,12</sup> Nonetheless, it was assigned to a lower resonance induced by O vacancies in the  $Cu_2O$  matrix by means of hybrid DFT calculations.<sup>129,195</sup> The presence of O defects in the  $(\sqrt{3}\times\sqrt{3})$  reconstructed surface was rationalized with a downward band-bending detected by XPS. Note that an upward band-shift was

revealed for the thermodynamically preferred nano-pyramidal ( $\sqrt{3}\times\sqrt{3}$ ) reconstruction discussed earlier,<sup>114</sup> and the true nature of the  $\text{Cu}_2\text{O}(111)$  surface probed in that study remained ambiguous. Surprisingly, no defect-trapping occurred for the non-reconstructed ( $1\times 1$ ) surface and a sizeable population of CB electrons could be detected there even 10 ps after excitation.<sup>129</sup>



**Figure 37:** Color maps of the transient two-photon-photon-emission from (a) the reconstructed  $\text{Cu}_2\text{O}(100)$  surface and (b) the Pt-covered oxide. The plots show the dependence of the electron kinetic energy on pump-probe delay.<sup>207</sup>

By exploiting the capabilities of PEEM to follow excitation processes with high spatial and temporal resolution, charge transfer processes within single  $\text{Cu}_2\text{O}$  nanocrystals could be detected with unmatched precision in Ref. 40. Following Wulff's construction principle, the crystallites developed truncated pyramidal shapes, exposing large (111)-oriented side facets and a (100) top plane (Fig. 5). After excitation with 2.4 eV pump pulses, the evolution of the charge distribution within the particle could be detected in real time, revealing a net electron transfer from (111) to (100) facets. Electric-field and work-function effects were identified as driving forces for this charge flow. Its relevance for photochemical applications was proven by correlating the induced photo-voltage measured on the  $\text{Cu}_2\text{O}$  crystallites with the efficiency of the hydrogen-evolution reaction.<sup>40</sup>

The above paragraph underlined how structural, optical and chemical properties of  $\text{Cu}_2\text{O}$  closely interfere at the nanometer scale, and should consequently be probed simultaneously within one spatially resolving experiment. In the following section, we therefore discuss the optical properties of  $\text{Cu}_2\text{O}$  surfaces as probed with STM luminescence spectroscopy at the atomic scale.

### 4.3. Spatially resolved optical measurements on $\text{Cu}_2\text{O}$ surfaces

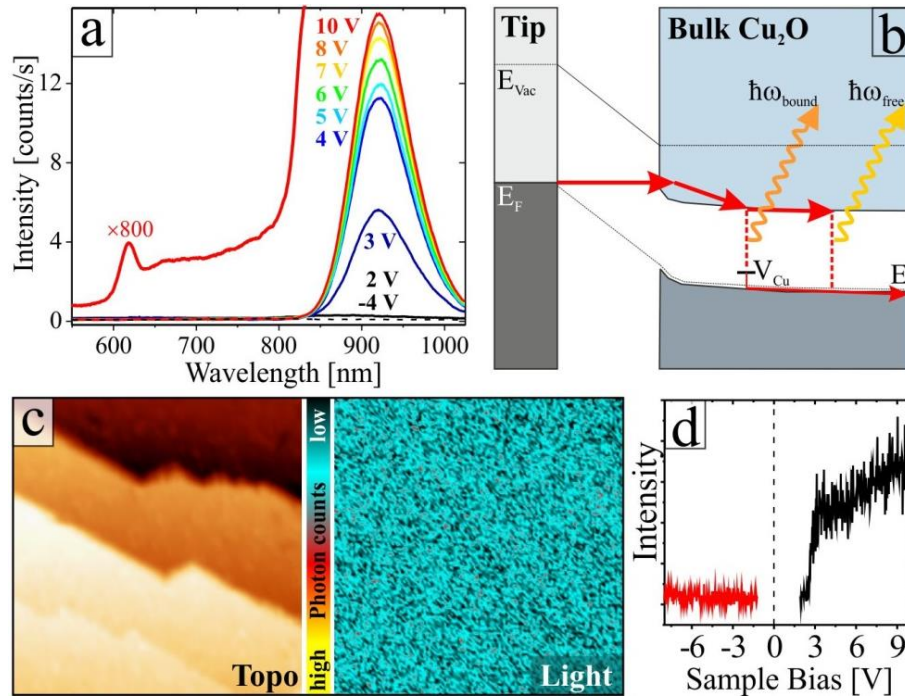
The optical response of dielectric materials exhibits pronounced spatial inhomogeneity, arising from the presence of structural defects and their ability to trap mobile optical modes, such as excitons. In the case

of  $\text{Cu}_2\text{O}$ , optical inhomogeneity originates from O and Cu vacancies in the lattice, as well as from grain boundaries and line defects in polycrystalline materials.<sup>1,26</sup> The variable thickness of oxide films introduces another source of spatially inhomogeneous optical signals.<sup>208</sup> Given the fundamental wave-character of light, conventional optical spectroscopy is intrinsically unable to record nanometer spatial variations in the luminescence response, as clearly stated in Abbes diffraction limit. To achieve spatial resolution well below the wavelength of visible light, nearfield optical techniques can be employed, such as scanning near-field optical microscopy (SNOM) and STM luminescence spectroscopy.<sup>209,210</sup> In both cases, the strong electromagnetic field-enhancement inside the tip-sample cavity and the symmetry breaking due to the sensor tip enable coupling to evanescent waves in the microscope gap.<sup>211</sup> Detection of these wave components in the far-field now yields optical information on a sub-nanometer length scale, sufficient to probe light emission from individual oxide defects.

In the context of cuprous oxide, STM luminescence spectroscopy at 100 K was employed to probe the local emission response from  $\text{Cu}_2\text{O}(111)$  surfaces. In the case of bulk crystals, STM luminescence has been triggered by injecting electrons from the tip into the oxide CB (Fig. 38).<sup>212</sup> The photon flux sets in at  $\sim 2.5$  V sample bias, corresponding to the band onset, and monotonously rises with voltage due to Auger-type excitations. The injected electrons then recombine with holes at the VB top of the p-type conductor, whereby different decay channels give rise to different wavelength maxima in the STM luminescence spectra (Fig. 38 a,b). The by far most intense peak is at 920 nm and matches a similar peak in the PL data, where it was assigned to Cu vacancies in the lattice (see Fig. 36a). Also, the  $V_{\text{O}}$ -mediated and the free-exciton peak are discernable at 750 and 620 nm, respectively, yet with strongly reduced intensity compared to the  $V_{\text{Cu}}$  emission. The largely different weights of  $V_{\text{Cu}}$ ,  $V_{\text{O}}$  and excitonic peaks in photo- and STM luminescence spectra reflect the deviating excitation schemes that involve electron-hole pairs in PL but hot electrons injected from the tip in the STM studies (Fig. 38b). In the latter case, the CB electrons can directly decay towards  $E_{\text{F}}$  via Cu vacancy states without forming an exciton first, explaining the dominance of the  $V_{\text{Cu}}$ -induced emission.<sup>212</sup>

STM luminescence spectroscopy provides the unique possibility to probe optical signals with nanometer spatial resolution. For this purpose, the tip is scanned across the surface and the emitted light is probed with a sensitive photomultiplier in the far-field.<sup>213</sup> Such photon maps acquired on bulk  $\text{Cu}_2\text{O}(111)$  display high overall intensity but hardly any spatial modulations of the emission yield, a finding that is independent of tunneling current and bias voltage (Fig. 38c).<sup>212</sup> The result is especially surprising, as the most intense emission peak was spectrally assigned to Cu vacancies and should thus arise from local emission centers in the surface (Fig. 38a). The missing correlation between defect landscape and optical response can be explained, however, with the long excitation lifetime in  $\text{Cu}_2\text{O}$ . In fact, electrons injected into the oxide CB can migrate over large distances before they decay via Cu vacancies in the lattice.<sup>20</sup> As a conse-

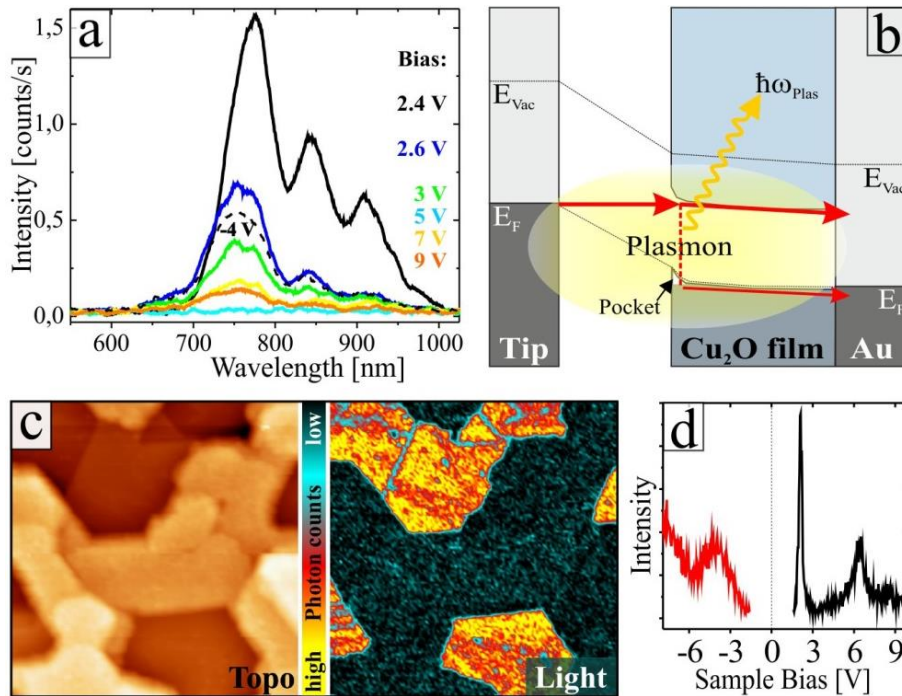
quence, any spatial correlation between the point of electron injection and the point of radiative decay is lost and the respective optical maps exhibit homogenous emission intensity. To identify local optical centers in the surface, the mobility of the excited modes needs to be reduced, for instance by performing experiments at even lower temperature. Successful STM luminescence studies with single-defect resolution were reported for dielectrics with dipole-allowed optical transitions and short radiative lifetimes, for example for GaAs and Eu-doped MgO.<sup>214,215</sup> As thin films have naturally a lower lattice quality than bulk crystals, STM photon maps of Cu<sub>2</sub>O layers also revealed pronounced spatial variations, as shown next.



**Figure 38:** (a) Bias-dependent STM luminescence spectra acquired on bulk Cu<sub>2</sub>O(111) (acquisition time 60s, 0.25 nA). (b) Underlying emission mechanism in the STM. The requirement for photon emission is electron injection from the STM tip into the oxide CB. (c) STM photon map of Cu<sub>2</sub>O(111) (150×150 nm<sup>2</sup>, 4.4 V, 0.25 nA). The spatially homogenous nature of the emission reflects the high mobility of optical modes in the oxide surface. (d) Integral emission intensity measured as a function of bias voltage with a photomultiplier tube.<sup>212</sup>

Respective STM studies have been performed on Cu<sub>2</sub>O/Au(111) films, and spatially modulated luminescence maps were indeed detected although the emission mechanism was distinctively different from the one on bulk crystals.<sup>212,216</sup> For Cu<sub>2</sub>O/Au(111) thin films, STM luminescence could be recorded at both bias polarities, i.e., for tunneling into the CB and out of the VB (Fig. 39). Spectrally, both tunneling directions gave rise to the same emission envelop, namely a broad maximum extending from 700 to 950 nm. In contrast, the emission fine structure, i.e., the number and position of individual peaks was found to depend on the nature of the STM tip used in the experiments.<sup>217</sup> Both peculiarities, a polarity independent spectral signature and the critical role of the sensor tip, identified the emission mechanism to be governed by plasmon modes in the tip-sample cavity.<sup>210,211</sup> In the experiment, the plasmons are sustained by coherent

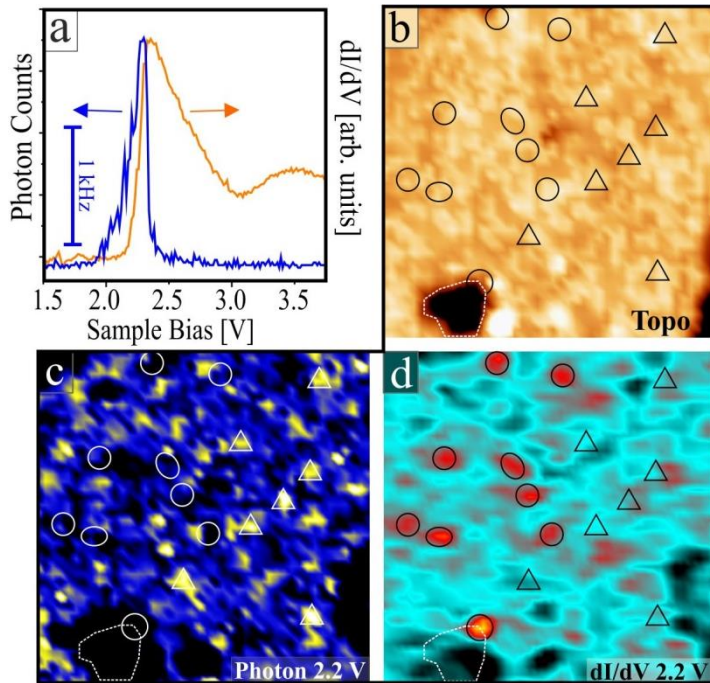
oscillations of the free electron gases in the gold tip and the gold sample below the oxide film, generating a field-enhancement window between 700-950 nm in agreement with the detected emission response (Fig. 39b). The  $\text{Cu}_2\text{O}$  film, on the other hand, has low carrier density and, apart from a small redshift due to its intrinsic polarizability, contributes only little to these cavity plasmons.<sup>208</sup> Its intrinsic optical modes thus remain invisible, also because the  $\text{Cu}_2\text{O}$  excitons have much longer radiative lifetimes and much lower oscillator strength than the STM cavity plasmons.<sup>216</sup>



**Figure 39:** (a) Bias-dependent STM luminescence spectra acquired on  $\text{Cu}_2\text{O}/\text{Au}(111)$  films (acquisition time 60s, 1.0 nA). The spectral response is independent of bias polarity in this case. (b) Emission mechanism governed by the excitation of cavity plasmons in the STM gap. (c) STM photon map of a  $\text{Cu}_2\text{O}/\text{Au}(111)$  film ( $150 \times 150 \text{ nm}^2$ , 5.5 V, 1.0 nA). At the selected bias, the emission involves field emission resonances and distinctively deviates for a  $\text{Cu}_3\text{O}_2$  surface oxide (bright) and thick  $\text{Cu}_2\text{O}$  patches (dark). (d) Integral emission intensity measured as a function of bias voltage with a photomultiplier tube.<sup>212</sup>

The bias-dependence of the luminescence yield perfectly corroborates the above emission scenario (Fig. 39d). At negative polarity, the detected intensity runs through a maximum at -4 V, slightly dependent on the oxide thickness. It can be linked to an emission channel, where electrons start from  $E_F$  in the  $\text{Au}(111)$  support, proceed to the oxide CB that bends downward in the tip-electric field, and recombine with holes in the VB via plasmon excitation. At positive polarity, the emission gets initiated at 2.5 V when electrons populate the CB and decay from there to the VB via plasmon stimulation. An additional maximum is detected at  $\sim 6.0$  V that can be assigned to electron recombination via field emission resonances. The latter are bound electronic states in the classical part of the tip-sample junction with energies depending on the local work function.<sup>218</sup> Electrons trapped in such high-bias resonances have long lifetimes, making them

ideally suited for plasmon stimulation via inelastic energy losses.<sup>219</sup> Moreover, a distinct work-function dependence makes this emission channel sensitive to the oxide film thickness, and produces the pronounced contrast seen in the STM photon maps (Fig. 39c). Hereby, a  $\text{Cu}_3\text{O}_2$  monolayer film that can be viewed as oxide precursor on Au(111) exhibits the lowest work function and consequently appears bright already in photon maps taken at 5.5 V.<sup>82</sup> For thicker films, the resonance condition gets fulfilled at higher bias and those turn bright only in maps taken above 6.0 V.<sup>213</sup> In clear difference to bulk crystals, photon maps of  $\text{Cu}_2\text{O}$  films thus exhibit a pronounced thickness-dependent contrast, although the associated emission channel contains no direct information on the  $\text{Cu}_2\text{O}$  optical modes.



**Figure 40:** (a) Bias-dependent STM luminescence yield measured with a photomultiplier tube and simultaneously detected  $dI/dV$  signal for a  $\text{Cu}_2\text{O}/\text{Au}(111)$  thin film. The luminescence maximum corresponds to an excitation energy inside the band gap. (b) Topography, (c) photon- and (d)  $dI/dV$ -map of the film taken at 2.2 V ( $25 \times 25 \text{ nm}^2$ ,  $I = 1 \text{ nA}$ ). Characteristic luminescence (triangles) and electronic spots (ellipses) do not coincide with topographic features in the surface, suggesting that the relevant emission centers correspond to single  $\text{V}_\text{O}$  defects in subsurface positions.<sup>217</sup>

Incompatible with the plasmon-picture developed above, the thin-film luminescence runs through a sharp intensity maximum at 2.1 V that is higher than at any other excitation bias and exhibits only 100 mV half width (Fig. 40a).<sup>217</sup> Surprisingly, the respective bias position lies inside the  $\text{Cu}_2\text{O}$  band gap, as the CB only starts at 2.3 eV, as deduced from a sharp increase in the differential conductance. Although the spectral signature still indicates cavity plasmons as source of the light emission, the resonance-like maximum points to an excitation pathway linked to the  $\text{Cu}_2\text{O}$  electronic structure. Using hybrid DFT calculations, this path has been assigned to resonant tunneling into defect states introduced by oxygen vacancies. Their

energy positions were determined to 1.7 and 1.6 eV above the VB top for  $V_{O2+}$  and  $V_{O+}$  defects, respectively, although only  $V_{O2+}$  defects are of relevance for  $Cu_2O/Au(111)$  films with their pronounced p-type nature.<sup>195</sup> The calculated defect energy is therefore 0.4 V lower than the experimental resonance position (2.1 V), a discrepancy that can be explained however with band-bending effects in the tip-sample junction of the STM.<sup>217</sup> In fact the upshift of the resonance can be reproduced with a plate-capacitor model that takes the oxide thickness (10 nm) and the  $Cu_2O$  dielectric constant ( $\epsilon_r = 7.1$ ) into account.<sup>220</sup> The defect-mediated excitation scenario also explains the high efficiency of the emission channel, as elastic electron transport into CB states is prohibited at the bias voltage inside the band gap. Conversely, an inelastic transport channel into the VB remains accessible, generating the bright photon emission observed in the measurements (Fig. 40a). The small FWHM of the resonance of 100 meV finally results from the intrinsic width of the gap state convoluted with a distribution of  $V_O$  defects in different layers below the oxide surface.<sup>217</sup>

The luminescence from  $V_O$  defects leaves sharp and discernible fingerprints also in photon maps acquired from metal-supported  $Cu_2O$  films.<sup>217</sup> Their high spatial localization can be rationalized with the fact that once electrons have been injected into a discrete defect state, no diffusive motion of the mode is possible anymore and radiative decay occurs directly at the point of excitation. Consequently, the photon maps taken at 2.1-2.2 V sample bias are highly inhomogeneous in space, with sharp, localized emission centers alternating with dark regions (Fig. 40 b,c). The optical centers are randomly distributed in the surface and have a mean diameter of  $\sim 1$  nm, although some centers exhibit non-spherical shapes due to agglomeration effects. Following the above discussion, the local emission spots can safely be assigned to single oxygen vacancies in the  $Cu_2O$  films. The assignment is strengthened by the observation that they disappear from the maps if electrons are injected into delocalized conduction states at higher bias. Interestingly, simultaneously recorded topographic and  $dI/dV$  maps do not show common features with the photon maps, as visualized by triangles (for luminescence maxima) and ellipses (for electronic features) in panels (c) and (d) of Fig. 40. Apparently, the O vacancies cannot be recognized in the topographic maps, indicating a position below the oxide surface. This finding agrees well with the theoretical prediction that O vacancies are instable in the  $Cu_2O(111)$  surface and tend to move deeper into the oxide matrix.<sup>114,128</sup> The electronic and optical features appear uncorrelated as well, i.e., regions with pronounced optical and electronic activity do not coincide. This is in perfect agreement with the proposed emission mechanism, in which  $V_O$  luminescence relies on inelastic electron transport, while the  $dI/dV$  channel probes elastic electron exchange between tip and sample.<sup>217</sup> The detection of single  $V_O$  defects via STM luminescence thus arises from a fortunate interplay of effective inelastic tunneling via plasmon stimulation in absence of elastic transport paths.



The observation of single-defect luminescence in  $\text{Cu}_2\text{O}$  is unprecedented and has not been reported for any other dielectric oxides so far. Given the pivotal role of cationic and anionic defects for controlling oxide properties, the possibility to identify individual defects in the surface region is expected to gain much more attention in the future. In fact,  $\text{Cu}_2\text{O}$  is far from being ideal for this kind of measurements, as the dark character of ground-state excitons hampers their observation in STM luminescence maps. Consequently, the technique may produce even more promising results if an oxide with direct band gap, such as  $\text{ZnO}$ , is used in the experiments.

## 5. Doping of $\text{Cu}_2\text{O}$ surfaces

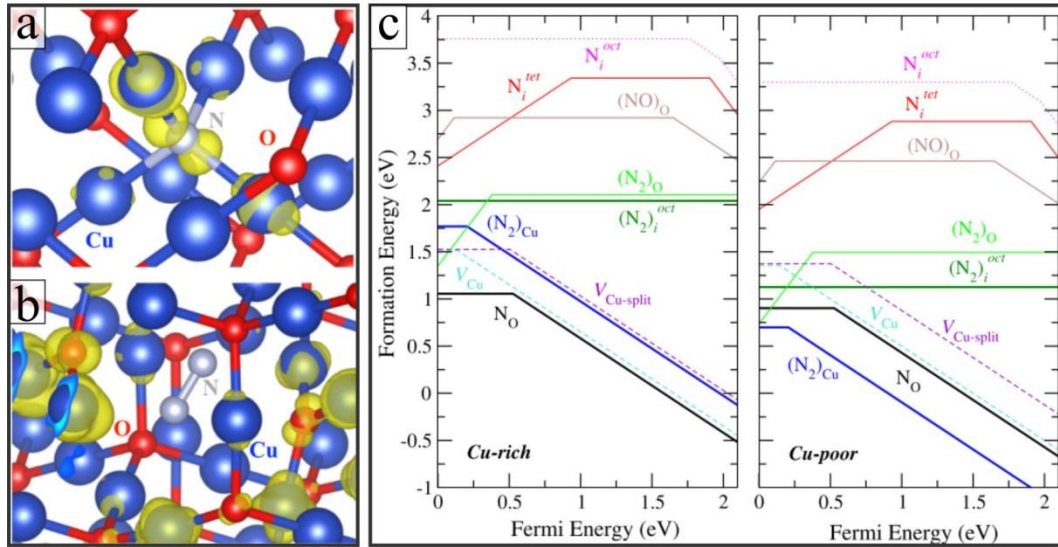
In the final chapter of this review article, we discuss possibilities to modify surface and bulk properties of cuprous oxide by inserting foreign atoms. Hereby, cationic (metal ions) and anionic (nitrogen) dopants will be considered, and both experimental and theoretical viewpoints will be compiled. We will start our discussion with nitrogen doping of cuprous oxide, as this approach has gained much attention in the literature as a means to increase the conductivity and p-type character of the oxide material.

### 5.1. Nitrogen-doping

Two main scenarios have been considered on how nitrogen gets introduced into the  $\text{Cu}_2\text{O}$  lattice.<sup>15</sup> In the first case, a nitrogen atom substitutes a lattice-oxygen species, producing a so called  $\text{N}_\text{O}$  defect (Fig. 41a). In a purely ionic picture, the dopant would trap an extra electron from nearby Cu ions, which increases the number of hole states in the VB and thus promotes the p-type character of the material. In a second scenario, a lattice Cu gets replaced by an  $\text{N}_2$  molecule,  $(\text{N}_2)_\text{Cu}$ , which introduces a new low-lying acceptor state in the band gap and thus increases the oxide conductivity at low temperature (Fig. 41b). The thermodynamic preference for one or the model is subject of intense discussions already for several years.

The  $\text{N}_\text{O}$  substitution scenario has been theoretically addressed first in a DFT / CASTEP study.<sup>221</sup> The authors find an unoccupied and spin-polarized in-gap resonance that has mostly N  $2p$  character and locates at 0.9 eV above the VB top. Although the Bader charge on the N atom is increased by 12% with respect to the initial oxygen, no complete charge transfer is revealed and no indication of additional hole states is found in the calculations. The new in-gap state was proposed to give rise to an optical transition at 1.5 eV in absorption spectra. In a subsequent hybrid DFT study, alternative positions were explored for N dopants in the  $\text{Cu}_2\text{O}$  lattice.<sup>15</sup> Using an ab-initio thermodynamic approach, substitutional  $\text{N}_\text{O}$  and  $(\text{N}_2)_\text{Cu}$  defects were found to be thermodynamically preferred at Cu-rich and Cu-poor chemical potentials, respectively,

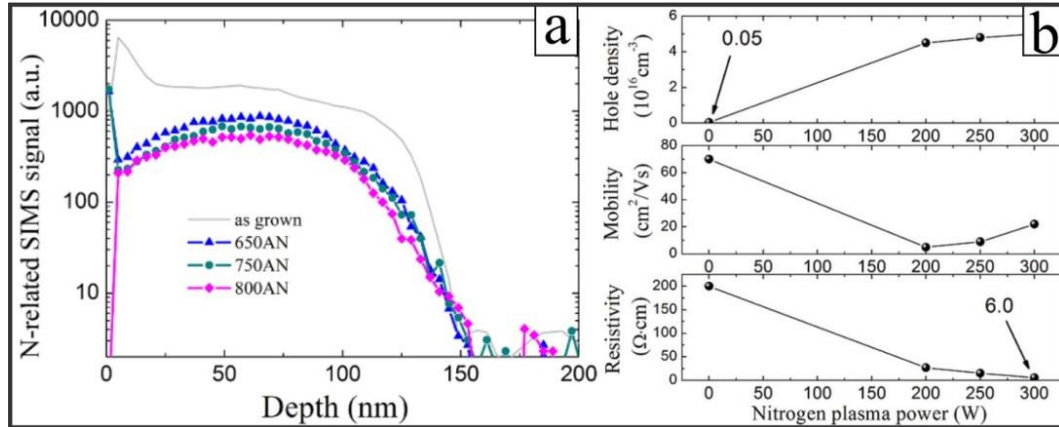
while anionic substitution with  $N_2$ ,  $(N_2)_O$ , or interstitial nitrogen atoms ( $N_i^{oct}$ ,  $N_i^{tet}$ ) turned out to be unstable (Fig. 41c). Similarly to the previous paper,<sup>221</sup> the  $N_O$  defect produces a deep transition state inside the band gap (0.53 eV above the VB top) that can neither serve as electron acceptor nor explain the increased p-type conductivity of N-doped  $Cu_2O$ . In contrast, the  $(N_2)_{Cu}$  substitution introduces a suitable acceptor state with  $\sim 0.2$  eV activation energy for VB electrons, being compatible with the experimental conductivity measured for bulk  $Cu_2O$  at temperatures below 100 K (Fig. 2).<sup>10</sup> Moreover, the  $(N_2)_{Cu}$  related defect state strongly overlaps with the VB and has delocalized character, corroborating its ability to act as shallow acceptor. The work further suggests that  $Cu_2O$  luminescence can be used to distinguish between  $(N)_O$  and  $(N_2)_{Cu}$  defects formed upon nitrogen doping.<sup>15</sup> The former produce an optical band at  $\sim 1.6$  eV, which blue-shifts to 1.9 eV in the latter case.



**Figure 41:** Local structure of (a)  $N_O$  and (b)  $(N_2)_{Cu}$  defects in  $Cu_2O$  as calculated with a DFT HSE approach. (c) Formation energies of N-related defects as a function of  $E_F$  at Cu-rich and Cu-poor growth conditions.<sup>15</sup>

The validity of the two nitrogen doping scenarios has been explored in numerous experimental studies, so far without clear preference for either one or the other model. The common approach to synthesize N-doped  $Cu_2O$  in these works was magnetron sputtering of copper in a mixture of oxygen and nitrogen. The nitrogen concentration inside the sample was typically probed by secondary-ion mass-spectrometry (SIMS) or XPS, and could be varied between  $10^{17}$  to  $10^{21}$  atoms/cm<sup>3</sup> (Fig. 42a).<sup>14,222,223</sup> In early photoluminescence experiments, an emerging peak at 875 nm (1.85 eV) was assigned to the N-dopants.<sup>224</sup> Unfortunately, the spectra lacked all the other characteristic fingerprints of bulk  $Cu_2O$ , especially the free-exciton, O- and Cu-vacancy related luminescence maxima. In a couple of further experiments, an increasing hole density and a decreasing sheet-resistance of the  $Cu_2O$  films was taken as evidence for successful nitrogen doping (Fig. 42b).<sup>223,225,226</sup> Also, the contact resistance between  $Cu_2O$  and different metal electrodes was found to decrease with increasing N-doping level.<sup>227</sup> However, no direct indication for N-

species populating either O or Cu substitutional sites could be provided in those studies. Moreover, it could not be precluded that the detected electronic effects were actually triggered by parasitic changes in crystallinity or morphology of the oxide material instead of the intended doping effect.



**Figure 42:** (a) Nitrogen concentration in differently annealed  $\text{Cu}_2\text{O}:\text{N}$  samples of 150 nm thickness measured with SIMS. (b) Hole density, hole mobility, and sheet resistance of  $\text{Cu}_2\text{O}:\text{N}$  samples annealed at  $750^\circ\text{C}$  as the function of the nitrogen plasma power used for preparation.<sup>14</sup>

Also, PL spectroscopy has been exploited to pinpoint the impact of nitrogen doping on the optical response of  $\text{Cu}_2\text{O}$ .<sup>14</sup> Instead of the PL maximum predicted by theory,<sup>15</sup> the experiments revealed a strong  $V_{\text{O}}$ -related resonance at 1.65 eV (750 nm) in the N-doped films that decreased in intensity during oxygen annealing. The diminishing  $V_{\text{O}}$  luminescence was hereby taken as evidence that interstitial nitrogen in the  $\text{Cu}_2\text{O}$  lattice fill the defect sites. However, the occurrence of a strong  $V_{\text{O}}$  emission could also be interpreted as compensation effect, in which N atoms in O substitutional sites generate O vacancies in order to keep the oxide charge neutral. The observed reduction of the  $V_{\text{O}}$  luminescence would then be the consequence of vacancy annihilation due to oxygen incorporation from the gas phase, a scenario that was discarded by the authors. In another work, the N concentration in the reactive gas used for Cu oxidation was found to determine the stoichiometry of the evolving copper oxide films.<sup>228</sup> While CuO was the dominant phase in an N-poor growth environment, the phase shifted towards  $\text{Cu}_2\text{O}$  with increasing nitrogen concentration. Simultaneously, the oxide band gap was found to widen, an effect that was assigned to N-doping but could be triggered by the phase transformation as well. In fact, none of the other optical studies could reveal a band-gap increase in  $\text{Cu}_2\text{O}$  upon nitrogen-doping.<sup>223</sup> Only very few works addressed the topic of  $\text{N}_2$  incorporation into  $\text{Cu}_2\text{O}$  films.<sup>229</sup> One study successfully detected a  $\text{N}_2$  Raman signal at  $2250 \text{ cm}^{-1}$  in line with the formation of  $(\text{N}_2)_{\text{Cu}}$  defects, although most of the N-species still got incorporated in the form on  $\text{N}_{\text{O}}$  defects, as deduced from a rising oxide conductivity at higher  $\text{N}_2$  flow rate. Moreover, a recent XPS study confirmed the presence of various N-species in nitrogen-doped  $\text{Cu}_2\text{O}$ , one due to substitutional  $\text{N}_{\text{O}}$  defects ( $E_{\text{B}} = 396 \text{ eV}$ ), and two related to  $\text{N}_2$ -derived species ( $E_{\text{B}} = 399$  and  $405 \text{ eV}$ ).<sup>230</sup> Somehow unex-

pected, the atomic N dopants turned into embedded molecular species upon annealing the oxide sample, suggesting higher thermodynamic stability of the latter. A systematic nitrogen-doping experiment of cupric oxide (CuO) is finally described in Ref. 231. It reproduced major doping effects found for Cu<sub>2</sub>O before, such as an increasing hole concentration and a reduced carrier mobility at higher doping level. Also, the activation barrier for charge transport was carefully determined to ~0.15 eV in a wide temperature window, which compares to 0.27 eV for non-doped CuO.

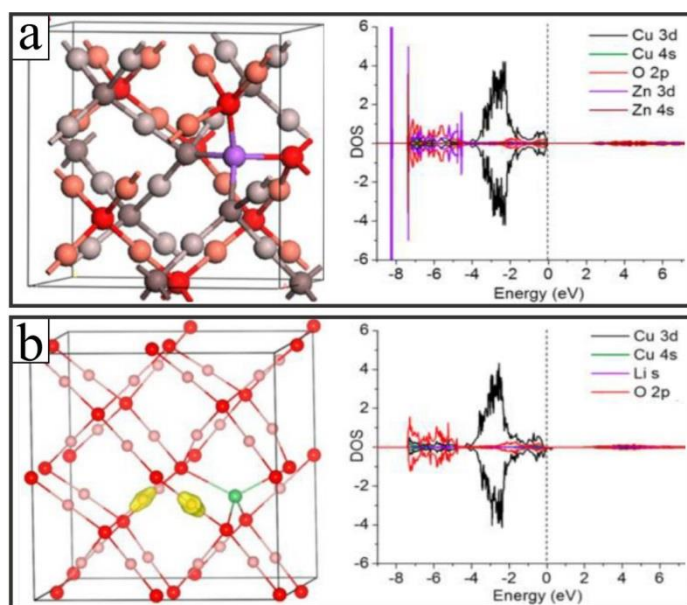
In summary, the mechanistic picture for nitrogen-doping of copper oxide remains incomplete and inconsistent at many points, despite the large number of experimental and theoretical studies. Moreover, experiments performed with a rigorous surface-science approach are still missing, although they would probably provide atomic-scale insights into the nature of the nitrogen dopants. The situation thus resembles the one on N-doped TiO<sub>2</sub>, where internal compensation mechanisms, e.g., O vacancy formation, counteract the expected doping effects, and the overall picture appeared to be much more complex than initially anticipated.<sup>232</sup>

## 5.2. Alternative dopants

While anionic doping of Cu<sub>2</sub>O concerned mostly nitrogen, a few theoretical studies addressed the insertion of other anions into the oxide lattice. Halogen doping (F, Cl, Br, I) generally induces an impurity level just below the CB edge, which in turn promotes an n-type conductance behavior of Cu<sub>2</sub>O.<sup>233</sup> With higher atomic number of the halogen, the donor level shifts towards the band edge, yet at the expense of an increasing lattice distortion and a larger defect formation energy. Due to this interplay, n-type doping of Cu<sub>2</sub>O is predicted to be most successful with Cl atoms substituting the lattice oxygen.

Cationic doping was mostly explored from a theoretical point of view, either as a means to promote the p-type conductivity of Cu<sub>2</sub>O or to narrow down its band gap and improve its photo-activity. A first systematic DFT PBE study of metal doping was carried out by Nolan and Elliott, placing different metal ions onto Cu substitutional sites and compensating their unmatched valence by Cu vacancies.<sup>234</sup> They identified two fundamental effects. While dopants with large ionic radius, e.g., La<sup>3+</sup>, Sr<sup>2+</sup> and Ba<sup>2+</sup>, trigger a sizeable lattice distortion that widens the Cu<sub>2</sub>O band gap, strongly interacting species, such as In<sup>3+</sup>, Ti<sup>4+</sup> and Ce<sup>4+</sup>, introduce defect levels inside the gap region that in turn reduce the optical transition energies. The impact of doping on the magnetic response of Cu<sub>2</sub>O was explored by substituting copper with Mn, Fe, Co or Ni atoms in the oxide lattice.<sup>235</sup> Especially, Fe (Mn) was found to induce large magnetic moments associated with a ferro (antiferro)-magnetic response of the intrinsically non-magnetic Cu<sub>2</sub>O. The latter was additionally altered by the presence of O vacancies in the lattice. The interaction between metal do-

ants and Cu vacancies was further explored in a detailed DFT-HSE study by Carter et al.<sup>11</sup> Hereby, the insertion of Mg, Mn and Zn single-atom dopants was found to be exothermic and accompanied by Cu vacancy formation. Li incorporation, on the other hand, was endothermic and, given its iso-charged nature, not compensated by a Cu defect (Fig. 43). Moreover, most dopants seem to prefer a tetrahedral coordination in the oxide lattice, with the compensating Cu vacancy located in the next coordination shell. Most interestingly, the formation of split vacancies was largely suppressed in the presence of metal dopants, especially for substitutional Li, removing a potential trapping site for charge carriers in the oxide material. Appropriate metal doping was therefore suggested to be a means to improve the photoconductivity of bulk Cu<sub>2</sub>O.<sup>11</sup> Hydrogen interstitials were finally proposed to change the conductance response of Cu<sub>2</sub>O from p- to n-type.<sup>236</sup>



**Figure 43:** Relaxed structure of (a) Zn-doped Cu<sub>2</sub>O with a Cu vacancy and (b) Li-doped Cu<sub>2</sub>O, as calculated with DFT-HSE. In both cases, the dopant takes a tetrahedral coordination with oxygen in the lattice. The yellow color in (b) marks the excess spin density introduced by the Li defect. The projected DOS for the two doping configurations is depicted in the right panels.<sup>11</sup>

In contrast to multiple theoretical studies aiming at cationic doping of Cu<sub>2</sub>O, the number of experiments addressing this topic is surprisingly small. Ni-doped Cu<sub>2</sub>O films, grown by pulsed-laser deposition from a Ni:CuO target, were shown to develop a higher hole concentrations than pristine films, in agreement with the formation of compensating Cu vacancies in the lattice.<sup>237</sup> Moreover, the increasing Ni content triggered a gradual phase change from Cu<sub>2</sub>O to CuO during film growth. Photoluminescence spectroscopy was used to investigate the effect of Mn-doping of Cu<sub>2</sub>O films. According to XPS, the Mn ions take a 2+ charge state and occupy Cu substitutional sites. An optical transition between two Mn crystal-field states produced a pronounced blue-light emission at ~480 nm, while excitonic bands were largely suppressed.

Attempts to dope Cu<sub>2</sub>O with sodium ions did not result in apparent changes of the electronic or optical response, as concluded from XPS and PL measurements.<sup>238</sup> The effect of alkali doping thus needs to be examined more carefully in forthcoming studies.

In summary, metal doping might be a powerful approach to change fundamental properties of cuprous oxide. Hereby, the carrier density is modulated by introducing Cu vacancies to compensate the charge mismatch with the aliovalent dopants.<sup>11,234</sup> In addition, defect states inserted by substitutional dopants may open dipole-allowed transitions across the band gap, releasing optical constraints imposed by the dark nature of ground-state excitons in Cu<sub>2</sub>O. However similar to anionic doping, the studies on cation-doped Cu<sub>2</sub>O are still in their infancy and high-quality doping experiments are hardly found in the literature.

## 6. Summary and Outlook

This article aimed at introducing the surface properties of cuprous oxide (Cu<sub>2</sub>O), putting special emphasis on the thermodynamically preferred (111) surface. The first section addressed the profound differences between ultrathin Cu-O precursor oxides, as grown on many (111)-oriented metal supports such as Cu(111), Pt(111) and Au(111), and a truly bulk-type Cu<sub>2</sub>O(111) surface. It demonstrated that ultrathin Cu-O layers cannot serve as model systems for the respective bulk material, as structural, electronic and optical properties deviate substantially. Moreover, experimental instructions were given on how thick Cu<sub>2</sub>O and CuO films with bulk-like properties can be fabricated reliably. For this purpose, the temperature and pressure-dependent oxidation behavior of copper was studied via time-resolved optical schemes, revealing that Cu oxidation does not take place at O<sub>2</sub> partial pressures below 50 mbar.

The central, third chapter provided detailed insights into the atomic-scale properties of low-index Cu<sub>2</sub>O planes, especially the (111), (100) and (110) one. All three surfaces are subject to massive reconstructions, driven by the strongly covalent nature of the Cu-O bond as well as by the inherent polarity of the (100) and (110) bulk cuts. The (111) surface develops a ( $\sqrt{3}\times\sqrt{3}$ )R30° reconstruction at vacuum-compatible preparation conditions that could be associated with the nano-pyramidal surface model proposed by DFT calculations. Hereby, Cu<sub>4</sub>O nanopyramids populate every third Cu<sub>6</sub>O<sub>6</sub> ring of the non-reconstructed surface, which saturates all O<sub>cus</sub>-derived dangling bonds and drastically reduces the surface energy. The resulting Cu-deficiency of the ( $\sqrt{3}\times\sqrt{3}$ )R30° termination gives rise to an electron accumulation in the surface, which in turn leads to an upward band bending, the formation of an empty VB pocket and a work function increase. The experimentally deduced (3,0;1,1) phase of Cu<sub>2</sub>O(100), on the other hand, largely follows the requirements for polarity compensation and primarily involves Cu-dimerization accompanied by a reduction of the copper surface charges. The atomic structure of Cu<sub>2</sub>O(110), on the other hand, had

only be explored by DFT calculations so far, and high-resolution microscopy data, confirming the proposed models, are unavailable at this point.

Chapter four reviewed the optical properties of  $\text{Cu}_2\text{O}$ , connecting the bulk optical response as governed by para- and ortho-excitons as well as their trapping behavior at lattice defects, with the luminescence characteristics of thin films. In particular, experimental techniques to probe the atomic-scale optical response of  $\text{Cu}_2\text{O}(111)$  by means of STM luminescence spectroscopy were presented. Experimental and theoretical studies dealing with the impact of cationic and anionic dopants in the  $\text{Cu}_2\text{O}$  lattice finally completed this review article. Here, mainly nitrogen doping as a means to enhance the carrier concentration, and metal doping to modify the excitonic response of  $\text{Cu}_2\text{O}$  have been discussed.

Given its pronounced p-type character, a band gap in the visible spectral range and an adaptable exciton response, cuprous oxide might become a decisive ingredient for future electronic, photovoltaic and photochemical applications. Despite this enormous potential, pivotal properties of the material are not sufficiently characterized and explored at this point. This concerns, for example, the termination of the catalytically relevant (110) surface, the precise structure and localization of Cu vacancies including the energy position of associated gap states as well as the role of dopants in the oxide lattice. Although tremendous progress has been made in the preparation, atomic-scale characterization, and modeling of cuprous oxide in recent years, as demonstrated in this article, a substantial amount of work still lies ahead of experimentalists and theoreticians. However, these efforts will pay out eventually, as new building blocks for photochemical and opto-electronic technologies may be established.

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